



LPC86x

32-bit Arm® Cortex®-M0+ microcontroller; up to 64 KB flash and 8 KB SRAM; 12-bit ADC; Comparator; FlexTimers

Rev. 3 — 28 April 2023

Product data sheet

1. General description

The LPC86x is an Arm Cortex-M0+ based, low-cost 32-bit MCU family operating at CPU frequencies of up to 60 MHz. The LPC86x supports up to 64 KB of flash memory and 8 KB of SRAM.

The peripheral complement of the LPC86x includes a CRC engine, one I²C-bus interface, one I³C-MIPI bus interface, up to three USARTs, up to two SPI interfaces, one multi-rate timer, self-wake-up timer, two FlexTimers (one with full motor control feature), a DMA, one 12-bit ADC, one analog comparator, function-configurable I/O ports through a switch matrix, an input pattern match engine, and up to 54 general-purpose I/O pins.

For additional information related to the LPC86x parts, see [Section 4](#).

2. Features and benefits

- System:
 - ◆ Arm Cortex-M0+ processor (revision r0p1), running at frequencies of up to 60 MHz with single-cycle multiplier and fast single-cycle I/O port.
 - ◆ Arm Cortex-M0+ built-in Nested Vectored Interrupt Controller (NVIC).
 - ◆ System tick timer.
 - ◆ AHB multilayer matrix.
 - ◆ Serial Wire Debug (SWD) with four break points and two watch points. JTAG boundary scan (BSDL) supported only.
- Memory:
 - ◆ Up to 64 KB on-chip flash programming memory with 64 Byte page write and erase.
 - ◆ Code Read Protection (CRP).
 - ◆ Up to 8 KB SRAM consisting of contiguous SRAM banks.
 - ◆ Bit-band addressing is supported to permit atomic operations to modify a single bit.
- ROM API support:
 - ◆ Boot loader.
 - ◆ Supports Flash In-Application Programming (IAP).
 - ◆ Supports In-System Programming (ISP) through USART.
 - ◆ FRO API.
- Digital peripherals:



- ◆ High-speed GPIO interface connected to the Arm Cortex-M0+ I/O bus with up to 54 General-Purpose I/O (GPIO) pins with configurable pull-up/pull-down resistors, programmable open-drain mode, input inverter, and digital filter. GPIO direction control supports independent set/clear/toggle of individual bits. The GPIO pins are tri-state when power is on.
- ◆ High-current source output driver (20 mA) on four pins.
- ◆ High-current sink driver (20 mA) on two true open-drain pins.
- ◆ GPIO interrupt generation capability with a boolean pattern-matching feature on eight GPIO inputs.
- ◆ Switch matrix for flexible configuration of each I/O pin function.
- ◆ CRC engine.
- ◆ DMA with 16 channels and 13 trigger inputs.
- Timers:
 - ◆ Two FlexTimers with DMA support and a selection of hardware triggers. The first FlexTimer has six channels and includes support for motor control (including Fault Control). The second FlexTimer has four channels. This timer does not include Fault Control but includes a Quadrature Decoder interface. Both FlexTimers are clocked up to 60 MHz.
 - ◆ Four-channel Multi-Rate Timer (MRT) for repetitive interrupt generation at up to four programmable, fixed rates.
 - ◆ Self-Wake-up Timer (WKT) clocked from either Free Running Oscillator (FRO), a low-power, low-frequency internal oscillator, or an external clock input in the always-on power domain.
 - ◆ Windowed Watchdog timer (WWDT).
- Analog peripherals:
 - ◆ One 12-bit ADC with up to 12 input channels with multiple internal and external trigger inputs and with sample rates of up to 1.9 Msamples/s. The ADC supports two independent conversion sequences.
 - ◆ Comparator with five input pins and external or internal reference voltage.
- Serial peripherals:
 - ◆ Three USART interfaces with pin functions are assigned through the switch matrix, support receives idle interrupt, and two fractional baud rate generators.
 - ◆ Two SPI controllers with pin functions are assigned through the switch matrix.
 - ◆ One I²C-bus interface. I²C supports Fast-mode Plus with a 1 Mbit/s data rate on two true open-drain pins and listen mode.
 - ◆ One controller/target I3C-MIPI bus interface. The I3C supports DDR. It is supported by the general-purpose DMA controller.
- Clock generation:
 - ◆ Free Running Oscillator (FRO). This oscillator provides selectable 60 MHz, 48 MHz, and 36 MHz outputs that can be used as a system clock. Also, these outputs can be divided down to 30 MHz, 24 MHz, and 18 MHz for the system clock. The FRO is trimmed to ± 1 % accuracy over the entire voltage and temperature range of 0 °C to 70 °C.
 - ◆ External clock input for clock frequencies of up to 25 MHz.
 - ◆ Crystal oscillator with an operating range of 1 MHz to 25 MHz.
 - ◆ 1 MHz (± 3 %) low-power oscillator (LPOSC) can be used as a clock source for the watchdog timer.

- ◆ PLL allows CPU operation up to the maximum CPU rate without the need for a high-frequency crystal. May be run from the system oscillator, the external clock input, or the internal FRO.
- ◆ Clock output function with a divider that can reflect all internal clock sources.
- Power control:
 - ◆ Reduced power modes: sleep mode, deep-sleep mode, power-down mode, and deep power-down mode.
 - ◆ Wake up from deep-sleep and power-down modes on activity on USART, SPI, I²C, and I3C peripherals.
 - ◆ Timer-controlled self wake up from deep power-down mode.
 - ◆ Power-On Reset (POR).
 - ◆ Brownout detect (BOD).
- Unique device serial number for identification.
- Single power supply (1.8 V to 3.6 V).
- Operating temperature range -40 °C to +105 °C.
- Available in LQFP64, HVQFN48, and HVQFN32 packages.

3. Applications

- | | |
|-------------------------|----------------------------------|
| ■ Sensor gateways | ■ Simple motor control |
| ■ Industrial | ■ Portables and wearables |
| ■ Gaming controllers | ■ Lighting |
| ■ 8/16-bit applications | ■ Motor control |
| ■ Consumer | ■ Fire and security applications |
| ■ Climate control | |

4. Ordering information

Table 1. Ordering information

Type number	Package		
	Name	Description	Version
LPC865M201JBD64	LQFP64	Plastic low profile quad flat package; 64 leads; body 10× 10 × 1.4 mm	SOT314-2
LPC865M201JHI48	HVQFN48	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 48 terminals; body 7× 7 × 0.85 mm	SOT619-1
LPC865M201JHI33	HVQFN32	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 32 terminals; body 5× 5 × 0.85 mm	SOT617-11

4.1 Ordering options

Table 2. Ordering options

Type number	CPU/MHz	Flash/KB	SRAM/KB	USART	I ² C	I3C	SPI	GPIO	Package
LPC865M201JBD64	60	64	8	3	1	1	2	54	LQFP64
LPC865M201JHI48	60	64	8	3	1	1	2	42	HVQFN48
LPC865M201JHI33	60	64	8	3	1	1	2	29	HVQFN32

5. Marking

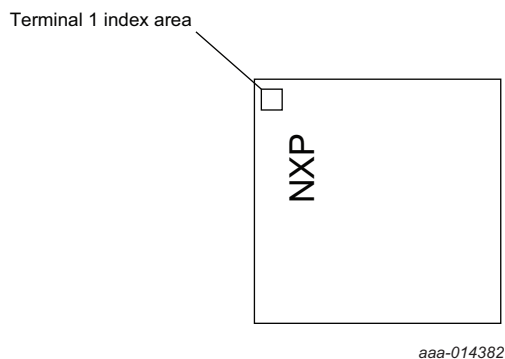


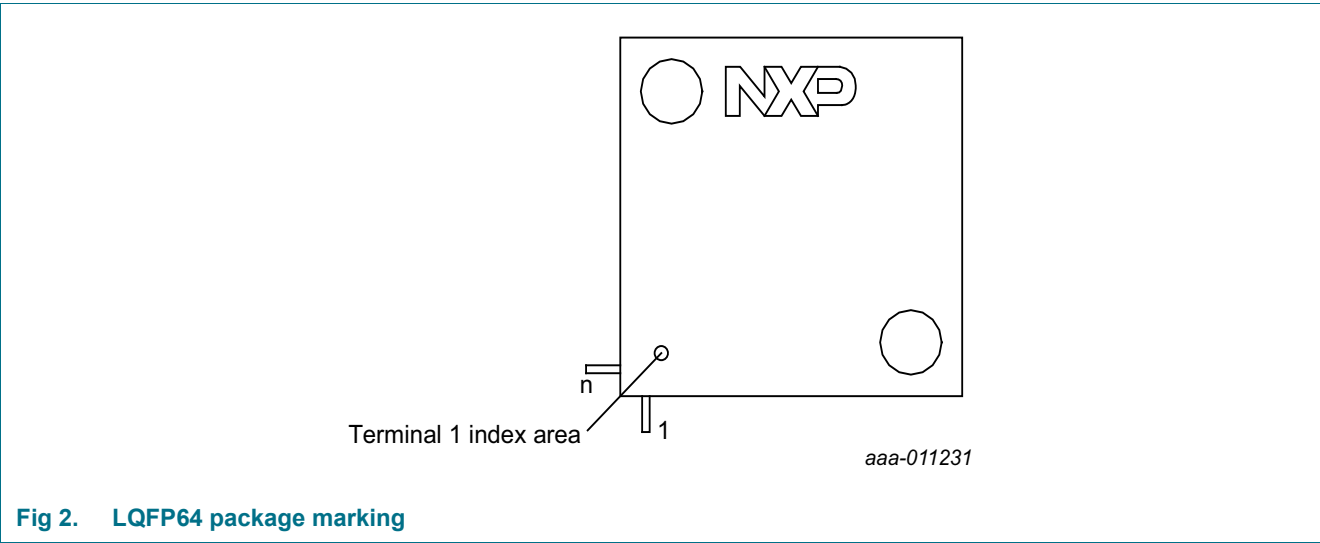
Fig 1. HVQFN48 and HVQFN32 package marking

The LPC86x HVQFN48 package has the following top-side marking:

- First line: 865M201
- Second line: [DBID][ASID]
- Third line:
- Fourth line: xxxyywwx[R]x
 - yyww: Date code with yy= year and ww= week.
 - xR: Boot code version and device revision.

The LPC86x HVQFN32 package has the following top-side marking:

- First line: 865M2
- Second line: [DBSN][ASID]
- Third line: yywwx[R]x
 - yyww: Date code with yy= year and ww= week.
 - xR: Boot code version and device revision.

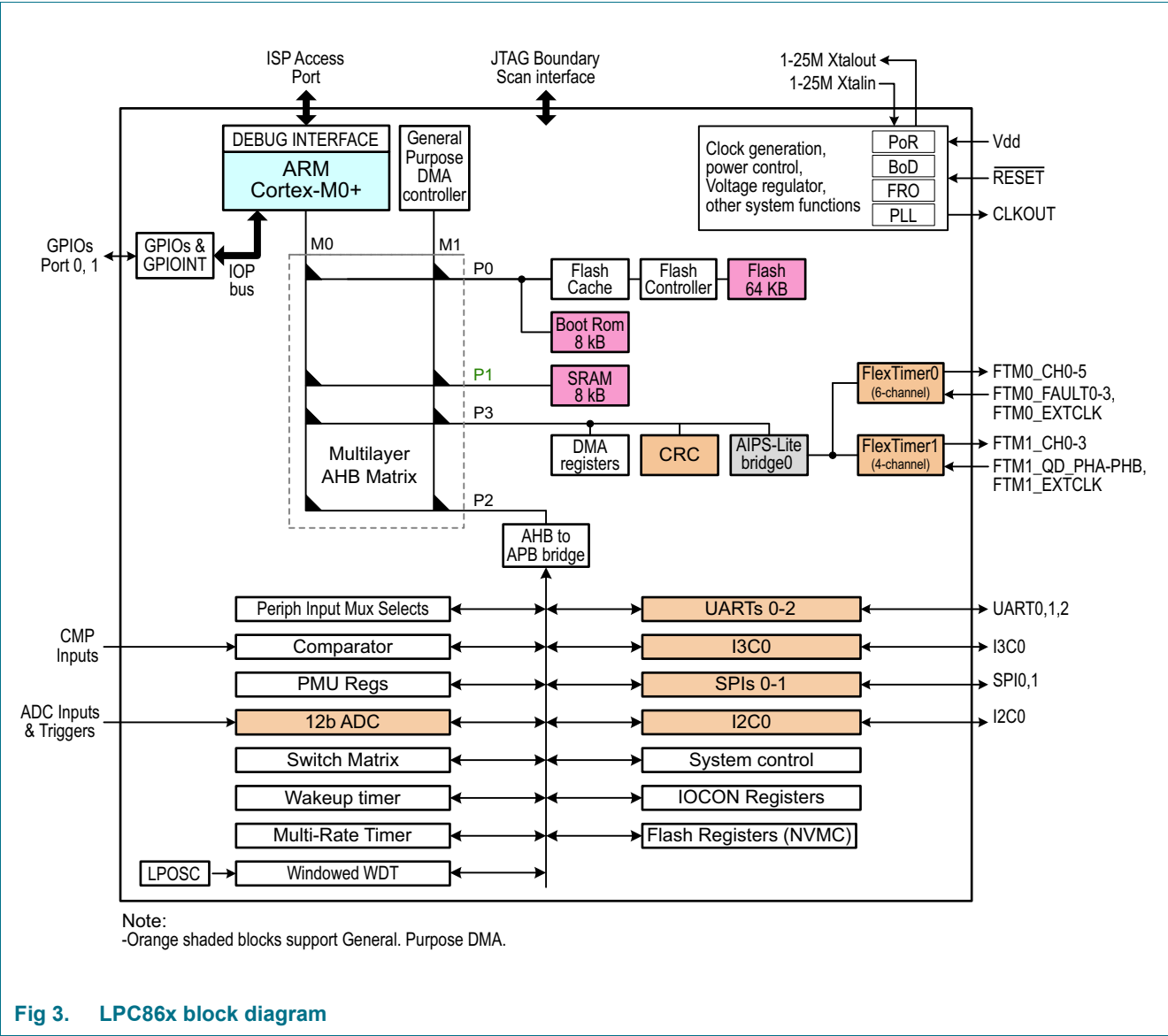


- The LPC86x LQFP64 package has the following top-side marking:
- First line: LPC865M201
 - Second line: [DBID][ASID]
 - Third line: xxxyywwx[R]x
 - yyww: Date code with yy = year and ww = week.
 - xR = Boot code version and device revision.

Table 3. Device revision table

Revision identifier (R)	Revision description
1A	Initial device revision with Boot ROM version 15.0

6. Block diagram



7. Pinning information

7.1 Pinning

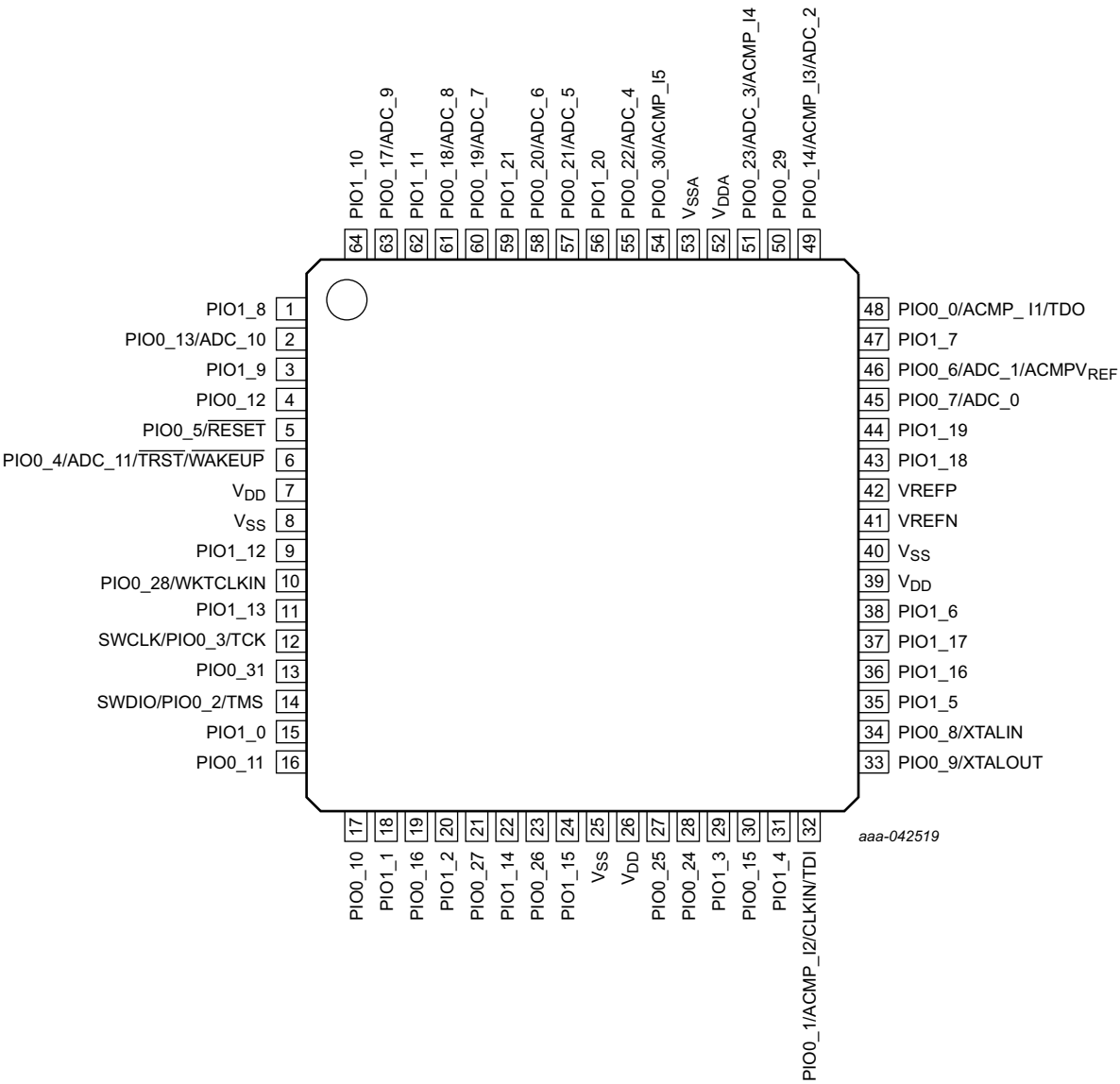


Fig 4. Pin configuration LQFP64 package

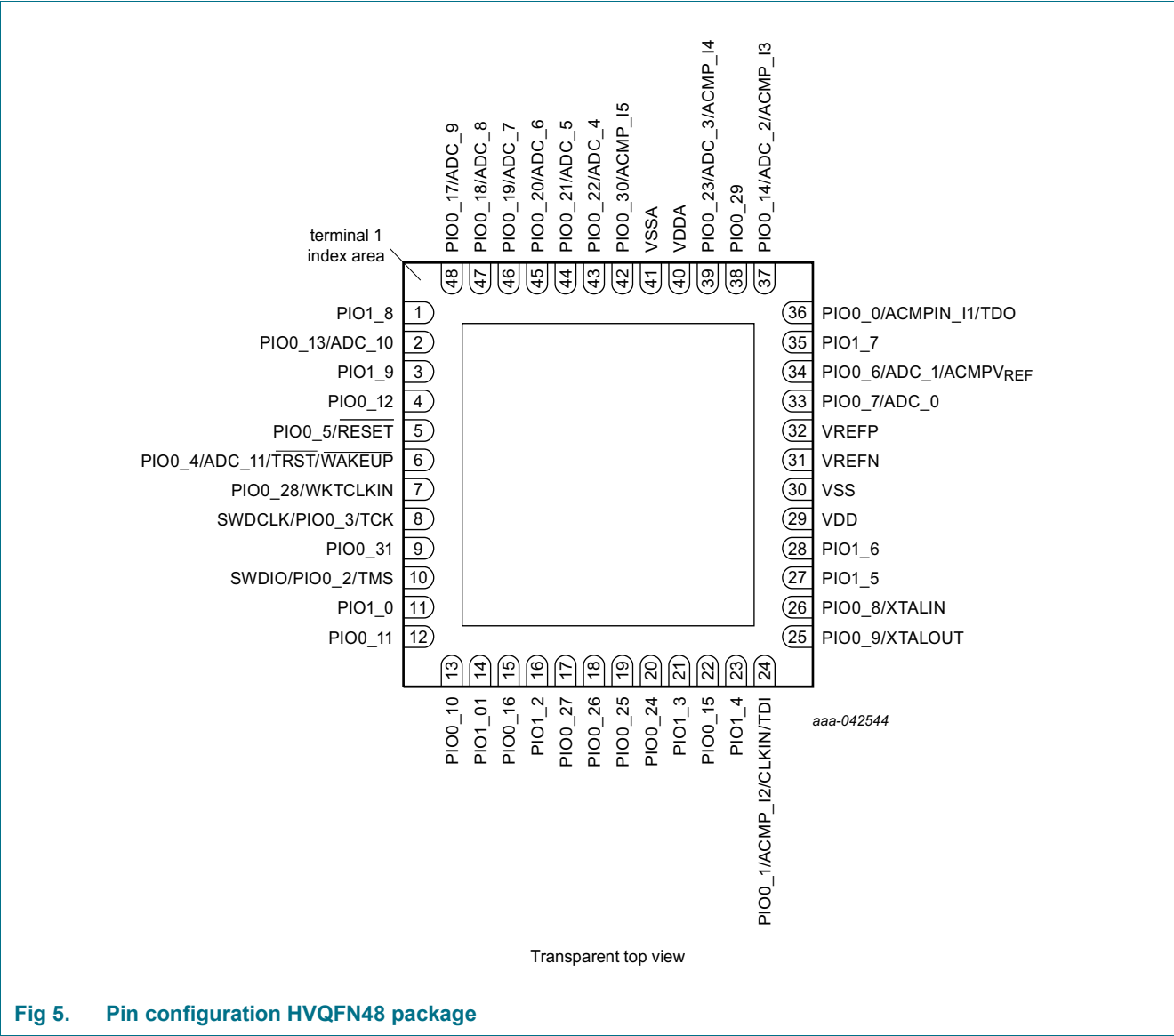


Fig 5. Pin configuration HVQFN48 package

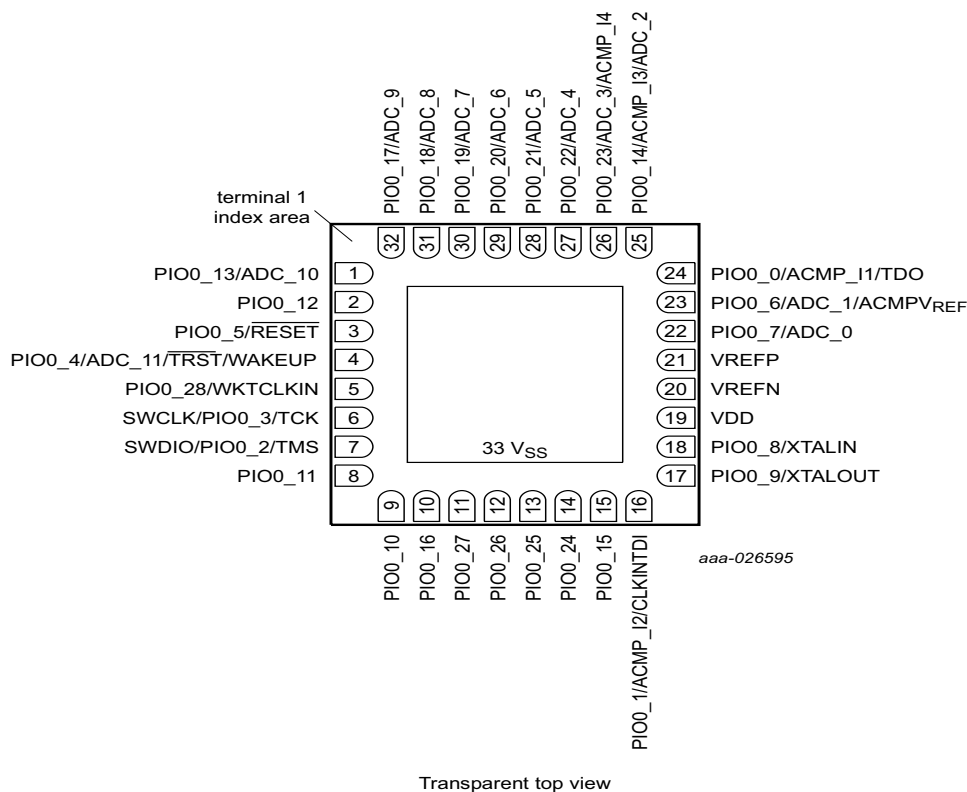


Fig 6. Pin configuration HVQFN32 package

7.2 Pin description

The pin description table shows the pin functions that are fixed to specific pins on each package. See [Table 4](#). These fixed-pin functions are selectable through the switch matrix between GPIO and the comparator, ADC, SWD, $\overline{\text{RESET}}$, and the XTAL pins. By default, the GPIO function is selected and is in a High-Z state except on pins PIO0_2, PIO0_3, and PIO0_5. JTAG functions are available in boundary scan mode only.

Movable functions for the I²C, I3C, USART, SPI, and other peripherals can be assigned through the switch matrix to any pin that is not powered or ground in place of the pin's fixed functions.

FlexTimer functions can be placed on a selection of up to 3 pins through the switch matrix.

The following exceptions apply:

Do not assign more than one output to any pin. However, an output and/or one or more inputs can be assigned to a pin. Once any function is assigned to a pin, the pin's GPIO functionality is disabled.

Pin PIO0_4 triggers a wake-up from deep power-down mode. If the part must wake up from deep power-down mode via an external pin, do not assign any movable function to this pin.

PIO0_10 and PIO0_11 are high current source pins while PIO0_2, PIO0_3, PIO0_12, and PIO0_16 are high drive output pins.

The JTAG functions TDO, TDI, TCK, TMS, and $\overline{\text{TRST}}$ are selected on pins PIO0_0 to PIO0_4 by hardware when the part is in boundary scan mode.

Note: The switch matrix allows the I3C to map the IO to all pads. See [Table 5](#) for details.

Table 4. Pin description

Symbol	LQFP64	HVQFN48	HVQFN32		Reset state ^[1]	Type	Description
PIO0_0/ACMP_I1/ TDO	48	36	24	[2]	I; HI-Z	IO	PIO0_0 — General-purpose port 0 input/output 0. In boundary scan mode: TDO (Test Data Out).
						A	ACMP_I1 — Analog comparator input 1.
PIO0_1/ACMP_I2/ CLKIN/TDI	32	24	16	[2]	I; HI-Z	IO	PIO0_1 — General-purpose port 0 input/output 1. In boundary scan mode: TDI (Test Data In).
						A	ACMP_I2 — Analog comparator input 2.
						I	CLKIN — External clock input.
SWDIO/PIO0_2/ TMS	14	10	7	[4]	I; HI-Z	IO	SWDIO — Serial Wire Debug I/O. SWDIO is enabled by default on this pin. In boundary scan mode: TMS (Test Mode Select).
						I/O	PIO0_2 — General-purpose port 0 input/output 2.
SWCLK/PIO0_3/ TCK	12	8	6	[4]	I; HI-Z	I	SWCLK — Serial Wire Clock. SWCLK is enabled by default on this pin. In boundary scan mode: TCK (Test Clock).
						IO	PIO0_3 — General-purpose port 0 input/output 3.
PIO0_4/ADC_11/ TRSTN/WAKEUP	6	6	4	[3]	I; HI-Z	IO	PIO0_4 — General-purpose port 0 input/output 4. In boundary scan mode: $\overline{\text{TRST}}$ (Test Reset). This pin triggers a wake-up from deep power-down mode. If the part must wake up from deep power-down mode via the WAKEUP pin, do not assign any movable function to this pin and must be externally pulled HIGH before entering deep power-down mode. A LOW-going pulse as short as 50 ns causes the chip to exit deep power-down mode and wakes up the part. The WAKEUP pin can be left unconnected or be used as a GPIO or for any movable function if an external WAKEUP function is not needed.
						A	ADC_11 — ADC input 11.

Table 4. Pin description

Symbol	LQFP64	HVQFN48	HVQFN32		Reset state ^[1]	Type	Description
RESET/PIO0_5	5	5	3	[7]	I; HI-Z	I	<p>RESET — External reset input: A LOW-going pulse (minimum 20 ns to maximum 50 ns) on this pin resets the device, causing I/O ports and peripherals to take on their default states, and processor execution to begin at address 0.</p> <p>This pin triggers a wake-up from deep power-down mode. If the part must wake up from deep power-down mode via the RESET pin, do not assign any movable function to this pin and must be externally pulled HIGH before entering deep power-down mode. The RESET pin can be left unconnected or be used as a GPIO or for any movable function if an external RESET function is not needed.</p>
PIO0_6/ADC_1/ ACMPV _{REF}	46	34	23	[10]	I; HI-Z	IO	PIO0_5 — General-purpose port 0 input/output 5.
						IO	PIO0_6 — General-purpose port 0 input/output 6.
						A	ADC_1 — ADC input 1.
						A	ACMPV_{REF} — Alternate reference voltage for the analog comparator.
PIO0_7/ADC_0	45	33	22	[2]	I; HI-Z	IO	PIO0_7 — General-purpose port 0 input/output 7.
						A	ADC_0 — ADC input 0.
PIO0_8/XTALIN	34	26	18	[8]	I; HI-Z	IO	PIO0_8 — General-purpose port 0 input/output 8.
						A	XTALIN — Input to the oscillator circuit and internal clock generator circuits. Input voltage must not exceed 1.95 V in target mode. See Section 14.2.2 “XTAL input” .
PIO0_9/XTALOUT	33	25	17	[8]	I; HI-Z	IO	PIO0_9 — General-purpose port 0 input/output 9.
						A	XTALOUT — Output from the oscillator circuit.
PIO0_10	17	13	9	[6]	I; F	IO	PIO0_10 — General-purpose port 0 input/output 10 (open-drain).
							I2C0_SCL — Open-drain I ² C-bus clock input/output. High-current sink if I ² C Fast-mode Plus is selected in the I/O configuration register.
PIO0_11	16	12	8	[6]	I; F	IO	PIO0_11 — General-purpose port 0 input/output 11 (open-drain).
							I2C0_SDA — Open-drain I ² C-bus data input/output. High-current sink if I ² C Fast-mode Plus is selected in the I/O configuration register.
PIO0_12	4	4	2	[4]	I; HI-Z	IO	PIO0_12 — General-purpose port 0 input/output 12. ISP entry pin. A LOW level on this pin during reset starts the ISP command handler.
PIO0_13/ADC_10	2	2	1	[2]	I; HI-Z	IO	PIO0_13 — General-purpose port 0 input/output 13.
						A	ADC_10 — ADC input 10.

Table 4. Pin description

Symbol	LQFP64	HVQFN48	HVQFN32		Reset state ^[1]	Type	Description
PIO0_14/ ACMP_I3/ADC_2	49	37	25	[2]	I; HI-Z	IO	PIO0_14 — General-purpose port 0 input/output 14.
						A	ACMP_I3 — Analog comparator common input 3.
						A	ADC_2 — ADC input 2.
PIO0_15	30	22	15	[5]	I; HI-Z	IO	PIO0_15 — General-purpose port 0 input/output 15.
PIO0_16	19	15	10	[4]	I; HI-Z	IO	PIO0_16 — General-purpose port 0 input/output 16.
PIO0_17/ADC_9	63	48	32	[2]	I; HI-Z	IO	PIO0_17 — General-purpose port 0 input/output 17.
						A	ADC_9 — ADC input 9.
PIO0_18/ADC_8	61	47	31	[2]	I; HI-Z	IO	PIO0_18 — General-purpose port 0 input/output 18.
						A	ADC_8 — ADC input 8.
PIO0_19/ADC_7	60	46	30	[2]	I; HI-Z	IO	PIO0_19 — General-purpose port 0 input/output 19.
						A	ADC_7 — ADC input 7.
PIO0_20/ADC_6	58	45	29	[2]	I; HI-Z	IO	PIO0_20 — General-purpose port 0 input/output 20.
						A	ADC_6 — ADC input 6.
PIO0_21/ADC_5	57	44	28	[2]	I; HI-Z	IO	PIO0_21 — General-purpose port 0 input/output 21.
						A	ADC_5 — ADC input 5.
PIO0_22/ADC_4	55	43	27	[2]	I; HI-Z	IO	PIO0_22 — General-purpose port 0 input/output 22.
						A	ADC_4 — ADC input 4.
PIO0_23/ADC_3/ ACMP_I4	51	39	26	[2]	I; HI-Z	IO	PIO0_23 — General-purpose port 0 input/output 23.
						A	ADC_3 — ADC input 3.
						A	ACMP_I4 — Analog comparator common input 4.
PIO0_24	28	20	14	[5]	I; HI-Z	IO	PIO0_24 — General-purpose port 0 input/output 24. In ISP mode, this is the U0_RXD pin.
PIO0_25	27	19	13	[5]	I; HI-Z	IO	PIO0_25 — General-purpose port 0 input/output 25. In ISP mode, this pin is the U0_TXD pin.
PIO0_26	23	18	12	[5]	I; HI-Z	IO	PIO0_26 — General-purpose port 0 input/output 26.
PIO0_27	21	17	11	[5]	I; HI-Z	IO	PIO0_27 — General-purpose port 0 input/output 27.
PIO0_28/ WKTCLKIN	10	7	5	[3]	I; HI-Z	IO	PIO0_28 — General-purpose port 0 input/output 28. This pin can host an external clock for the self-wake-up timer. To use the pin as a self-wake-up timer clock input, select the external clock in the wake-up timer CTRL register. The external clock input is active in all power modes, including deep power-down.
PIO0_29	50	38	-	[5]	I; HI-Z	IO	PIO0_29 — General-purpose port 0 input/output 29.
PIO0_30/ACMP_I5	54	42	-	[5]	I; HI-Z	IO	PIO0_30 — General-purpose port 0 input/output 30.
						A	ACMP_I5 — Analog comparator common input 5.
PIO0_31	13	9	-	[5]	I; HI-Z	IO	PIO0_31 — General-purpose port 0 input/output 31.
PIO1_0	15	11	-	[5]	I; HI-Z	IO	PIO1_0 — General-purpose port 1 input/output 0.
PIO1_1	18	14	-	[5]	I; HI-Z	IO	PIO1_1 — General-purpose port 1 input/output 1.

Table 4. Pin description

Symbol	LQFP64	HVQFN48	HVQFN32		Reset state ^[1]	Type	Description
PIO1_2	20	16	-	[5]	I; HI-Z	IO	PIO1_2 — General-purpose port 1 input/output 2.
PIO1_3	29	21	-	[5]	I; HI-Z	IO	PIO1_3 — General-purpose port 1 input/output 3.
PIO1_4	31	23	-	[5]	I; HI-Z	IO	PIO1_4 — General-purpose port 1 input/output 4.
PIO1_5	35	27	-	[5]	I; HI-Z	IO	PIO1_5 — General-purpose port 1 input/output 5.
PIO1_6	38	28	-	[5]	I; HI-Z	IO	PIO1_6 — General-purpose port 1 input/output 6.
PIO1_7	47	35	-	[5]	I; HI-Z	IO	PIO1_7 — General-purpose port 1 input/output 7.
PIO1_8	1	1	-	[5]	I; HI-Z	IO	PIO1_8 — General-purpose port 1 input/output 8.
PIO1_9	3	3	-	[5]	I; HI-Z	IO	PIO1_9 — General-purpose port 1 input/output 9.
PIO1_10	64	-	-	[5]	I; HI-Z	IO	PIO1_10 — General-purpose port 1 input/output 10.
PIO1_11	62	-	-	[5]	I; HI-Z	IO	PIO1_11 — General-purpose port 1 input/output 11.
PIO1_12	9	-	-	[5]	I; HI-Z	IO	PIO1_12 — General-purpose port 1 input/output 12.
PIO1_13	11	-	-	[5]	I; HI-Z	IO	PIO1_13 — General-purpose port 1 input/output 13.
PIO1_14	22	-	-	[5]	I; HI-Z	IO	PIO1_14 — General-purpose port 1 input/output 14.
PIO1_15	24	-	-	[5]	I; HI-Z	IO	PIO1_15 — General-purpose port 1 input/output 15.
PIO1_16	36	-	-	[5]	I; HI-Z	IO	PIO1_16 — General-purpose port 1 input/output 16.
PIO1_17	37	-	-	[5]	I; HI-Z	IO	PIO1_17 — General-purpose port 1 input/output 17.
PIO1_18	43	-	-	[5]	I; HI-Z	IO	PIO1_18 — General-purpose port 1 input/output 18.
PIO1_19	44	-	-	[5]	I; HI-Z	IO	PIO1_19 — General-purpose port 1 input/output 19.
PIO1_20	56	-	-	[5]	I; HI-Z	IO	PIO1_20 — General-purpose port 1 input/output 20.
PIO1_21	59	-	-	[5]	I; HI-Z	IO	PIO1_21 — General-purpose port 1 input/output 21.
V _{DD}	7;26;39	29	19		-	-	Supply voltage for the I/O pad ring and the core voltage regulator.
V _{DDA}	52	40	-				Analog supply voltage.
V _{SS}	8;25;40	30	33		-	-	Ground.
V _{SSA}	53	41	-				Analog ground.
VREFN	41	31	20		-	-	ADC negative reference voltage.
VREFP	42	32	21		-	-	ADC positive reference voltage. Must be equal or lower than V _{DDA} .

- [1] Pin state at reset for default function: I = Input; AI = Analog Input; O = Output; PU = internal pull-up enabled (pins pulled up to full V_{DD} level); IA = inactive, no pull-up/down enabled; F = floating. For pin states in the different power modes, see [Section 14.6 “Pin states in different power modes”](#). For termination on unused pins, see [Section 14.5 “Termination of unused pins”](#).
- [2] 5 V tolerant pin providing standard digital I/O functions with configurable modes, configurable hysteresis, and analog input. When configured as an analog input, the digital section of the pin is disabled, and the pin is not 5 V tolerant.
- [3] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors and configurable hysteresis. This pin is active in deep power-down mode and includes a 20 ns glitch filter (active in all power modes). In deep power-down mode, pulling the WAKEUP pin LOW wakes up the chip. The wake-up pin function can be disabled and the pin can be used for other purposes if the WKT low-power oscillator is enabled for waking up the part from deep power-down mode. See [Table 21 “Dynamic characteristics: WKTCLKIN pin”](#) for the WKTCLKIN input.
- [4] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors and configurable hysteresis; includes high-current output driver.
- [5] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors and configurable hysteresis.

- [6] True open-drain pin. I²C-bus pins are compliant with the I²C-bus specification for I²C standard mode, I²C Fast-mode, and I²C Fast-mode Plus. Do not use this pad for high-speed applications such as SPI or USART. The pin requires an external pull-up to provide output functionality. When power is switched off, this pin is floating and does not disturb the I²C lines. Open-drain configuration applies to all functions on this pin.
- [7] See [Figure 12](#) for the reset pad configuration. This pin includes a 20 ns glitch filter (active in all power modes). $\overline{\text{RESET}}$ functionality is available in deep power-down mode. Use the $\overline{\text{WAKEUP}}$ pin to reset the chip and wake up from deep power-down mode.
- [8] 5 V tolerant pin providing standard digital I/O functions with configurable modes, configurable hysteresis, and analog I/O for the system oscillator. When configured for XTALIN and XTALOUT, the digital section of the pin is disabled, and the pin is not 5 V tolerant.
- [9] The WKTCLKIN function is enabled in the DPDCTRL register in the PMU. See the LPC86x user manual.
- [10] The digital part of this pin is a 3 V tolerant pin due to special analog functionality. Pin provides standard digital I/O functions with configurable modes, configurable hysteresis, and an analog input. When configured as an analog input, the digital section of the pin is disabled.

Table 5. Movable functions (assign to pins PIO0_0 to PIO0_31, PIO1_0 to PIO1_21 through switch matrix)

Function name	Type	Description
Ux_TXD	O	Transmitter output for USART0 to USART2.
Ux_RXD	I	Receiver input for USART0 to USART2.
$\overline{\text{Ux_RTS}}$	O	Request To Send output for USART0 to USART2.
$\overline{\text{Ux_CTS}}$	I	Clear To Send input for USART0 to USART2.
Ux_SCLK	I/O	Serial clock input/output for USART0 to USART2 in synchronous mode.
SPIx_SCK	I/O	Serial clock for SPI0 and SPI1.
SPIx_MOSI	I/O	Controller Out Target In for SPI0 and SPI1.
SPIx_MISO	I/O	Controller In Target Out for SPI0 and SPI1.

Table 5. Movable functions (assign to pins PIO0_0 to PIO0_31, PIO1_0 to PIO1_21 through switch matrix)

Function name	Type	Description
SPIx_SSEL0	I/O	Target select 0 for SPI0 and SPI1.
SPIx_SSEL1	I/O	Target select 1 for SPI0 and SPI1.
SPIx_SSEL2	I/O	Target select 2 for SPI0.
SPIx_SSEL3	I/O	Target select 3 for SPI0.
I2Cx_SDA	I/O	I ² C0 bus data input/output.
I2Cx_SCL	I/O	I ² C0 bus clock input/output.
ACMP_O	O	Analog comparator output.
CLKOUT	O	Clock output.
GPIO_INT_BMAT	O	Output of the pattern match engine.
I3C0_SDA	I/O	I3C data input/output.
I3C0_SCL	I/O	I3C clock input/output.
I3C0_PUR	O	I3C pull-up resistor control

Table 6. Flextimer pin assignments

Function name	Type	Selection 0	Selection 1	Selection 2	Selection 3
FTM0_EXTCLK	I	P0_24	P0_30	-	Not connected
FTM0_CH0	I/O	P0_17	P1_1	-	Not connected
FTM0_CH1	I/O	P0_18	P1_2	P0_16	Not connected
FTM0_CH2	I/O	P0_19	P1_3	P1_2	Not connected
FTM0_CH3	I/O	P0_20	P1_4	P0_27	Not connected
FTM0_CH4	I/O	P0_21	P1_5	P0_25	Not connected
FTM0_CH5	I/O	P0_22	P1_6	P0_24	Not connected
FTM0_FAULT0	I	P0_10	P1_7	P0_28	Not connected
FTM0_FAULT1	I	P0_11	P1_12	P1_3	Not connected
FTM0_FAULT2	I	P0_13	P1_13	-	Not connected
FTM0_FAULT3	I	P0_23	P1_14	-	Not connected
FTM1_EXTCLK	I	P0_25	P0_29	-	Not connected
FTM1_CH0	I/O	P0_15	P1_8	-	Not connected
FTM1_CH1	I/O	P0_16	P1_9	-	Not connected
FTM1_CH2	I/O	P0_26	P0_31	-	Not connected
FTM1_CH3	I/O	P0_27	P1_0	-	Not connected
FTM1_QD_PHA	I	P0_24	P0_29	-	Not connected
FTM1_QD_PHB	I	P0_25	P0_30	-	Not connected

8. Functional description

8.1 Arm Cortex-M0+ core

The Arm Cortex-M0+ core runs at an operating frequency of up to 60 MHz using a two-stage pipeline. The core revision is r0p1.

Integrated in the core are the NVIC and Serial Wire Debug with four breakpoints and two watchpoints. The Arm Cortex-M0+ core supports a single-cycle I/O enabled port for fast GPIO access.

The core includes a single-cycle multiplier and a system tick timer.

8.2 On-chip flash program memory

The LPC86x contains up to 64 KB of on-chip flash program memory. The flash memory supports a 64 Byte page size with page write and erase.

8.3 On-chip SRAM

The LPC86x contains a total of 8 KB of on-chip static RAM data memory in one block.

A bit-band module is added in series with the AHB matrix to allow atomic read-modify-write operations acting on a single bit.

8.4 On-chip ROM

The on-chip ROM contains the bootloader:

- Boot loader.
- Supports Flash In-Application Programming (IAP).
- Supports In-System Programming (ISP) through USART.
- FRO API.

8.5 Memory map

The LPC86x incorporates several distinct memory regions. [Figure 7](#) shows the overall map of the entire address space from the user program viewpoint following the reset. The interrupt vector area supports address remapping.

The Arm private peripheral bus includes the Arm core registers for controlling the NVIC, the system tick timer (SysTick), and the reduced power modes.

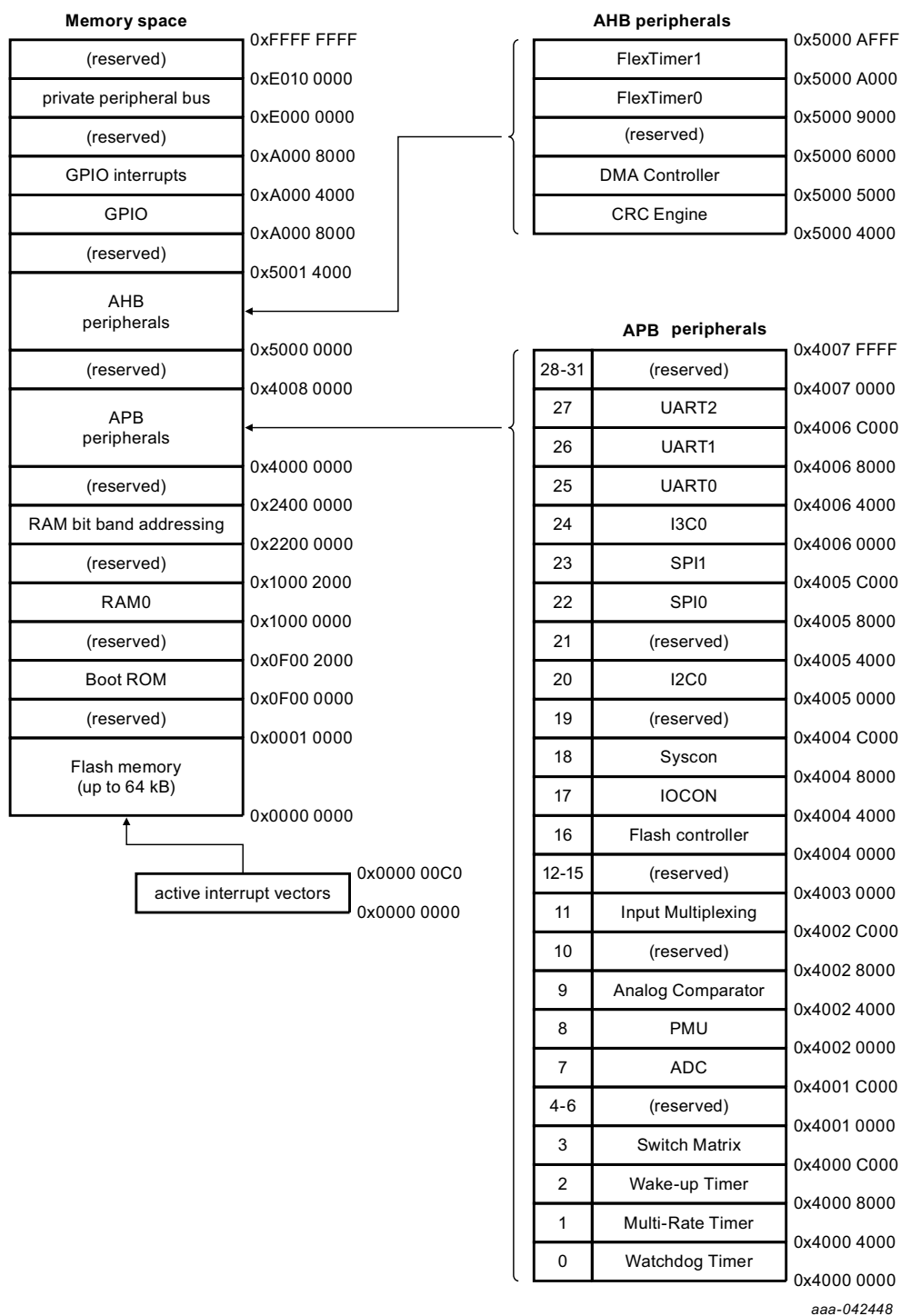


Fig 7. LPC86x AHB Memory mapping

8.6 Nested Vectored Interrupt Controller (NVIC)

The Nested Vectored Interrupt Controller (NVIC) is part of the Cortex-M0+. The tight coupling to the CPU allows for low interrupt latency and efficient processing of late-arriving interrupts.

8.6.1 Features

- Nested Vectored Interrupt Controller is a part of the Arm Cortex-M0+.
- Tightly coupled interrupt controller provides low interrupt latency.
- Controls system exceptions and peripheral interrupts.
- Supports 32 vectored interrupts.
- In the LPC86x, the NVIC supports vectored interrupts for each of the peripherals and the eight-pin interrupts.
- Four programmable interrupt priority levels with hardware priority level masking.
- Software interrupt generation using the Arm exceptions SVCALL and PENDSV.
- Supports NMI.

8.6.2 Interrupt sources

Each peripheral device has at least one interrupt line connected to the NVIC but can have several interrupt flags. Individual interrupt flags can also represent more than one interrupt source.

8.7 System tick timer

The Arm Cortex-M0+ includes a 24-bit system tick timer (SysTick) that is intended to generate a dedicated SysTick exception at a fixed time interval (typically 10 ms).

8.8 I/O configuration

The IOCON block controls the configuration of the I/O pins. Each digital or mixed digital/analog pin with the PIO0_n designator (except the true open-drain pins PIO0_10 and PIO0_11) in [Table 4](#) can be configured as follows:

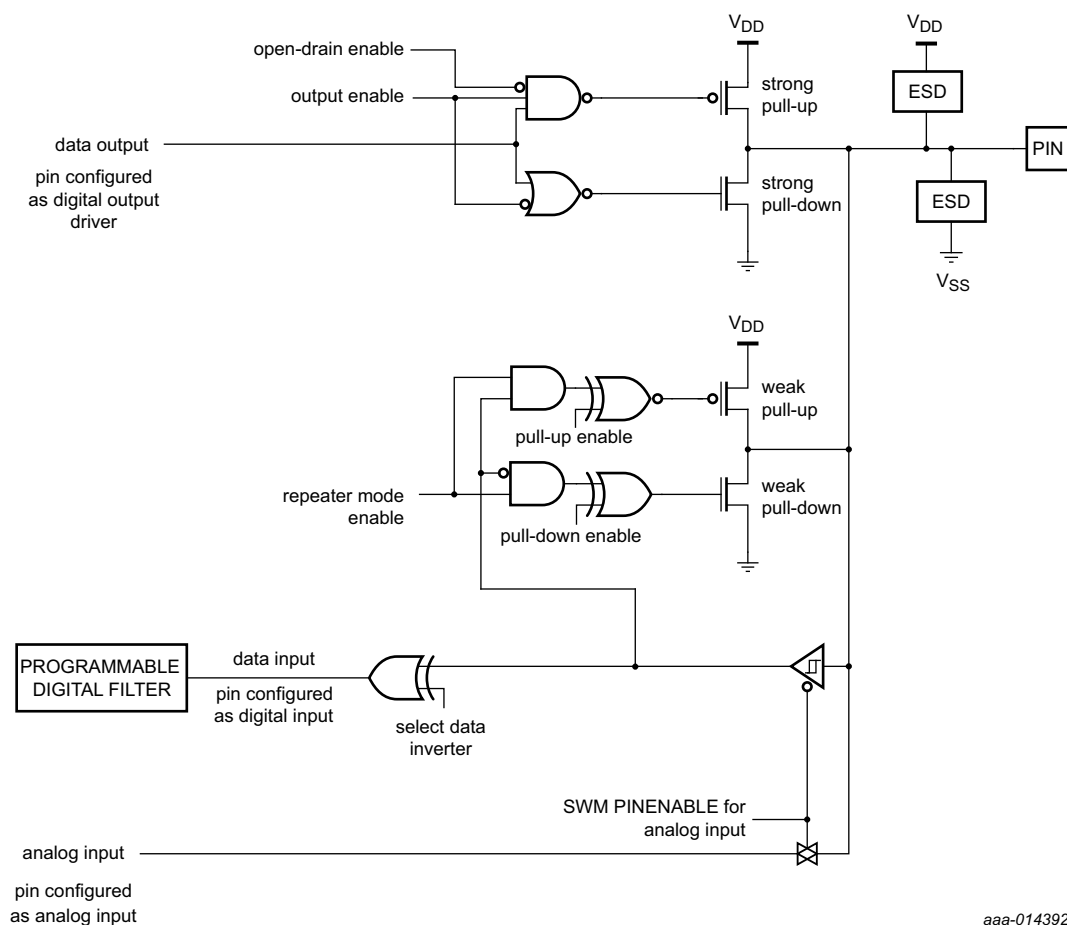
- Enable or disable the weak internal pull-up and pull-down resistors. After power on, the default state is tri-state.
- Select a pseudo open-drain mode. The input cannot be pulled up above V_{DD} . The pins are not 5 V tolerant when V_{DD} is grounded.
- Program the input glitch filter with different filter constants using one of the IOCON divided clock signals (IOCONCLKCDIV, see [Figure 10 "Clock generation"](#)). You can also bypass the glitch filter.
- Invert the input signal.
- Hysteresis can be enabled or disabled.
- For pins PIO0_10 and PIO0_11, select the I²C-mode and output driver for standard digital operation, for I²C standard and fast modes, or I²C Fast mode+.
- The switch matrix setting enables the analog input mode on pins with analog and digital functions. Enabling the analog mode disconnects the digital functionality.

Remark: The functionality of each I/O pin is flexible and is determined entirely through the switch matrix. See [Section 8.9](#) for details.

8.8.1 Standard I/O pad configuration

[Figure 8](#) shows the possible pin modes for standard I/O pins with analog input function:

- Digital output driver with configurable open-drain output.
- Digital input: Weak pull-up resistor (PMOS device) enabled/disabled.
- Digital input: Weak pull-down resistor (NMOS device) enabled/disabled.
- Digital input: Repeater mode enabled/disabled.
- Digital input: Programmable input digital filter selectable on all pins.
- Analog input: Selected through the switch matrix.



aaa-014392

Fig 8. Standard I/O pad configuration

8.9 Switch Matrix (SWM)

The switch matrix controls the function of each digital or mixed analog/digital pin in a highly flexible way by allowing it to connect many functions, for example, the USART, SPI, I2C, and I3C functions to any pin that is not power or ground. These functions are called movable functions and are listed in [Table 5](#). FlexTimer functions can be assigned to one of 2 or 3 selectable IO pins. The FlexTimer connections are listed in [Table 6](#).

Functions that need specialized pads like the oscillator pins XTALIN and XTALOUT can be enabled or disabled through the switch matrix. These functions are called fixed-pin functions and cannot move to other pins. The fixed-pin functions are listed in [Table 4](#). If a fixed-pin function is disabled, any other movable function can be assigned to this pin.

8.10 Fast General-Purpose parallel I/O (GPIO)

Device pins that are not connected to a specific peripheral function are controlled by the GPIO registers. Pins may be dynamically configured as inputs or outputs. Multiple outputs can be set or cleared in one write operation.

LPC86x use accelerated GPIO functions:

- GPIO registers are on the Arm Cortex-M0+ IO bus for the fastest possible single-cycle I/O timing, allowing GPIO toggling with rates of up to 30 MHz.
- An entire port value can be written in one instruction.
- Mask, set, and clear operations are supported for the entire port.

All GPIO port pins are fixed-pin functions that are enabled or disabled on the pins by the switch matrix. Therefore each GPIO port pin is assigned to one specific pin and cannot be moved to another pin. Except for pins SWDIO/PIO0_2, SWCLK/PIO0_3, and RESET/PIO0_5, the switch matrix enables the GPIO port pin function by default.

8.10.1 Features

- Bit-level port registers allow a single instruction to set and clear any number of bits in one write operation.
- Direction control of individual bits.
- All I/O default to GPIO inputs with internal pull-up resistors enabled after reset - except for the I²C-bus true open-drain pins PIO0_10 and PIO0_11.
- Pull-up/pull-down configuration, repeater, and open-drain modes can be programmed through the IOCON block for each GPIO pin (see [Figure 8](#)).
- Direction (input/output) can be set and cleared individually.
- Pin direction bits can be toggled.

8.11 Pin interrupt/pattern match engine

The pin interrupt block configures up to eight pins from all digital pins for providing eight external interrupts connected to the NVIC.

The pattern match engine can be used, with software, to create complex state machines based on pin inputs.

Any digital pin, independently of the function selected through the switch matrix, can be configured through the SYSCON block as input to the pin interrupt or pattern match engine. The registers that control the pin interrupt or pattern match engine are on the IO+ bus for fast single-cycle access.

8.11.1 Features

- Pin interrupts
 - Up to eight pins can be selected from all digital pins as edge- or level-sensitive interrupt requests. Each request creates a separate interrupt in the NVIC.
 - Edge-sensitive interrupt pins can interrupt on rising or falling edges or both.
 - Level-sensitive interrupt pins can be HIGH- or LOW-active.
 - Pin interrupts can wake up the LPC86x from sleep mode, deep-sleep mode, and power-down mode.
- Pin interrupt pattern match engine
 - Up to eight pins can be selected from all digital pins to contribute to a boolean expression. The boolean expression consists of specified levels and/or transitions on various combinations of these pins.
 - Each minterm (product term) comprising the specified boolean expression can generate its own, dedicated interrupt request.
 - Any occurrence of a pattern match can be also programmed to generate an RXEV notification to the Arm CPU. The RXEV signal can be connected to a pin.
 - The pattern match engine does not facilitate wake-up.

8.12 DMA controller

The DMA controller can access all memories and the USART, SPI, I²C, and I³C. DMA transfers can also be triggered by internal events like the ADC interrupts, the pin interrupts (PININT0 and PININT1), FlexTimer, DMA requests, and the DMA trigger outputs.

8.12.1 Features

- Sixteen channels with each channel connected to peripheral request inputs.
- DMA operations can be triggered by on-chip events or by two-pin interrupts. Each DMA channel can select one trigger input from 13 sources.
- Priority is user selectable for each channel.
- Continuous priority arbitration.
- Address cache with two entries.
- Efficient use of data bus.
- Supports single transfers up to 1,024 words.
- Address increment options allow packing and/or unpacking data.

8.12.2 DMA trigger input MUX (TRIGMUX)

Each DMA trigger is connected to a programmable multiplexer which connects the trigger input to one of the multiple trigger sources. Each multiplexer supports the same trigger sources: the ADC sequence interrupts, the FlexTimer DMA request lines and pin interrupts PININT0 and PININT1, and the outputs of the DMA trigger 0 and 1 for chaining DMA triggers.

8.13 USART0/1/2

All USART functions are movable functions and are assigned to pins through the switch matrix.

8.13.1 Features

- Maximum bit rates of 1.875 Mbit/s in asynchronous mode and 10 Mbit/s in a synchronous mode for USART functions connected to all digital pins except the open-drain pins.
- 7, 8, or 9 data bits and 1 or 2 stop bits
- Synchronous mode with controller or target operation. Includes data phase selection and continuous clock option.
- Multiprocessor/multidrop (9-bit) mode with software address compare. (RS-485 possible with software address detection and transceiver direction control.)
- Parity generation and checking: odd, even, or none.
- One transmit and one receive data buffer.
- RTS/CTS for hardware signaling for automatic flow control. Software flow control can be performed using Delta CTS detect, Transmit Disable control, and any GPIO as an RTS output.
- Received data and status can optionally be read from a single register
- Break generation and detection.
- Receive data is 2 of 3 sample "voting". Status flag set when one sample differs.
- Built-in Baud Rate Generator.
- A fractional rate divider is shared among all UARTs.
- Interrupts available for Receiver Ready, Transmitter Ready, Receiver Idle, change in receiver break detect, Framing error, Parity error, Overrun, Underrun, Delta CTS detect, and receiver sample noise detected.
- Separate data and flow control loopback modes for testing.
- Baud rate clock can also be output in asynchronous mode.
- Receive idle timeout status detect and interrupt supported.

8.14 SPI0/1

All SPI functions are movable functions and are assigned to pins through the switch matrix.

8.14.1 Features

- Maximum data rates of up to 30 Mbit/s in controller mode and up to 18 Mbit/s in target mode for SPI functions connected to all digital pins except the open-drain pins.
- Data frames of 1 to 16 bits are supported directly. Larger frames are supported by the software.
- Controller and Target operation.
- Data can be transmitted to a target without the need to read incoming data, which can be useful while setting up an SPI memory.
- Control information can optionally be written along with data, which allows very versatile operation, including “any length” frames.
- One Target Select input/output with selectable polarity and flexible usage.

Remark: Texas Instruments SSI and National Microwire modes are not supported.

8.15 I²C-bus interface (I²C0)

The I²C-bus is bidirectional for inter-IC control using only two wires: a serial clock line (SCL) and a serial data line (SDA). Each device is recognized by a unique address and can operate as either a receiver-only device (for example, an LCD driver) or a transmitter with the capability to both receive and send information (such as memory). Transmitters and/or receivers can operate in either controller or target mode, depending on whether the chip has to initiate a data transfer or is only addressed. The I²C is a multi-master bus and can be controlled by more than one bus master.

The I²C0-bus functions are movable. However, only the true open-drain pins provide the electrical characteristics to support the full I²C-bus specification (see [Ref. 3](#)).

8.15.1 Features

- I²C0 supports Fast-mode Plus with data rates of up to 1 Mbit/s in addition to standard and fast modes on two true open-drain pins.
- True open-drain pins provide fail-safe operation: When the power to an I²C-bus device is switched off, the SDA and SCL pins connected to the I²C0-bus are floating and do not disturb the bus.
- Independent Controller, Target, and Monitor functions.
- Supports both Multi-controller and Multi-controller with Target functions.
- Multiple I²C target addresses are supported in hardware.
- One target address can be selectively qualified with a bit mask or an address range in order to respond to multiple I²C bus addresses.
- 10-bit addressing supported with software assist.
- Supports SMBus.

8.16 I³C-bus interface (I³C0)

The MIPI Alliance Improved Inter-Integrated Circuit (MIPI I³C) brings major improvements in use and power over I²C and provides an alternative to SPI for mid-speed applications.

The I3C bus protocol supports in-band interrupts (interrupts can go from target to controller without extra wires, such that the controller knows which target sent the interrupt), in-band command codes (Common Command Codes (CCC)), dynamic addressing, and multi-master / multi-drop.

Note: FCLK of I3C must < 25 MHz.

8.16.1 Features

- Two-wire multi-drop bus capable of 12.5 MHz clock speeds, with up to 11 devices.
 - Uses standard pads with 4 mA drive
 - Dynamically assigns target addresses, and targets do not require static addresses. However, targets may have an I²C static address assigned at start-up, so the target can operate on an I²C bus. By default, I3C supports seven-bit I²C-style addresses.
 - Allows targets to use the inbound SCL clock as the peripheral clock (instead of the clock from the controller) so devices can have slow or inaccurate clocks internally.
 - Allows simple targets, such as temperature sensors, to have no internal clock.
 - I3C controller supports handoff from Open Drain to Push-Pull mode for ACK to data transfer.
 - Normally the controller terminates the read, but for I3C, the target can also end the read.
- In-Band interrupts (IBI) are allowed, which allow slaves to notify a controller.
 - Can be prioritized. When multiple targets send interrupts to a controller at the same time, the order is resolved. Dynamic addresses establish the priority of the targets, so the controller controls the priority of the targets. Targets with lower-value dynamic addresses are higher-priority level IBIs.
 - Can start interrupts even when the controller is not active on the bus. No free-running clock is needed, but starting an interrupt requires a Bus Available condition.
 - Can resolve an initial event via a time-stamping option, not requiring an interrupt.
- Built-in commands are in separate “space,” so that these commands do not collide with normal Controller->Target messages.
 - Controls bus behavior, modes and states, low power state, inquiries, and more.
 - Has additional room for new built-in commands to be used by other groups.
- Organized forms of multi-master modes.
 - Secondary controllers, which use clean handoffs between different controllers.
- Hot-join onto the I3C bus allows devices to connect to the bus later than when the bus starts.
 - Enables a device or module to get onto the I3C bus when it wakes up after power-up or was physically inserted onto the I3C bus.
 - Provides a clean method for notification when new devices or modules get onto the I3C bus.
- Can use both I²C and I3C buses.

- I3C supports specific legacy I²C devices on the bus.
- I3C target devices can operate on I²C buses.
- Supports bridging to I²C, SPI, UART, and other busses.
- Higher data rate modes are available.
 - Has a High Data Rate - Double Data Rate (HDR-DDR) mode, which is double the data rate of SDR.
 - Only the controller and the specific target must support the higher data rate. The other targets can ignore it.
- The I3C peripheral supports the full I3C feature set, except for the ternary data rates (HDR-TSP and HDR-TSL) and peer-to-peer messaging, which are not supported.

8.17 FlexTimer (FTM0/1)

The FlexTimer module (FTM) is a two-to-eight-channel timer that supports input capture, output compare, and the generation of PWM signals to control electric motor and power management applications. The FTM time reference is a 16-bit counter that can be used as an unsigned or signed counter.

The LPC86x device has two FlexTimers, FTM0 and FTM1. The first FlexTimer (FTM0) provides six channels and includes support for motor control (including Fault Control). The second FlexTimer (FTM1) provides four channels. This timer does not include Fault Control but includes a Quadrature Decoder.

The corresponding FlexTimer trigger signals can be used to start ADC conversion as ADC hardware trigger inputs, see [Table 7 “ADC trigger inputs”](#).

8.17.1 Features

- FTM source clock is selectable. The source clock can be the FTM input clock, the fixed frequency clock, or an external clock
- Prescaler divide by 1, 2, 4, 8, 16, 32, 64, or 128
- 16-bit counter
- Each channel can be configured for input capture, output compare, or edge-aligned PWM mode
- Support dead time insertion, and automatic fault protection in PWM mode for FTM0
- Dual edge capture for pulse and period width measurement
- Generation of match triggers
- Up to 4 fault inputs for global fault control
- Configurable polarity of each channel
- Interrupt generation when the counter overflows, fault condition occurs, a register reload point occurs
- Half-cycle and Full-cycle register reload capacity

- Direct access to input pin states
- Dual edge capture for pulse and period width measurement
- Quadrature decoder with relative position counting, and interrupt on position count or capture of position count on external event
- Dithering capability to simulate fine edge control for both PWM period or PWM duty cycle

8.18 Multi-Rate Timer (MRT)

The Multi-Rate Timer (MRT) provides a repetitive interrupt timer with four channels. Each channel can be programmed with an independent time interval, and each channel operates independently from the other channels.

8.18.1 Features

- 31-bit interrupt timer
- Four channels independently counting down from individually set values
- Bus stall, repeat, and one-shot interrupt modes

8.19 Windowed WatchDog Timer (WWDT)

The watchdog timer resets the controller if the software fails to service the watchdog timer periodically within a programmable time window.

8.19.1 Features

- Internally resets chip if not periodically reloaded during the programmable time-out period.
- Optional windowed operation requires reload to occur between a minimum and maximum period, both programmable.
- Optional warning interrupt can be generated at a programmable time prior to watchdog time-out.
- Enabled by software but requires a hardware reset or a watchdog reset/interrupt to be disabled.
- Incorrect feed sequence causes reset or interrupt if enabled.
- Flag to indicate watchdog reset.
- Programmable 24-bit timer with internal prescaler.
- Selectable time period from $(T_{cy(WDCLK)} \times 256 \times 4)$ to $(T_{cy(WDCLK)} \times 2^{24} \times 4)$ in multiples of $T_{cy(WDCLK)} \times 4$.
- The WatchDog Clock (WDCLK) is generated by the low-power oscillator (LPOSC).

8.20 Self-Wake-up Timer (WKT)

The self-wake-up timer is a 32-bit, loadable down counter. Writing any non-zero value to this timer automatically enables the counter and launches a count-down sequence. When the counter is used as a wake-up timer, this write can occur prior to entering a reduced power mode.

8.20.1 Features

- 32-bit loadable down counter. The Counter starts automatically when a count value is loaded. Time-out generates an interrupt/wake-up request.
- The WKT resides in a separate, always-on power domain.
- The WKT supports three clock sources: an external clock on the WKTCLKIN pin, the low-power oscillator, and the FRO. The low-power oscillator is located in the always-on power domain, so it can be used as the clock source in deep power-down mode.
- The WKT can be used for waking up the part from any reduced power mode, including deep power-down mode, or for general-purpose timing.

8.21 Analog comparator (ACMP)

The analog comparator with selectable hysteresis can compare voltage levels on external pins and internal voltages.

After power-up and after switching the input channels of the comparator, the output of the voltage ladder must be allowed to settle to its stable value before it can be used as a comparator reference input. Settling times are given in [Table 32](#).

The analog comparator output is a movable function and is assigned to a pin through the switch matrix. The comparator inputs and the voltage reference are enabled through the switch matrix.

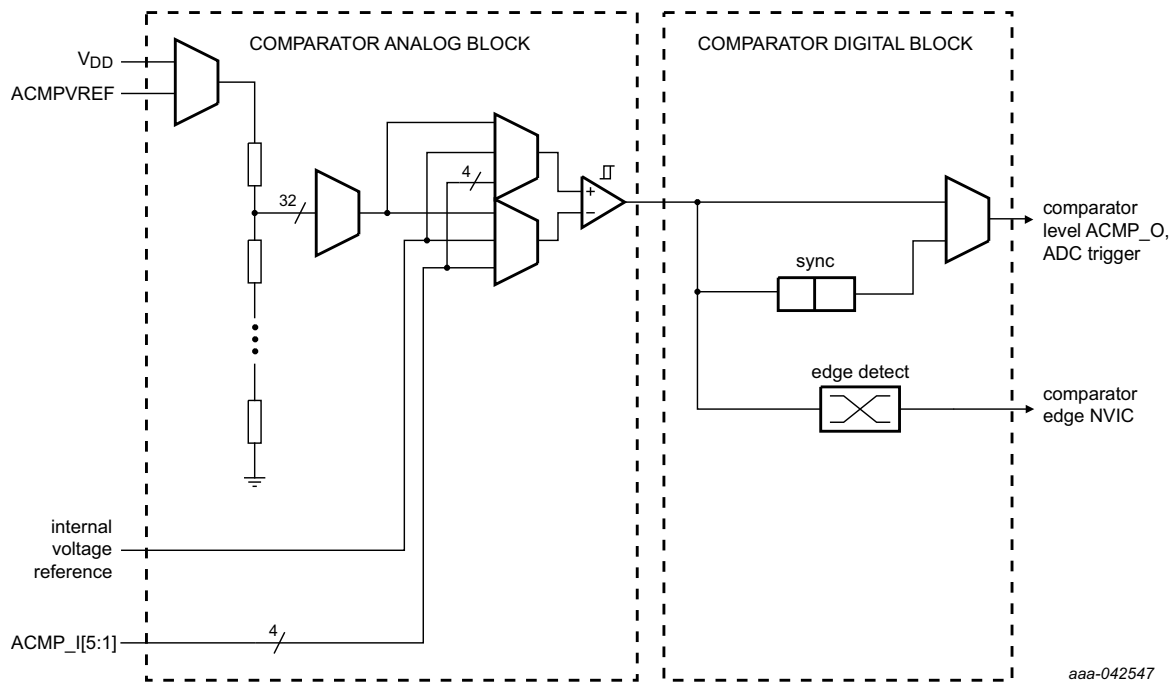


Fig 9. Comparator block diagram

8.21.1 Features

- Selectable 0 mV, 10 mV (± 5 mV), and 20 mV (± 10 mV), 40 mV (± 20 mV) input hysteresis.
- Two selectable external voltages (V_{DD} or $ACMPV_{REF}$); fully configurable on either positive or negative input channel.
- Internal voltage reference from band gap selectable on either positive or negative input channel.
- 32-stage voltage ladder with the internal reference voltage selectable on either the positive or the negative input channel.
- Voltage ladder source voltage is selectable from an external pin or the main 3.3 V supply voltage rail.
- Voltage ladder can be separately powered down for applications only requiring the comparator function.
- Interrupt output is connected to NVIC.
- Comparator level output is connected to output pin $ACMP_O$.
- One comparator output is internally connected to the ADC trigger input multiplexer.

8.22 Analog-to-Digital Converter (ADC)

The ADC supports a resolution of 12-bit and fast conversion rates of up to 1.9 MSamples/s. Sequences of analog-to-digital conversions can be triggered by multiple sources. The ADC trigger inputs are listed in the following table.

Table 7. ADC trigger inputs

Selection	Input source
0	No hardware trigger
1	GPIO_INT0
2	GPIO_INT1
3	FTM0_INIT_TRIG ORed with FTM0_EXT_TRIG
4	FTM1_INIT_TRIG ORed with FTM1_EXT_TRIG
5	ORed all FTM1_CHn_OUT
6	ACMP0_OUT
7	GPIOINT_BMATCH
8	ARM_TXEV

The ADC includes a hardware threshold compare function with zero-crossing detection.

Remark: For best performance, select V_{REFP} and V_{REFN} at the same voltage levels as V_{DD} and V_{SS} . When selecting V_{REFP} and V_{REFN} different from V_{DD} and V_{SS} , ensure that the voltage midpoints are the same:

$$(V_{REFP} - V_{REFN})/2 + V_{REFN} = V_{DD}/2$$

8.22.1 Features

- 12-bit successive approximation analog to digital converter.

- 12-bit conversion rate of up to 1.9 MSamples/s.
- Two configurable conversion sequences with independent triggers.
- Optional automatic high/low threshold comparison and zero-crossing detection.
- Power-down mode and low-power operating mode.
- Measurement range VREFN to VREFP (not to exceed V_{DD} voltage level).
- Burst conversion mode for single or multiple inputs.
- Hardware calibration mode.

8.23 CRC engine

The Cyclic Redundancy Check (CRC) generator with programmable polynomial settings supports several CRC standards commonly used. To save system power and bus bandwidth, the CRC engine supports DMA transfers.

8.23.1 Features

- Supports three common polynomials CRC-CCITT, CRC-16, and CRC-32.
 - CRC-CCITT: $x^{16} + x^{12} + x^5 + 1$
 - CRC-16: $x^{16} + x^{15} + x^2 + 1$
 - CRC-32: $x^{32} + x^{26} + x^{23} + x^{22} + x^{16} + x^{12} + x^{11} + x^{10} + x^8 + x^7 + x^5 + x^4 + x^2 + x + 1$
- Bit order reverse and 1's complement programmable setting for input data and CRC sum.
- Programmable seed number setting.
- Supports CPU PIO or DMA back-to-back transfer.
- Accept any size of data width per write: 8, 16 or 32-bit.
 - 8-bit write: 1-cycle operation.
 - 16-bit write: 2-cycle operation (8-bit x 2-cycle).
 - 32-bit write: 4-cycle operation (8-bit x 4-cycle).

8.24 Clocking and power control

8.24.1 Crystal and internal oscillators

The LPC86x includes four independent oscillators:

1. The crystal oscillator (SysOsc) operating at frequencies between 1 MHz and 25 MHz.
2. Free-Running Oscillator.
3. Low-Power Oscillator.

Each oscillator can be used for more than one purpose as required in a particular application.

Following reset, the LPC86x operates from the FRO until switched by software allowing the part to run without any external crystal and the bootloader code to operate at a known frequency.

See [Figure 10](#) for an overview of the LPC86x clock generation.

8.24.1.1 Free Running Oscillator (FRO)

The FRO oscillator provides the default clock at reset and provides a clean system clock shortly after the supply pins reach operating voltage.

- This oscillator provides selectable 36 MHz, 48 MHz, and 60 MHz outputs that can be used as a system clock. Also, these outputs can be divided down to 18 MHz, 24 MHz, and 30 MHz for the system clock.
- The FRO is trimmed to ± 1 % accuracy over the entire voltage and temperature range of 0 °C to 70 °C.
- By default, the `fro_oscout` is 48 MHz and is divided by 2 to provide a default system (CPU) clock frequency of 24 MHz.

8.24.1.2 Crystal Oscillator (SysOsc)

The crystal oscillator can be used as the clock source for the CPU, with or without using the PLL.

The SysOsc operates at frequencies of 1 MHz to 25 MHz. This frequency can be boosted to a higher frequency, up to the maximum CPU operating frequency, by the system PLL.

8.24.1.3 Low power Oscillator (LPOSC)

The nominal frequency of the LPOSC is programmable at 1 MHz. The frequency spread over silicon process variations is ± 3 %.

The LPOSC is a dedicated oscillator for the windowed WWDT.

The internal low-power 10 kHz (± 40 % accuracy) oscillator (ULPOSC) serves as the clock input to the WKT. This oscillator can be configured to run in all low-power modes.

8.24.2 Clock input

An external clock source can be supplied on the selected CLKIN pin directly to the PLL input. When selecting a clock signal for the CLKIN pin, follow the specifications for digital I/O pins in [Table 14 “Static characteristics, supply pins”](#) and [Table 20 “Dynamic characteristics: I/O pins^{\[1\]}”](#).

An 1.8 V external clock source can be supplied on the XTALIN pins to the system oscillator limiting the voltage of this signal (see [Section 14.2 “XTAL oscillator”](#)).

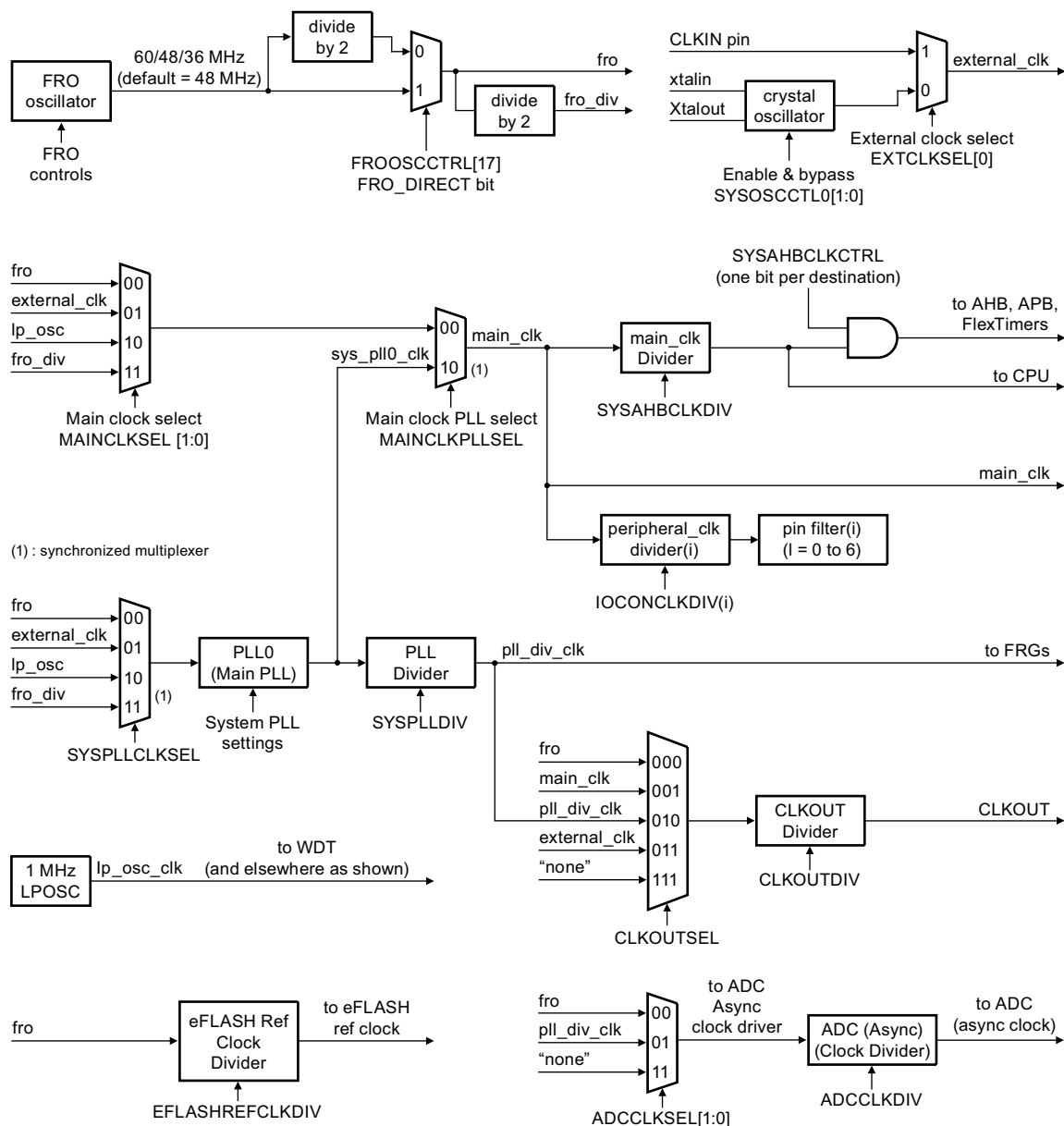
The maximum frequency for both clock signals is 25 MHz.

8.24.3 System PLL

The PLL accepts an input clock frequency in the range of 10 MHz to 25 MHz. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO). The multiplier can be an integer value from 1 to 32. The CCO operates in the range of 156 MHz to 320 MHz, so there is an additional divider in the loop to keep the CCO within its frequency range while the PLL is providing the desired output frequency. The output divider may be set to divide by 2, 4, 8, or 16 to produce the output clock. Since the minimum output divider value is 2, it is insured that the PLL output has a 50 % duty cycle. The PLL is turned off and bypassed following a chip reset and may be enabled by software. The program must configure and activate the PLL, wait for the PLL to lock, and then connect to the PLL as a clock source. The PLL settling time is nominally 100 μ s.

8.24.4 Clock output

The LPC86x features a clock output function that routes the FRO, the main clock to the CLKOUT function. The CLKOUT function can be connected to any digital pin through the switch matrix.



aaa-045744

Fig 10. Clock generation

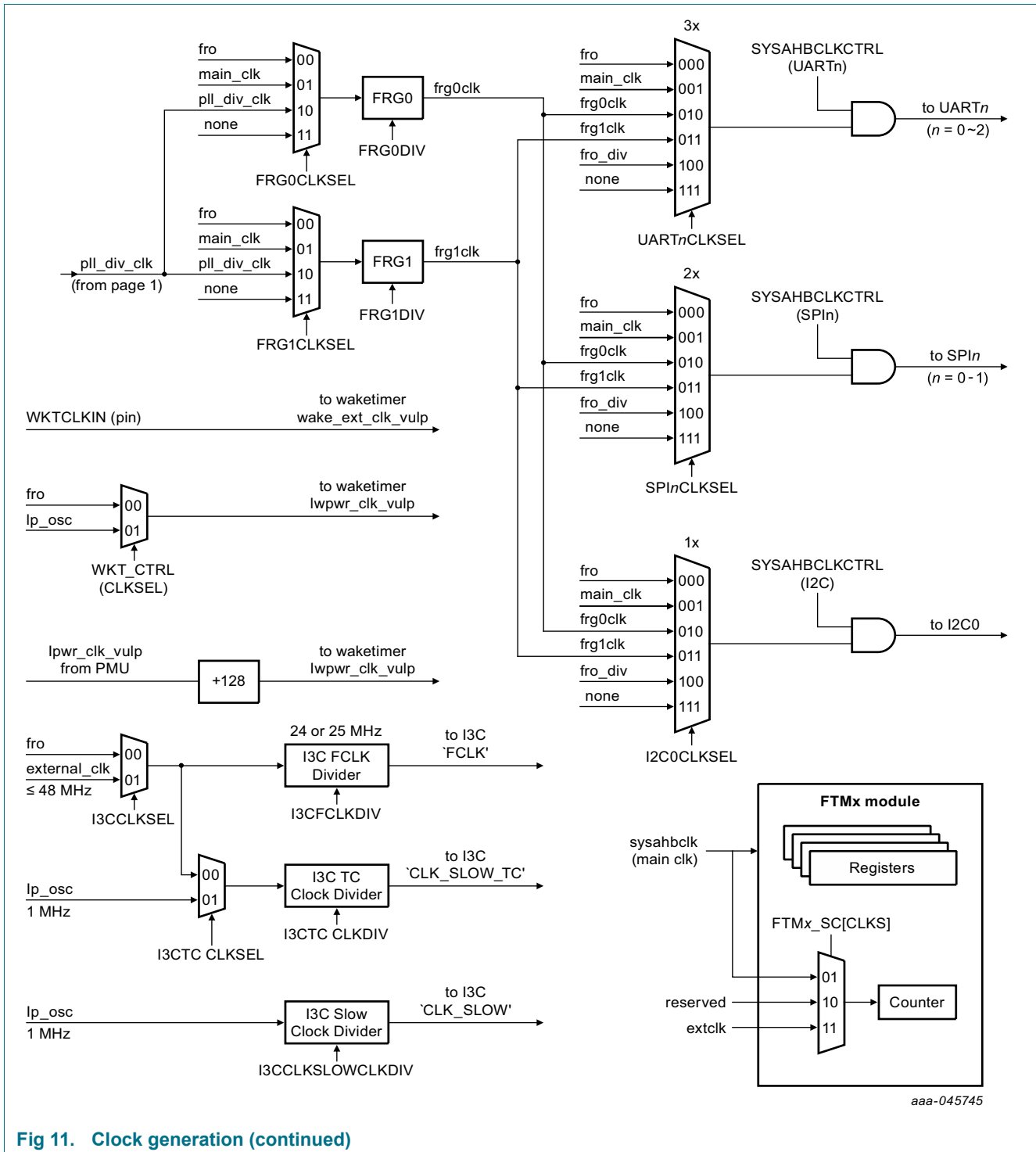


Fig 11. Clock generation (continued)

[1] FCLK of I3C must < 25MHz

Table 8. Clocking diagram signal name descriptions

Name	Description
sys_osc_clk	This is the internal clock that comes from external crystal oscillator through dedicated pins.
frg_clk	The output of the Fractional Rate Generator. The FRG and its source selection are shown in Figure 11 “Clock generation (continued)” .
fro	The output of the currently selected on-chip FRO oscillator. See UM11029 User manual.
fro_div	The FRO output. This may be either 15 Hz, 12 MHz, or 9 MHz. See UM11029 User manual.
main_clk	The main clock is used by the CPU and AHB bus, and potentially many others. The main clock and its source selection are shown in Figure 10 “Clock generation” .
“none”	A tied-off source should be selected to save power when the output of the related multiplexer is not used.
sys_pll0_clk	The output of the System PLL. The System PLL and its source selection are shown in Figure 10 “Clock generation” .
lp_osc_clk	The output of the low-power oscillator, which has a selectable target frequency. It must also be enabled in the PDRINCFG0 register. See UM11607 User manual.
xtalin	Input of the main oscillator. If used, this is connected to an external crystal and load capacitor.
xtalout	Output of the main oscillator. If used, this is connected to an external crystal and load capacitor.
clk_in	This is the internal clock that comes from the main CLK_IN pin function. Connect that function to the pin by selecting it in the IOCON block.
external_clk	This is the internal clock that comes from the external crystal oscillator or the CLK_IN pin.
extclk	FlexTimer external clock coming from FTM0_EXTCLK or FTM1_EXTCLK.

8.24.5 Power control

The LPC86x supports the Arm Cortex-M0+ sleep mode. The CPU clock rate may also be controlled as needed by changing clock sources, reconfiguring PLL values, and/or altering the CPU clock divider value. This allows a trade-off of power versus processing speed based on application requirements. In addition, a register is provided for shutting down the clocks to individual on-chip peripherals, allowing to fine-tune power consumption by eliminating all dynamic power use in any peripherals that are not required for the application. Selected peripherals have their own clock divider which provides even better power control.

8.24.5.1 Sleep mode

When sleep mode is entered, the clock to the core is stopped. Resumption from the sleep mode does not need any special sequence but re-enabling the clock to the Arm core.

In sleep mode, the execution of instructions is suspended until either a reset or interrupt occurs. Peripheral functions continue operation during sleep mode and may generate interrupts to cause the processor to resume execution. sleep mode eliminates dynamic power used by the processor itself, memory systems and related controllers and internal buses.

8.24.5.2 Deep-sleep mode

In deep-sleep mode, the LPC86x core is in sleep mode and all peripheral clocks and all clock sources are off except for the FRO or low-power oscillator if selected. The FRO output is disabled. In addition, all analog blocks are shut down and the flash is in standby mode. In deep-sleep mode, the application can keep the low-power oscillator and the BOD circuit running for self-timed wake-up and BOD protection.

The LPC86x can wake up from deep-sleep mode via a reset, digital pins selected as inputs to the pin interrupt block, a watchdog timer interrupt, or an interrupt from the USART (if the USART is configured in synchronous target mode), the SPI, or the I²C blocks (in target mode).

Any interrupt used for waking up from deep-sleep mode must be enabled in one of the SYSCON wake-up enable registers and the NVIC.

Deep-sleep mode saves power and allows for short wake-up times.

8.24.5.3 Power-down mode

In power-down mode, the LPC86x is in sleep mode and all peripheral clocks and all clock sources are off except for low-power oscillator if selected. In addition, all analog blocks and the flash are shut down. In power-down mode, the application can keep the low-power oscillator and the BOD circuit running for self-timed wake-up and BOD protection.

The LPC86x can wake up from power-down mode via a reset, digital pins selected as inputs to the pin interrupt block, a watchdog timer interrupt, or an interrupt from the USART (if the USART is configured in synchronous target mode), the SPI, or the I²C blocks (in target mode).

Any interrupt used for waking up from power-down mode must be enabled in one of the SYSCON wake-up enable registers and the NVIC.

Power-down mode reduces power consumption compared to deep-sleep mode at the expense of longer wake-up times.

8.24.5.4 Deep power-down mode

In deep power-down mode, power is shut off to the entire chip except for the $\overline{\text{WAKEUP}}$ pin and the self-wake-up timer. The LPC86x can wake up from deep power-down mode via the $\overline{\text{WAKEUP}}$ pin, $\overline{\text{RESET}}$ pin, or without an external signal by using the time-out of the self-wake-up timer (see [Section 8.20](#)).

The LPC86x can be prevented from entering deep power-down mode by setting a lock bit in the PMU block. Locking out deep power-down mode enables the application to keep the watchdog timer or the BOD running at all times.

If the part must wake up from deep power-down mode via the $\overline{\text{WAKEUP}}$ pin or $\overline{\text{RESET}}$ pin, do not assign any movable function to this pin, and must be externally pulled HIGH before entering deep power-down mode.

Table 9. Peripheral configuration in reduced power modes

Peripheral	Sleep mode	Deep-sleep mode	Power-down mode	Deep power-down mode
FRO	software configurable	on	off	off
FRO output	software configurable	off	off	off
Flash	software configurable	on	off	off
BOD	software configurable	software configurable	software configurable	off
PLL	software configurable	off	off	off
SysOsc	software configurable	off	off	off

Table 9. Peripheral configuration in reduced power modes

Peripheral	Sleep mode	Deep-sleep mode	Power-down mode	Deep power-down mode
LPOS	software configurable	software configurable	software configurable	off
Digital peripherals	software configurable	off	off	off
WKT	software configurable	software configurable	software configurable	software configurable
ADC	software configurable	off	off	off
Comparator	software configurable	off	off	off

Table 10. Wake-up sources for reduced power modes

power mode	Wake-up source	Conditions
Sleep	Any interrupt	Enable interrupt in NVIC.
	RESET pin PIO0_5	Enable the reset function in the PINENABLE0 register via switch matrix.
Deep-sleep and power-down	Pin interrupts	Enable pin interrupts in NVIC and STARTERP0 registers.
	BOD interrupt	<ul style="list-style-type: none"> • Enable interrupt in NVIC and STARTERP1 registers. • Enable interrupt in BODCTRL register. • BOD powered in PDSLEEPCFG register.
	BOD reset	<ul style="list-style-type: none"> • Enable reset in BODCTRL register. • BOD powered in PDSLEEPCFG register.
	WWDT interrupt	<ul style="list-style-type: none"> • Enable interrupt in NVIC and STARTERP1 registers. • WWDT running. Enable WWDT in WWDT MOD register and feed. • Enable interrupt in WWDT MOD register. • LPOSC powered in PDSLEEPCFG register.
	WWDT reset	<ul style="list-style-type: none"> • WWDT running. • Enable reset in WWDT MOD register. • LPOSC powered in PDSLEEPCFG register.
	Self-Wake-up Timer (WKT) time-out	<ul style="list-style-type: none"> • Enable interrupt in NVIC and STARTERP1 registers. • Enable low-power oscillator in the DPDCTRL register in the PCON block. • Select low-power clock for WKT clock in the WKT CTRL register. • Start the WKT by writing a time-out value to the WKT COUNT register.
	Interrupt from USART/SPI/I ² C peripheral	<ul style="list-style-type: none"> • Enable interrupt in NVIC and STARTERP1 registers. • Enable USART/I²C/SPI interrupts. • Provide an external clock signal to the peripheral. • Configure the USART in synchronous target mode and I²C and SPI in target mode.
	RESET pin PIO0_5	Enable the reset function in the PINENABLE0 register via switch matrix.
Deep power-down	WAKEUP pin PIO0_4	Enable the WAKEUP function in the DPDCTRL register in the PMU.
	RESET pin PIO0_5	Enable the reset function in the DPDCTRL register in the PMU to allow wake-up in deep power-down mode.
	WKT time-out	<ul style="list-style-type: none"> • Enable the low-power oscillator in the DPDCTRL register in the PMU. • Enable the low-power oscillator to keep running in deep power-down mode in the DPDCTRL register in the PMU. • Select low-power clock for WKT clock in the WKT CTRL register. • Start WKT by writing a time-out value to the WKT COUNT register.

8.24.6 Wake-up process

The LPC86x begin operation at power-up by using the FRO as the clock source allowing chip operation to resume quickly. If the SysOsc, the external clock source, or the PLL are needed by the application, the software must enable these features and wait for them to stabilize before they are used as a clock source.

8.25 System control

8.25.1 Reset

Reset has four sources on the LPC86x: the $\overline{\text{RESET}}$ pin, the Watchdog reset, power-on reset (POR), and the BrownOut Detection (BOD) circuit. The $\overline{\text{RESET}}$ pin is a Schmitt trigger input pin. Assertion of chip reset by any source, once the operating voltage attains a usable level, starts the FRO and initializes the flash controller.

A LOW-going pulse as short as 50 ns resets the part.

When the internal Reset is removed, the processor begins executing at address 0, which is initially the Reset vector mapped from the boot block. At that point, all of the processor and peripheral registers have been initialized to predetermined values.

In deep power-down mode, an external pull-up resistor is required on the $\overline{\text{RESET}}$ pin.

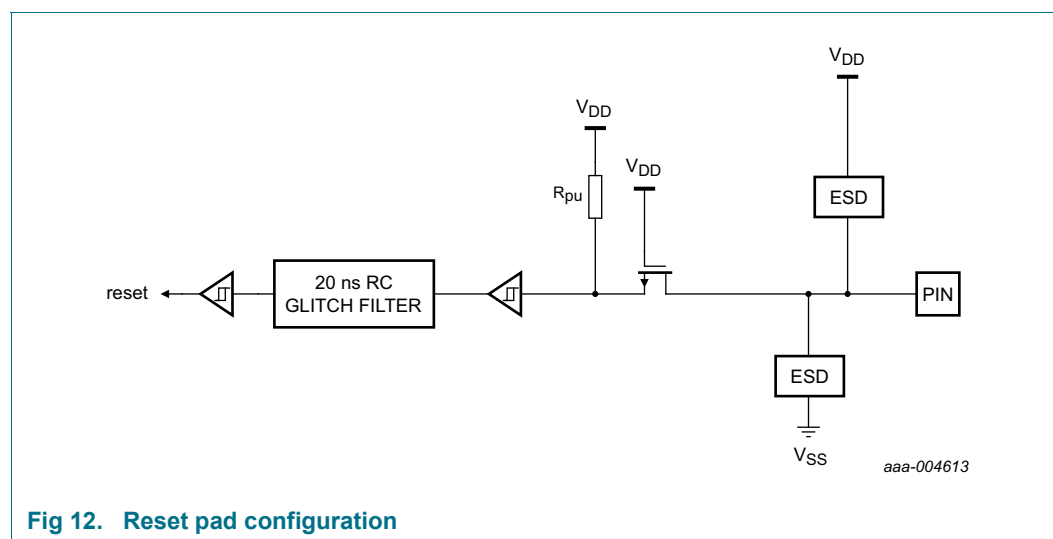


Fig 12. Reset pad configuration

8.25.2 Brownout detection

The LPC86x includes up to four levels for monitoring the voltage on the V_{DD} pin. If this voltage falls below one of the selected levels, the BOD asserts an interrupt signal to the NVIC. This signal can be enabled for interrupt in the Interrupt Enable Register in the NVIC to cause a CPU interrupt. Alternatively, the software can monitor the signal by reading a dedicated status register. Four threshold levels can be selected to cause a forced reset of the chip. BOD is enabled by default and reset level 0 is default.

8.25.3 Code Read Protection - CRP

CRP provides different levels of security in the system so that access to the on-chip flash and use of the Serial Wire Debugger (SWD) and In-System Programming (ISP) can be restricted. Programming a specific pattern into a dedicated flash location invokes CRP. IAP commands are not affected by the CRP.

In addition, ISP entry via the ISP entry pin can be disabled without enabling CRP. For details, see the *LPC86x user manual*.

There are three levels of Code Read Protection:

1. CRP1 disables access to the chip via the SWD and allows partial flash update (excluding flash sector 0) using a limited set of ISP commands. This mode is useful when CRP is required and flash field updates are needed but all sectors cannot be erased.
2. CRP2 disables access to the chip via the SWD and only allows full flash erase and update using a reduced set of the ISP commands.
3. Running an application with level CRP3 selected, fully disables any access to the chip via the SWD pins and ISP. This mode effectively disables ISP override using the ISP entry pin as well. If necessary, the application must provide a flash update mechanism using IAP calls or using a call to reinvoke ISP command to enable flash update via the USART.

CAUTION



If level three Code Read Protection (CRP3) is selected, no future factory testing can be performed on the device.

In addition to the three CRP levels, sampling of the ISP entry pin for valid user code can be disabled. For details, see the *LPC86x user manual*.

8.25.4 APB interface

The APB peripherals are located on one APB bus.

8.25.5 AHBLite

The AHBLite connects the CPU bus of the Arm Cortex-M0+ to the flash memory, the main static RAM, the CRC, the DMA, the ROM, and the APB peripherals.

8.26 Emulation and debugging

Debug functions are integrated into the Arm Cortex-M0+. Serial wire debug functions are supported in addition to a standard JTAG boundary scan. The Arm Cortex-M0+ is configured to support up to four breakpoints and two watch points.

The $\overline{\text{RESET}}$ pin selects between the JTAG boundary scan ($\overline{\text{RESET}} = \text{LOW}$) and the Arm SWD debug ($\overline{\text{RESET}} = \text{HIGH}$). The Arm SWD debug port is disabled while the LPC86x is in reset. The JTAG boundary scan pins are selected by hardware when the part is in boundary scan mode (see [Table 4 “Pin description”](#)).

To perform boundary scan testing, follow these steps:

1. Erase any user code residing in Flash.
2. Power up the part with the $\overline{\text{RESET}}$ pin pulled HIGH externally.
3. Wait for at least 250 μs .
4. Pull the $\overline{\text{RESET}}$ pin LOW externally.
5. Perform boundary scan operations.
6. Once the boundary scan operations are completed, assert the $\overline{\text{TRST}}$ pin to enable the SWD debug mode, and release the $\overline{\text{RESET}}$ pin (pull HIGH).

Remark: The JTAG interface cannot be used for debug purposes.

9. Limiting values

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DD}	supply voltage (core and external rail)		[2]	-0.5	+4.6	V
V_{DDA}	Analog supply voltage	on pin VDDA		-0.5	+4.6	V
V_{ref}	reference voltage	on pin VREFP		-0.5	V_{DD}	V
V_I	input voltage	5 V tolerant I/O pins; $V_{DD} \geq 1.8$ V	[3][4]	-0.5	+5.5	V
		on I2C open-drain pins	[5]	-0.5	+5.5	V
V_{IA}	analog input voltage	on digital pins configured for an analog function	[6][7] [8]	-0.5	+4.6	V
$V_{I(xtal)}$	crystal input voltage		[2]	-0.5	+2.5	V
I_{DD}	supply current	per supply pin (LQFP64)		-	100	mA
		per supply pin (HVQFN48)		-	75	
		per supply pin (HVQFN32)		-	50	
I_{SS}	ground current	per ground pin (LQFP64);		-	100	mA
		per ground pin (HVQFN48)		-	75	
		per ground pin (HVQFN32)		-	100	
I_{latch}	I/O latch-up current	$-(0.5V_{DD}) < V_I < (1.5V_{DD})$; $T_j < 125$ °C		-	100	mA
T_{stg}	storage temperature		[9]	-65	+150	°C
$T_{j(max)}$	maximum junction temperature			-	150	°C
$P_{tot(pack)}$	total power dissipation (per package)	LQFP64, based on package heat transfer, not device power consumption	[11]	-	0.66	W
		LQFP64, based on package heat transfer, not device power consumption	[12]	-	0.48	W
		HVQFN48, based on package heat transfer, not device power consumption	[11]	-	1.12	W
		HVQFN48, based on package heat transfer, not device power consumption	[12]	-	0.46	W
		HVQFN32, based on package heat transfer, not device power consumption	[11]	-	0.98	W
		HVQFN32, based on package heat transfer, not device power consumption	[12]	-	0.34	W
V_{esd}	electrostatic discharge voltage	human body model; all pins		-	2000	V

[1] The following applies to the limiting values:

- a) This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge. Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maximum.
 - b) Parameters are valid over operating temperature range unless otherwise specified. All voltages are with respect to V_{SS} unless otherwise noted.
- [2] Maximum/minimum voltage above the maximum operating voltage (see [Table 14](#)) and below ground that can be applied for a short time (< 10 ms) to a device without leading to irrecoverable failure. Failure includes the loss of reliability and shorter lifetime of the device.
 - [3] Applies to all 5 V tolerant I/O pins except true open-drain pins PIO0_10 and PIO0_11 and except the 3 V tolerant pin PIO0_6.
 - [4] Including the voltage on outputs in 3-state mode.
 - [5] V_{DD} present or not present. Compliant with the I²C-bus standard. 5.5 V can be applied to this pin when V_{DD} is powered down.
 - [6] An ADC input voltage above 3.6 V can be applied for a short time without leading to immediate, unrecoverable failure. Accumulated exposure to elevated voltages at 4.6 V must be less than 10^6 s total over the lifetime of the device. Applying an elevated voltage to the ADC inputs for a long time affects the reliability of the device and reduces its lifetime.
 - [7] If the comparator is configured with the common mode input $V_{IC} = V_{DD}$, the other comparator input can be up to 0.2 V above or below V_{DD} without affecting the hysteresis range of the comparator function.
 - [8] It is recommended to connect an overvoltage protection diode between the analog input pin and the voltage supply pin.
 - [9] Dependent on package type.
 - [10] Human body model: equivalent to discharging a 100 pF capacitor through a 1.5 k Ω series resistor.
 - [11] JEDEC (4.5 in \times 4 in); still air.
 - [12] Single layer (4.5 in \times 3 in); still air.

10. Thermal characteristics

The average chip junction temperature, T_j (°C), can be calculated using the following equation:

$$T_j = T_{amb} + (P_D \times R_{th(j-a)}) \quad (1)$$

- T_{amb} = ambient temperature (°C)
- $R_{th(j-a)}$ = the package junction-to-ambient thermal resistance (°C/W)
- P_D = sum of internal and I/O power dissipation

The internal power dissipation is the product of I_{DD} and V_{DD} . The I/O power dissipation of the I/O pins is often small and many times can be negligible. However, it can be significant in some applications.

Table 11. Thermal resistance

Symbol	Parameter	Board Type	Value	Unit
LQFP64 package				
$R_{\theta JA}$	Junction to Ambient Thermal Resistance ^[1]	JESD51-7, 2s2p	40	°C/W
$R_{\theta JC}$	Junction to Case (Top) Thermal Resistance ^[3]	JESD51-7, 1s	17	°C/W
Ψ_{JT}	Junction-to-Top of Package Thermal Characterization Parameter ^[1]	JESD51-7, 2s2p	0.4	°C/W
HVQFN48 package				
$R_{\theta JA}$	Junction to Ambient Thermal Resistance ^[1]	JESD51-7, 2s2p	27	°C/W
$R_{\theta JC}$	Junction to Case (Bottom) Thermal Resistance ^[4]	JESD51-7, 1s	2.4	°C/W
Ψ_{JT}	Junction-to-Top of Package Thermal Characterization Parameter ^[1]	JESD51-7, 2s2p	0.2	°C/W
HVQFN32 package				
$R_{\theta JA}$	Junction to Ambient Thermal Resistance ^[1]	JESD51-7, 2s2p	31	°C/W
$R_{\theta JC}$	Junction to Case (Bottom) Thermal Resistance ^[4]	JESD51-7, 1s	2.0	°C/W
Ψ_{JT}	Junction-to-Top of Package Thermal Characterization Parameter ^[1]	JESD51-7, 2s2p	0.3	°C/W

- [1] Determined in accordance with JEDEC JESD51-2A natural convection environment. Thermal resistance data in this report is solely for a thermal performance comparison of one package to another in a standardized specified environment. It is not meant to predict the performance of a package in an application-specific environment.
- [2] Thermal test board meets JEDEC specifications for this package (JESD51-7).
- [3] Junction-to-Case thermal resistance determined using an isothermal cold plate. Case temperature refers to the mold surface temperature at the package's top side dead center.
- [4] Junction-to-Case (bottom) thermal resistance determined using an isothermal cold plate. Case temperature refers to the package's bottom surface temperature.

11. Static characteristics

11.1 General operating conditions

Table 12. General operating conditions

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
f_{clk}	clock frequency	internal CPU/system clock		-	-	60	MHz
V_{DD}	supply voltage (core and external rail)		^[3]	1.8	-	3.6	V
		For ADC operations		2.4	-	3.6	V
V_{DDA}	analog supply voltage	For ADC operations		2.4	-	3.6	V
V_{ref}	ADC positive reference voltage	on pin VREFP		2.4	-	V_{DDA}	V
Oscillator pins							
$V_{i(xtal)}$	crystal input voltage	on pin XTALIN		-0.5	1.8	1.95	V
$V_{o(xtal)}$	crystal output voltage	on pin XTALOUT		-0.5	1.8	1.95	V
Pin capacitance							
C_{io}	input/output capacitance	pins with analog and digital functions	^[2]	-	-	7.1	pF
		I ² C-bus pins	^[2]	-	-	2.5	pF
		pins with digital functions only	^[2]	-	-	2.8	pF

- [1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), nominal supply voltages.
- [2] Including bonding pad capacitance. Based on the simulation, not tested in production.
- [3] The V_{DD} supply voltage must be 1.9 V or above when connecting an external crystal oscillator to the system oscillator. If the V_{DD} supply voltage is below 1.9 V, an external clock source can be fed to the XTALIN by bypassing the system oscillator or the other clock sources mentioned above can be used.

11.2 Power-up ramp conditions

Table 13. Power-up characteristics^[1]
T_{amb} = −40 °C to +105 °C.

Symbol	Parameter		Min	Typ	Max	Unit
t _{wd}	Window duration (time where V ₁ <V _{DD} <V ₂)		-	-	8	ms
V ₁	Window low voltage	^[2]	1.4	-	-	V
V ₂	Window high voltage	^[3]	-	-	1.8	V

- [1] Assert the external reset pin until V_{DD} is > 1.8 V if the power-up characteristic specification cannot be implemented.
- [2] V_{DD} to stay above V₁ for the entire duration t_{wd}.
- [3] V_{DD} to stay below V₂ for the minimum duration of t_{wd}.

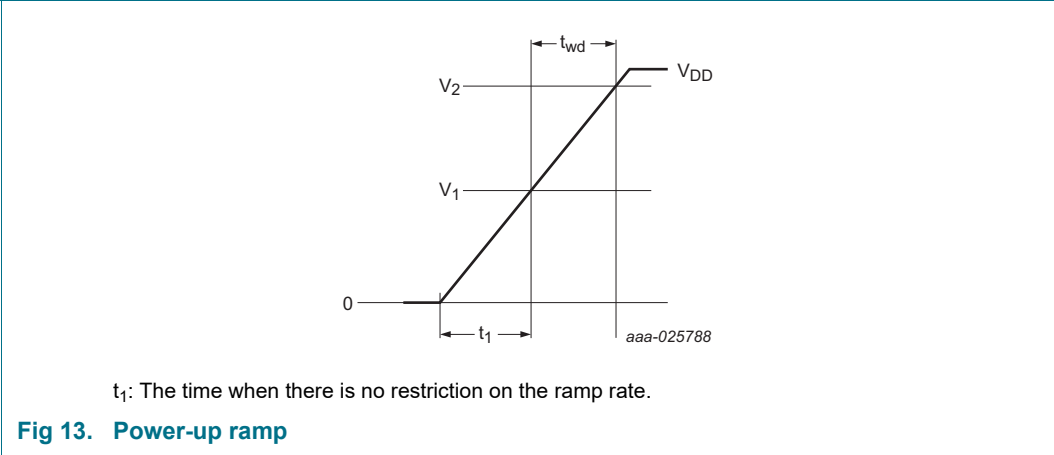


Fig 13. Power-up ramp

11.3 Power consumption

Power measurements in active, sleep, deep-sleep, and power-down modes were performed under the following conditions:

- Configure all pins as GPIO with pull-up resistor disabled in the IOCON block.
- Configure GPIO pins as outputs using the GPIO DIR register.
- Write 1 to the GPIO CLR register to drive the outputs LOW.

Table 14. Static characteristics, supply pins

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ ^{[1][2]}	Max ^[9]	Unit
I_{DD}	supply current	Active mode; code while(1) { } executed from flash;					
		system clock = 1 MHz from LPOSC; $V_{DD} = 3.3\text{ V}$; Low power boot	[3][4][5][6]	-	381	-	μA
			[3][4][5][6]	-	339	-	μA
		system clock = 12 MHz; $V_{DD} = 3.3\text{ V}$; Normal boot			2.1		
		system clock = 12 MHz; $V_{DD} = 1.8\text{ V}$; Normal boot	[3][4][5][6]	-	2.0	-	mA
		system clock = 24 MHz; $V_{DD} = 3.3\text{ V}$; Normal boot	[3][4][5][6]	-	3.6	-	mA
		system clock = 24 MHz; $V_{DD} = 1.8\text{ V}$; Normal boot	[3][4][5][6]	-	3.5	-	mA
		system clock = 48 MHz; $V_{DD} = 3.3\text{ V}$; Normal boot	[3][4][5][6]	-	6.5	-	mA
		system clock = 48 MHz; $V_{DD} = 1.8\text{ V}$; Normal boot	[3][4][5][6]		3.7	-	mA
		system clock = 60 MHz; $V_{DD} = 3.3\text{ V}$; Normal boot	[3][4][5][6]		11.2	-	mA
		system clock = 60 MHz; $V_{DD} = 1.8\text{ V}$; Normal boot	[3][4][5][6]		8.9	-	mA
		Sleep mode	[3][4][5][6]				
		system clock = 12 MHz; $V_{DD} = 3.3\text{ V}$	[3][4][5][6]	-	1.19	-	mA
		system clock = 12 MHz; $V_{DD} = 1.8\text{ V}$	[3][4][5][6]	-	1.13	-	mA
		system clock = 24 MHz; $V_{DD} = 3.3\text{ V}$	[3][4][5][6]	-	1.83	-	mA
		system clock = 24 MHz; $V_{DD} = 1.8\text{ V}$	[3][4][5][6]	-	1.74	-	mA
		system clock = 48 MHz; $V_{DD} = 3.3\text{ V}$	[3][4][5][6]		3.18		mA
		system clock = 48 MHz; $V_{DD} = 1.8\text{ V}$	[3][4][5][6]		3.01		mA
		system clock = 60 MHz; $V_{DD} = 3.3\text{ V}$	[3][4][5][6]		3.96		mA
		system clock = 60 MHz; $V_{DD} = 1.8\text{ V}$	[3][4][5][6]		3.79		mA
I_{DD}	supply current	Deep-sleep mode; $V_{DD} = 3.3\text{ V}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$	[3][7]	-	270	320	μA
		$T_{amb} = 105\text{ }^{\circ}\text{C}$		-	-	440	μA

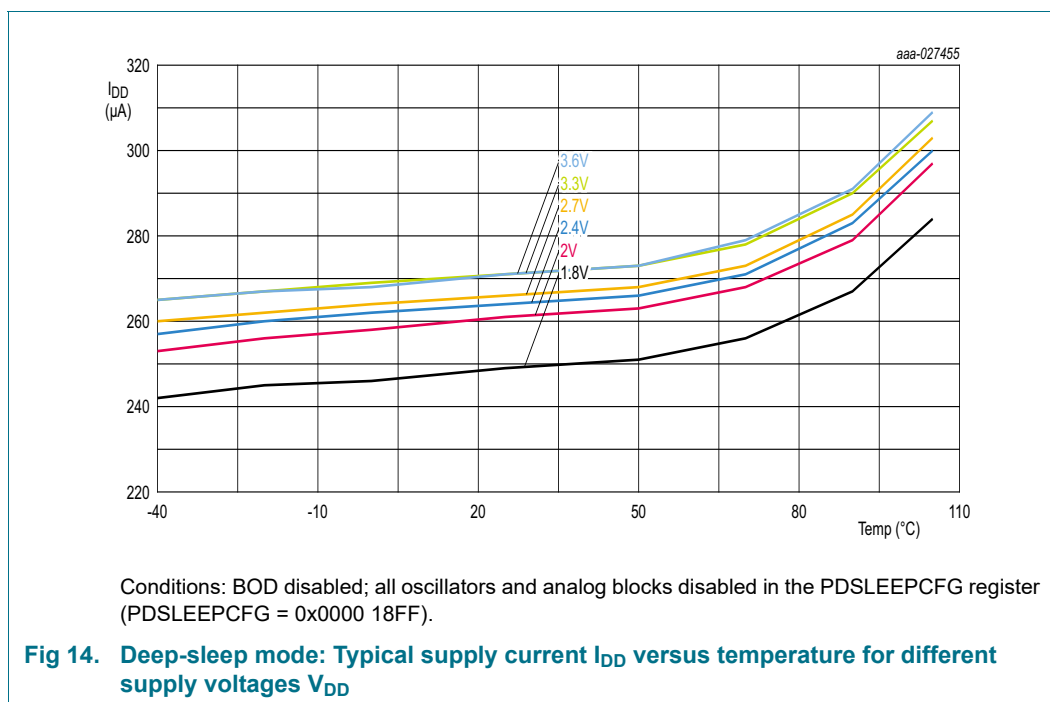
Table 14. Static characteristics, supply pins ...continued*T_{amb} = -40 °C to +105 °C, unless otherwise specified.*

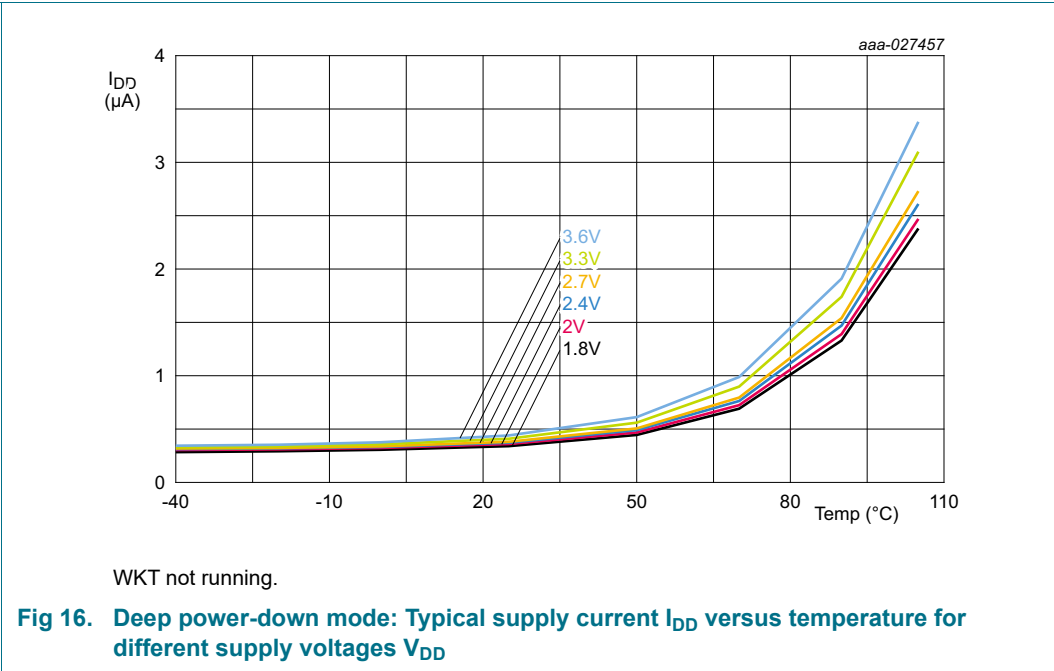
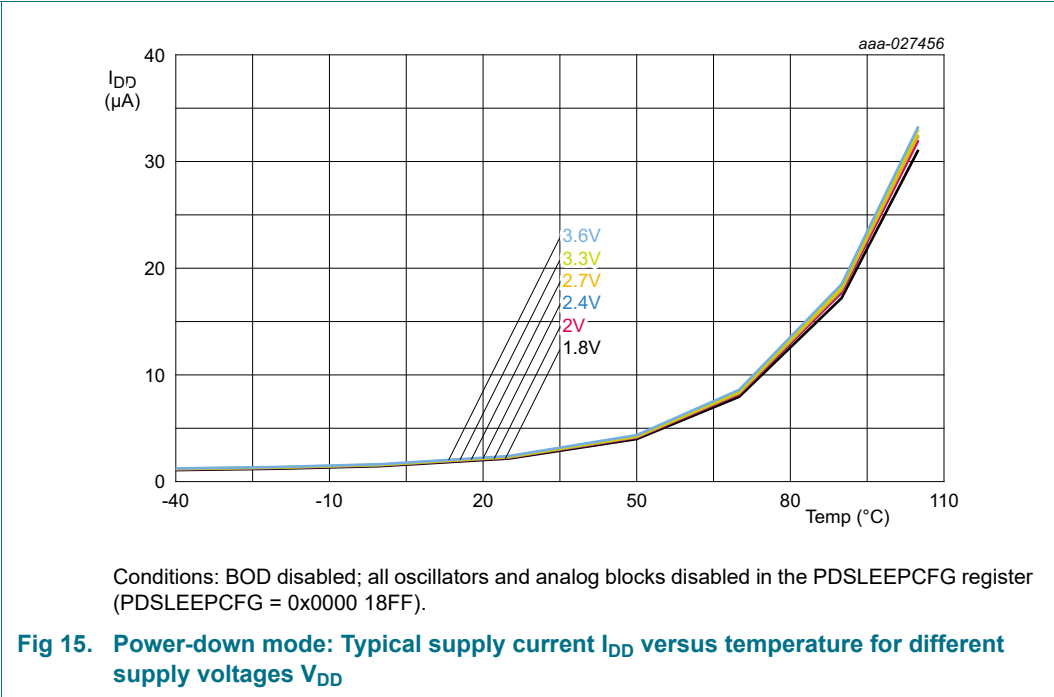
Symbol	Parameter	Conditions		Min	Typ ^{[1][2]}	Max ^[9]	Unit
I _{DD}	supply current	Power-down mode; V _{DD} = 3.3 V T _{amb} = 25 °C	[3][7]	-	1.8	10	μA
		T _{amb} = 105 °C		-	-	70	μA
I _{DD}	supply current	Deep power-down mode; V _{DD} = 3.3 V; 10 kHz low-power oscillator and self-wake-up timer (WKT) disabled T _{amb} = 25 °C	[8]	-	0.35	1	μA
		T _{amb} = 105 °C		-	-	6	μA
I _{DD}	supply current	Deep power-down mode; V _{DD} = 3.3 V; 10 kHz low-power oscillator and self-wake-up timer (WKT) enabled		-	1.2	-	μA
		Deep power-down mode; V _{DD} = 3.3 V; external clock input WKTCLKIN @ 10 kHz with self-wake-up timer enabled		-	0.35	-	μA
		Deep power-down mode; V _{DD} = 3.3 V; external clock input WKTCLKIN @ 32 kHz with self-wake-up timer enabled		-	0.36	-	μA

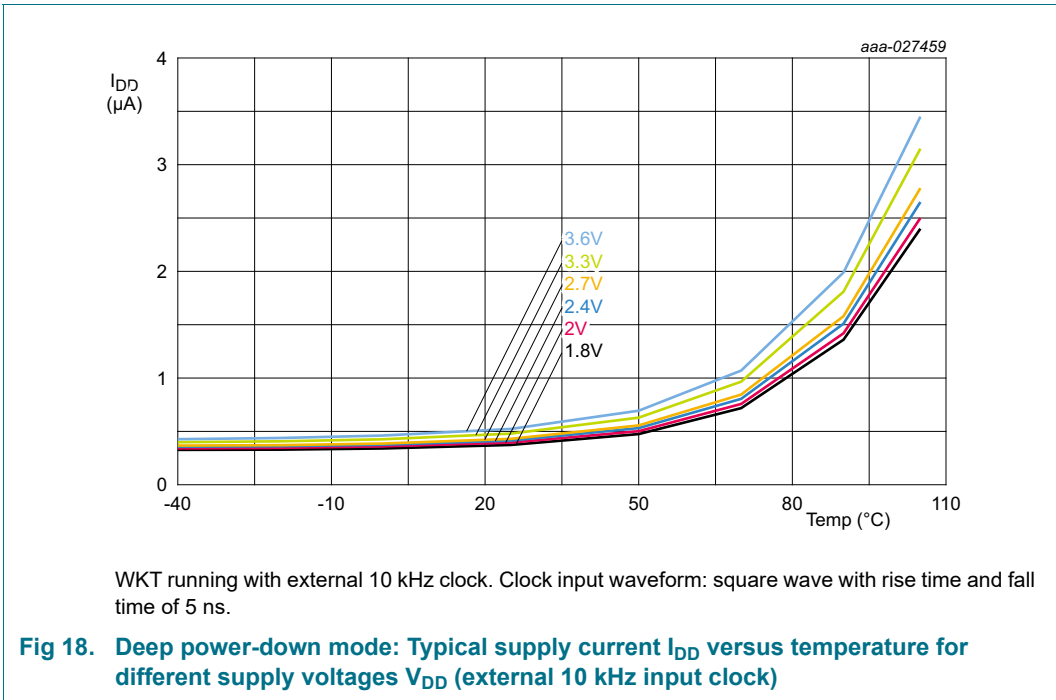
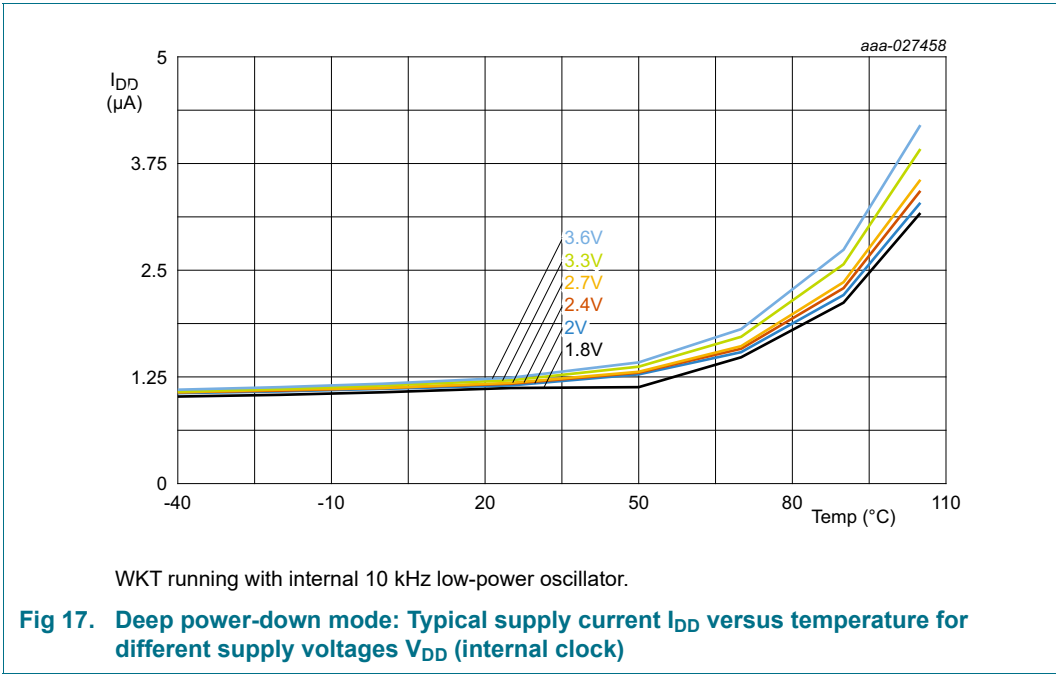
[1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), V_{DD} = 3.3 V.

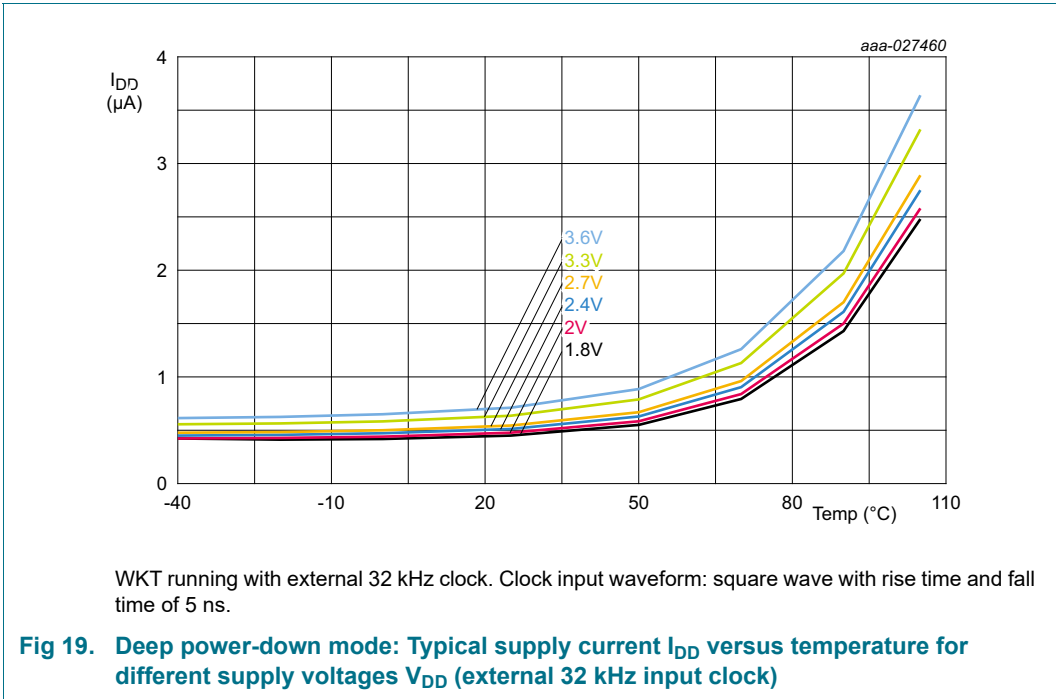
[2] Characterized through bench measurements using typical samples.

- [3] I_{DD} measurements were performed with all pins configured as GPIO outputs driven LOW and pull-up resistors disabled.
- [4] FRO enabled; system oscillator disabled; system PLL disabled.
- [5] BOD disabled.
- [6] All peripherals are disabled in the SYSAHBCLKCTRL register. Peripheral clocks disabled in system configuration block.
- [7] All oscillators and analog blocks are turned off.
- [8] \overline{WAKEUP} pin pulled HIGH externally.
- [9] Tested in production, $V_{DD} = 3.3$ V.









11.4 Peripheral power consumption

The supply current per peripheral is measured as the difference in supply current between the peripheral block enabled and the peripheral block disabled in the SYSAHBCLKCFG and PDRUNCFG (for analog blocks) registers. All other blocks are disabled in both registers and no code accessing the peripheral is executed. Measured on a typical sample at $T_{amb} = 25\text{ }^{\circ}\text{C}$.

The supply currents are shown for FRO clock frequencies of 24 MHz and 48 MHz.

Table 15. Power consumption for individual analog and digital blocks

Peripheral	Typical supply current in μA			Notes
	System clock frequency =			
	n/a	24 MHz	48 MHz	
FRO	97	-	-	System oscillator running; PLL off; independent of main clock frequency; FRO = 24 MHz. FRO output disabled.
System oscillator at 12 MHz	243	-	-	FRO running; PLL off; independent of main clock frequency.
Low power oscillator	1	-	-	FRO; PLL off; independent of main clock frequency.
BOD	37	-	-	
Flash	273	-	-	
Main PLL	222	-	-	FRO (24 MHz) running; Main clock running at fro_div (12 MHz)
CLKOUT	-	102	189	Main clock divided by 4 in the CLKOUTDIV register. Not connected to pin.
ROM	-	71	151	-
GPIO + pin interrupt/pattern match	-	351	661	GPIO pins configured as outputs and set to LOW. Direction and pin state are maintained if the GPIO is disabled in the SYSAHBCLKCFG register.
SWM	-	135	252	-
IOCON	-	174	326	-
FlexTimer0	-	473	906	-
FlexTimer1		338	645	
MRT	-	162	303	-
WWDT	-	54	94	-
I2C0	-	100	183	-
I3C0	-	307	587	
SPI0	-	63	111	-
SPI1	-	68	121	-
USART0	-	87	156	-
USART1	-	87	143	-
USART2	-	93	166	-
Comparator ACMP	-	61	104	-

Table 15. Power consumption for individual analog and digital blocks ...continued

Peripheral	Typical supply current in μA			Notes
	System clock frequency =			
	n/a	24 MHz	48 MHz	
ADC	-	174	313	Digital controller only. Analog portion of the ADC disabled in the PDRUNCFG register.
	-	136	162	Combined analog and digital logic. ADC enabled in the PDRUNCFG register and LPWRMODE bit set to 1 in the ADC CTRL register (ADC in low-power mode).
	-	105	271	Combined analog and digital logic. ADC enabled in the PDRUNCFG register and LPWRMODE bit set to 0 in the ADC CTRL register (ADC powered).
DMA	-	501	963	-
CRC	-	79	137	-

11.5 Pin characteristics

Table 16. Static characteristics, pin characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
Standard port pins configured as digital pins, RESET							
I _{IL}	LOW-level input current	V _I = 0 V; on-chip pull-up resistor disabled		-	0.5	10 ^[2]	nA
I _{IH}	HIGH-level input current	V _I = V _{DD} ; on-chip pull-down resistor disabled		-	0.5	10 ^[2]	nA
I _{OZ}	OFF-state output current	V _O = 0 V; V _O = V _{DD} ; on-chip pull-up/down resistors disabled		-	0.5	10 ^[2]	nA
V _I	input voltage	V _{DD} ≥ 1.8 V; 5 V tolerant pins		0	-	5	V
		V _{DD} = 0 V		0	-	3.6	V
V _O	output voltage	output active		0	-	V _{DD}	V
V _{IH}	HIGH-level input voltage			0.7V _{DD}	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{DD}	V
V _{hys}	hysteresis voltage			-	0.4	-	V
V _{OH}	HIGH-level output voltage	I _{OH} = 4 mA; 2.5 V ≤ V _{DD} ≤ 3.6 V		V _{DD} − 0.4	-	-	V
		I _{OH} = 3 mA; 1.8 V ≤ V _{DD} < 2.5 V		V _{DD} − 0.5	-	-	V
V _{OL}	LOW-level output voltage	I _{OL} = 4 mA; 2.5 V ≤ V _{DD} ≤ 3.6 V		-	-	0.5	V
		I _{OL} = 3 mA; 1.8 V ≤ V _{DD} < 2.5 V		-	-	0.5	V
I _{OH}	HIGH-level output current	V _{OH} = V _{DD} − 0.4 V; 2.5 V ≤ V _{DD} ≤ 3.6 V		4	-	-	mA
		V _{OH} = V _{DD} − 0.5 V; 1.8 V ≤ V _{DD} < 2.5 V		3	-	-	mA
I _{OL}	LOW-level output current	V _{OL} = 0.5 V 2.5 V ≤ V _{DD} ≤ 3.6 V		4	-	-	mA
		1.8 V ≤ V _{DD} < 2.5 V		3	-	-	mA
I _{OHS}	HIGH-level short-circuit output current	V _{OH} = 0 V	^[5]	-	-	45	mA
I _{OLS}	LOW-level short-circuit output current	V _{OL} = V _{DD}	^[5]	-	-	50	mA
I _{pd}	pull-down current	V _I = 5 V	^[6]	10	50	150	μA
I _{pu}	pull-up current	V _I = 0 V; 2.0 V ≤ V _{DD} ≤ 3.6 V	^[6]	15	50	85	μA
		1.8 V ≤ V _{DD} < 2.0 V		10	50	85	
		V _{DD} < V _I < 5 V		0	0	0	μA
High-drive output pin configured as digital pin (PIO0_2, PIO0_3, PIO0_12, and PIO0_16)							
I _{IL}	LOW-level input current	V _I = 0 V; on-chip pull-up resistor disabled		-	0.5	10 ^[2]	nA
I _{IH}	HIGH-level input current	V _I = V _{DD} ; on-chip pull-down resistor disabled		-	0.5	10 ^[2]	nA

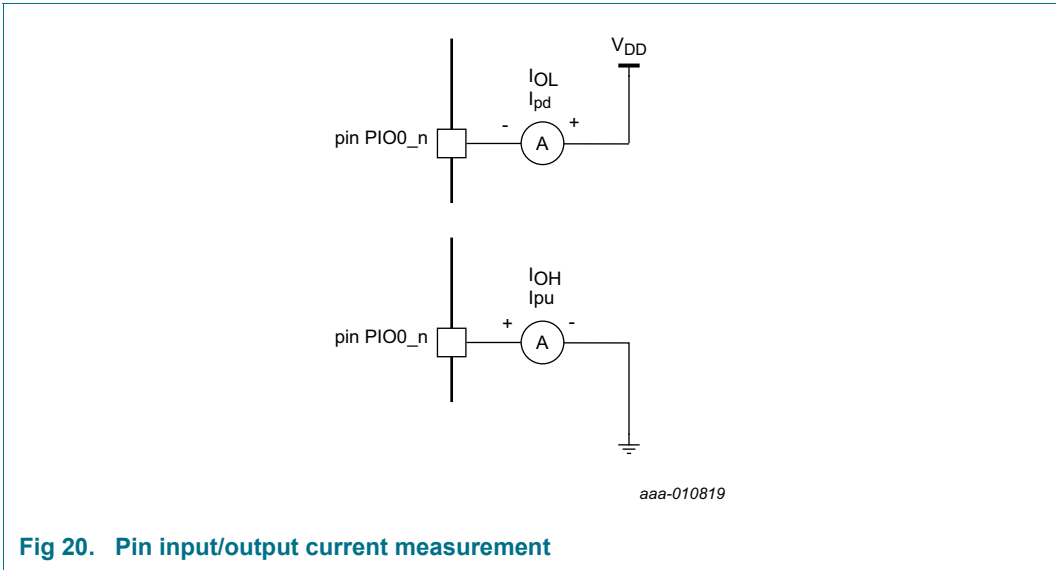
Table 16. Static characteristics, pin characteristics ...continued $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
I _{OZ}	OFF-state output current	V _O = 0 V; V _O = V _{DD} ; on-chip pull-up/down resistors disabled		-	0.5	10 ^[2]	nA
V _I	input voltage	V _{DD} ≥ 1.8 V		0	-	5.0	V
		V _{DD} = 0 V		0	-	3.6	V
V _O	output voltage	output active		0	-	V _{DD}	V
V _{IH}	HIGH-level input voltage			0.7V _{DD}	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{DD}	V
V _{hys}	hysteresis voltage			-	0.4	-	V
V _{OH}	HIGH-level output voltage	I _{OH} = 20 mA; 2.5 V ≤ V _{DD} < 3.6 V		V _{DD} − 0.5	-	-	V
		I _{OH} = 12 mA; 1.8 V ≤ V _{DD} < 2.5 V		V _{DD} − 0.5	-	-	V
V _{OL}	LOW-level output voltage	I _{OL} = 4 mA 2.5 V ≤ V _{DD} < 3.6 V		-	-	0.5	V
		I _{OL} = 3 mA 1.8 V ≤ V _{DD} < 2.5 V		-	-	0.5	V
I _{OH}	HIGH-level output current	V _{OH} = V _{DD} − 0.5 V; 2.5 V ≤ V _{DD} < 3.6 V		20	-	-	mA
		V _{OH} = V _{DD} − 0.5 V; 1.8 V ≤ V _{DD} < 2.5 V		12	-	-	mA
I _{OL}	LOW-level output current	V _{OL} = 0.5 V 2.5 V ≤ V _{DD} ≤ 3.6 V		4	-	-	mA
		1.8 V ≤ V _{DD} < 2.5 V		3	-	-	mA
I _{OLS}	LOW-level short-circuit output current	V _{OL} = V _{DD}	^[5]	-	-	50	mA
I _{pd}	pull-down current	V _I = 5 V	^[6]	10	50	150	μA
I _{pu}	pull-up current	V _I = 0 V	^[6]	−10	−50	−85	μA
		V _{DD} < V _I < 5 V		0	0	0	μA
I ² C-bus pins (PIO0_10 and PIO0_11)							
V _{IH}	HIGH-level input voltage			0.7V _{DD}	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{DD}	V
V _{hys}	hysteresis voltage			-	0.05V _{DD}	-	V
I _{OL}	LOW-level output current	V _{OL} = 0.5 V; I ² C-bus pins configured as standard mode pins 2.5 V ≤ V _{DD} < 3.6 V		3.5	-	-	mA
		1.8 V ≤ V _{DD} < 2.5 V		3	-	-	mA
I _{OL}	LOW-level output current	V _{OL} = 0.5 V; I ² C-bus pins configured as Fast-mode Plus pins; 2.5 V ≤ V _{DD} < 3.6 V		20	-	-	mA
		1.8 V ≤ V _{DD} < 2.5 V		16	-	-	mA

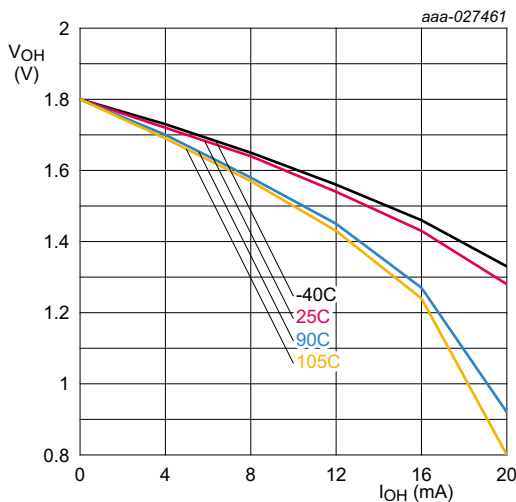
Table 16. Static characteristics, pin characteristics ...continued
T_{amb} = -40 °C to +105 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
I _{LI}	input leakage current	V _I = V _{DD}	^[7]	-	2	4	μA
		V _I = 5 V		-	10	22	μA

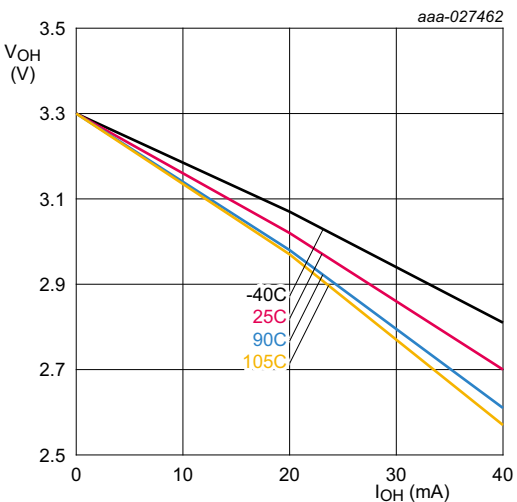
- [1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), nominal supply voltages.
- [2] Based on characterization. Not tested in production.
- [3] Including voltage on outputs in 3-state mode.
- [4] 3-state outputs go into 3-state mode in deep power-down mode.
- [5] Allowed as long as the current limit does not exceed the maximum current allowed by the device.
- [6] Pull-up and pull-down currents are measured across the weak internal pull-up/pull-down resistors. See [Figure 20](#).
- [7] To V_{SS}.



11.5.1 Electrical pin characteristics

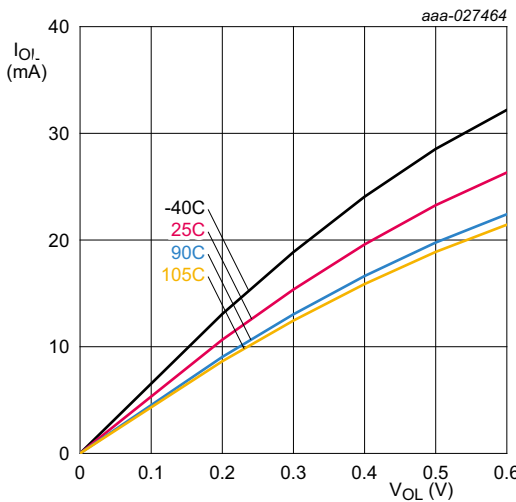


Conditions: $V_{DD} = 1.8$ V; on pin PIO0_12.

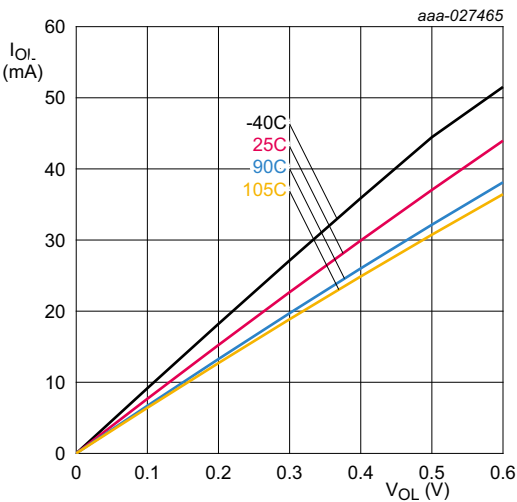


Conditions: $V_{DD} = 3.3$ V; on pin PIO0_12.

Fig 21. High-drive output: Typical HIGH-level output voltage V_{OH} versus HIGH-level output current I_{OH}

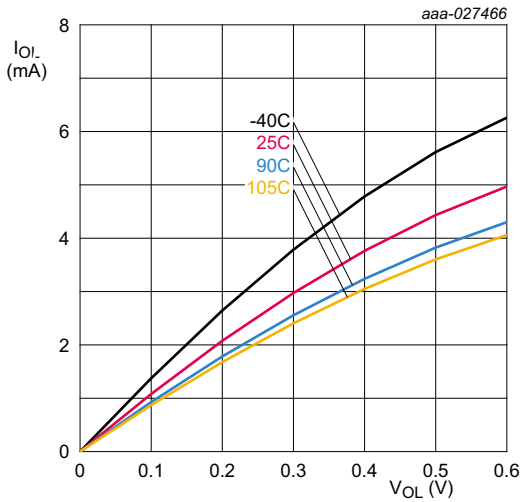


Conditions: $V_{DD} = 1.8$ V; on pins PIO0_10 and PIO0_11.

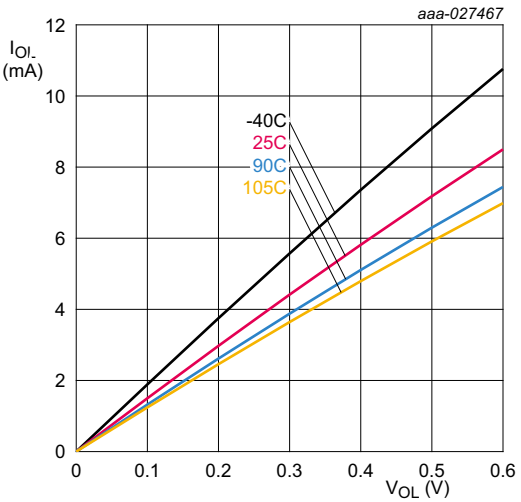


Conditions: $V_{DD} = 3.3$ V; on pins PIO0_10 and PIO0_11.

Fig 22. I²C-bus pins (high current sink): Typical LOW-level output current I_{OL} versus LOW-level output voltage V_{OL}

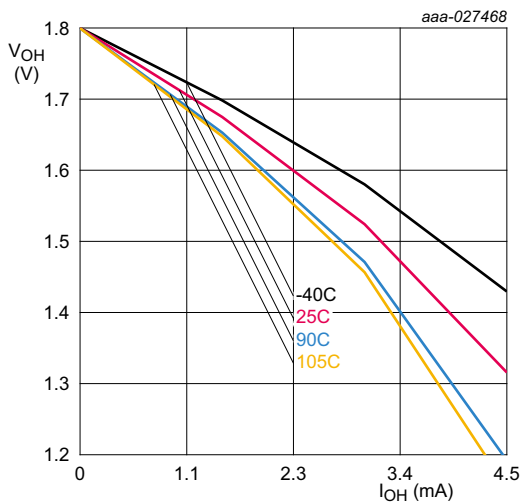


Conditions: $V_{DD} = 1.8$ V; standard port pins and high-drive pin PIO0_12.

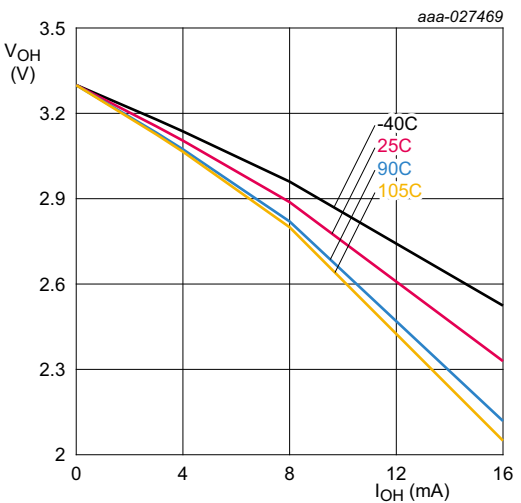


Conditions: $V_{DD} = 3.3$ V; standard port pins and high-drive pin PIO0_12.

Fig 23. Typical LOW-level output current I_{OL} versus LOW-level output voltage V_{OL}

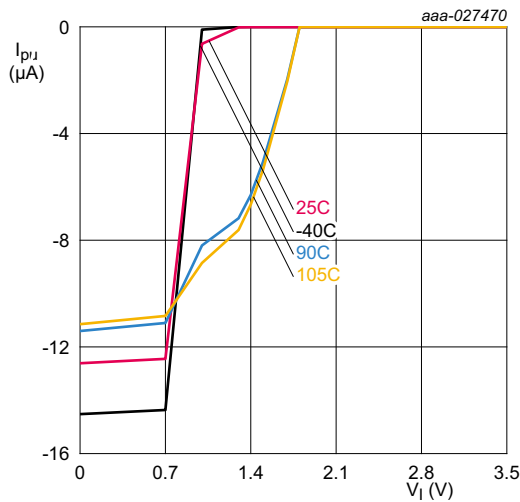


Conditions: $V_{DD} = 1.8$ V; standard port pins.

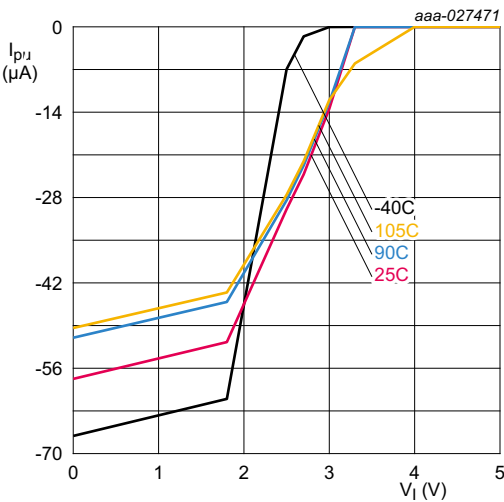


Conditions: $V_{DD} = 3.3$ V; standard port pins.

Fig 24. Typical HIGH-level output voltage V_{OH} versus HIGH-level output source current I_{OH}

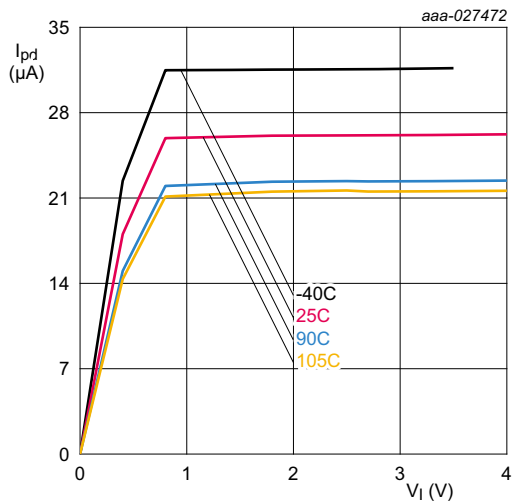


Conditions: $V_{DD} = 1.8 V$; standard port pins.

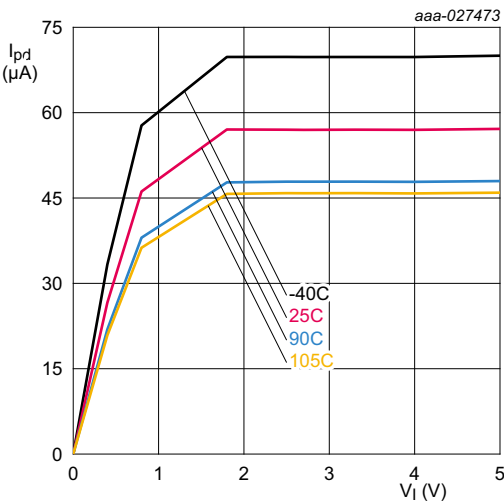


Conditions: $V_{DD} = 3.3 V$; standard port pins.

Fig 25. Typical pull-up current I_{pu} versus input voltage V_i



Conditions: $V_{DD} = 1.8 V$; standard port pins.



Conditions: $V_{DD} = 3.3 V$; standard port pins.

Fig 26. Typical pull-down current I_{pd} versus input voltage V_i

12. Dynamic characteristics

12.1 Flash memory

Table 17. Flash characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$. Based on JEDEC NVM qualification. Failure rate < 10 ppm for parts as specified below.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
N_{endu}	endurance		[1]	10 000	100 000	-	cycles
t_{ret}	retention time	powered		10	20	-	years
		not powered		20	40	-	years
t_{er}	erase time	page or multiple consecutive pages, sector or multiple consecutive sectors		95	100	105	ms
t_{prog}	programming time		[2]	0.95	1	1.05	ms

[1] Number of program/erase cycles.

[2] Programming times are given for writing 64 bytes to the flash. $T_{amb} \leq +85\text{ }^{\circ}\text{C}$. Flash programming with IAP calls (see *LPC86x user manual*).

12.2 FRO

Table 18. Dynamic characteristic: FRO

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; $1.8\text{ V} \leq V_{DD} \leq 3.6\text{ V}$.

Symbol	Min	Typ ^[1]	Max	Unit
FRO clock frequency; Condition: $0\text{ }^{\circ}\text{C} \leq T_{amb} \leq 70\text{ }^{\circ}\text{C}$				
$f_{osc(RC)}$	36 -1 %	36	36 +1 %	MHz
$f_{osc(RC)}$	48 -1 %	48	48 +1 %	MHz
$f_{osc(RC)}$	60 -1 %	60	60 +1 %	MHz
FRO clock frequency; Condition: $-20\text{ }^{\circ}\text{C} \leq T_{amb} \leq 70\text{ }^{\circ}\text{C}$				
$f_{osc(RC)}$	36 -2 %	36	36 +1 %	MHz
$f_{osc(RC)}$	48 -2 %	48	48 +1 %	MHz
$f_{osc(RC)}$	60 -2 %	60	60 +1 %	MHz
FRO clock frequency; Condition: $-40\text{ }^{\circ}\text{C} \leq T_{amb} \leq 105\text{ }^{\circ}\text{C}$				
$f_{osc(RC)}$	36 -4 %	36	36 +3.5 %	MHz
$f_{osc(RC)}$	48 -4 %	48	48 +3.5 %	MHz
$f_{osc(RC)}$	60 -4 %	60	60 +3.5 %	MHz

[1] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

Table 19. Dynamic characteristics: low-power oscillator (LPOSC)

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
$f_{osc(int)}$	internal oscillator frequency	-	[2][3]	0.97	1	1.03	MHz

- [1] Typical ratings are not guaranteed. The values listed are at nominal supply voltages.
- [2] The typical frequency spread over processing and temperature ($T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$) is $\pm 40\%$.
- [3] See the LPC86x *user manual*.

12.3 I/O pins

Table 20. Dynamic characteristics: I/O pins^[1]

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; $3.0\text{ V} \leq V_{DD} \leq 3.6\text{ V}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_r	rise time	pin configured as output	3.0	-	5.0	ns
t_f	fall time	pin configured as output	2.5	-	5.0	ns

[1] Applies to standard port pins and $\overline{\text{RESET}}$ pin.

12.4 WKTCLKIN pin (wake-up clock input)

Table 21. Dynamic characteristics: WKTCLKIN pin

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; $1.8\text{ V} \leq V_{DD} \leq 3.6\text{ V}$.

Symbol	Parameter	Conditions		Min	Max	Unit
f _{clk}	clock frequency	deep power-down mode and power-down mode	[1]	-	1	MHz
		deep-sleep, sleep, and active mode	[1]	-	10	MHz
t _{CHCX}	clock HIGH time	-		50	-	ns
t _{CLCX}	clock LOW time	-		50	-	ns

[1] Assuming a square-wave input clock.

12.5 I²C-bus

Table 22. Dynamic characteristic: I²C-bus pins^[1]

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; values guaranteed by design.^[2]

Symbol	Parameter	Conditions	Min	Max	Unit
f_{SCL}	SCL clock frequency	Standard-mode	0	100	kHz
		Fast-mode	0	400	kHz
		Fast-mode Plus; on pins PIO0_10 and PIO0_11	0	1	MHz
t_f	fall time	[4][5][6][7] of both SDA and SCL signals	-	300	ns
		Standard-mode	-	300	ns
		Fast-mode	20 (VDD/5.5 V)	300	ns
t_{LOW}	LOW period of the SCL clock	Fast-mode Plus; on pins PIO0_10 and PIO0_11	-	120	ns
		Standard-mode	4.7	-	μs
		Fast-mode	1.3	-	μs
		Fast-mode Plus; on pins PIO0_10 and PIO0_11	0.5	-	μs

Table 22. Dynamic characteristic: I²C-bus pins^[1] $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; values guaranteed by design.^[2]

Symbol	Parameter		Conditions	Min	Max	Unit
t_{HIGH}	HIGH period of the SCL clock		Standard-mode	4.0	-	μs
			Fast-mode	0.6	-	μs
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	0.26	-	μs
$t_{HD;DAT}$	data hold time	[3] [4] [8]	Standard-mode	0	-	μs
			Fast-mode	0	-	μs
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	0	-	μs
$t_{SU;DAT}$	data set-up time	[9] [10]	Standard-mode	250	-	ns
			Fast-mode	100	-	ns
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	50	-	ns

[1] See the I²C-bus specification *UM10204* for details.

[2] Parameters are valid over operating temperature range unless otherwise specified.

[3] $t_{HD;DAT}$ is the data hold time that is measured from the falling edge of SCL; applies to data in transmission and the acknowledge.

[4] A device must internally provide a hold time of at least 300 ns for the SDA signal (with respect to the $V_{IH(min)}$ of the SCL signal) to bridge the undefined region of the falling edge of SCL.

[5] C_b = total capacitance of one bus line in pF.

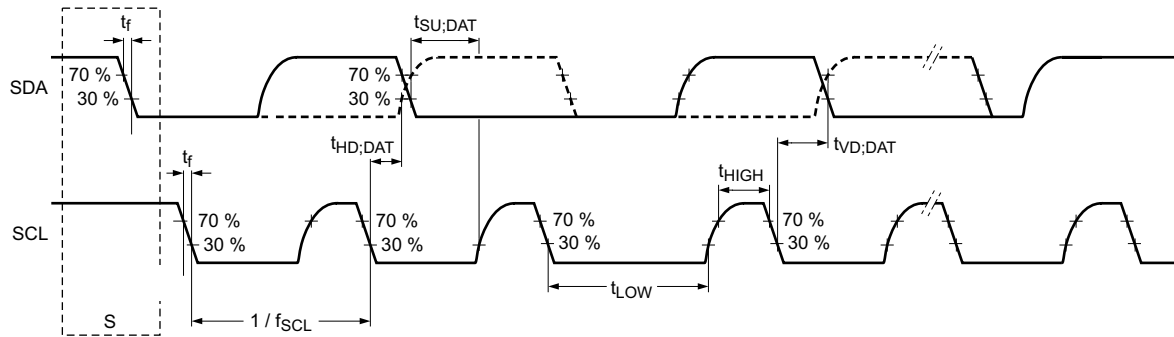
[6] The maximum t_f for the SDA and SCL bus lines is specified at 300 ns. The maximum fall time for the SDA output stage t_f is specified at 250 ns. This allows series protection resistors to be connected in between the SDA and the SCL pins and the SDA/SCL bus lines without exceeding the maximum specified t_f .

[7] In Fast-mode Plus, fall time is specified the same for both output stage and bus timing. If series resistors are used, designers should allow for this when considering bus timing.

[8] The maximum $t_{HD;DAT}$ could be 3.45 μs and 0.9 μs for Standard-mode and Fast-mode but must be less than the maximum of $t_{VD;DAT}$ or $t_{VD;ACK}$ by a transition time (see *UM10204*). This maximum must only be met if the device does not stretch the LOW period (t_{LOW}) of the SCL signal. If the clock stretches the SCL, the data must be valid by the set-up time before it releases the clock.

[9] $t_{SU;DAT}$ is the data set-up time that is measured with respect to the rising edge of SCL; applies to data in transmission and the acknowledge.

[10] A Fast-mode I²C-bus device can be used in a Standard-mode I²C-bus system but the requirement $t_{SU;DAT} = 250\text{ ns}$ must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line $t_{r(max)} + t_{SU;DAT} = 1000 + 250 = 1250\text{ ns}$ (according to the Standard-mode I²C-bus specification) before the SCL line is released. Also, the acknowledge timing must meet this set-up time.



aaa-004643

Fig 27. I²C-bus pins clock timing

12.6 MIPI-I3C

Unless otherwise specified, MIPI-I3C specifications are timed to/from the V_{IH} and/or V_{IL} signal points.

Table 23. MIPI-I3C specifications when communicating with legacy I2C devices^[1]

Symbol	Parameter	400 kHz/Fast mode		1 MHz/Fast+ mode		Unit
		Min	Max	Min	Max	
f_{SCL}	SCL clock frequency	0	0.4	0	1	MHz
t_{SU_STA}	Set-up time for repeated START condition	600	-	260	-	ns
Hold time (repeated)	t_{HD_STA}	600	-	260	-	ns
START condition						
t_{LOW}	LOW period of the SCL clock	1300	-	500	-	ns
t_{HIGH}	HIGH period of the SCL clock	600	-	260	-	ns
t_{SU_DAT}	Data set-up time	100	-	50	-	ns
t_{HD_DAT}	Data hold time for I2C-bus devices	-	-	-	-	ns
t_F	Fall time of SDA and SCL signals	$20 \cdot (V_{dd}/5.5v)$	300	$20 \cdot (V_{dd}/5.5v)$	120	ns
t_R	Rise time of SDA and SCL signals	20	300	-	120	ns
t_{SU_STO}	Set-up time for STOP condition	600	-	260	-	ns
t_{BUF}	Bus free time between STOP and START condition	1.3	-	0.5	-	μs
t_{SP}	Pulse width of spikes that must be suppressed by the input filter	0	50	0	50	μs

Table 24. MIPI-I3C open drain mode specifications^[1]

Symbol	Parameter	Min	Max	Unit	Notes
t _{LOW_OD}	LOW period of the SCL clock	200	-	ns	
t _{HIGH}	HIGH period of the SCL clock	-	41	ns	
t _{rDA_OD}	Fall time of SDA signal	-	12	ns	2
t _{SU_OD}	Data set-up time during open drain mode	3	-	ns	
t _{CAS}	Clock after START (S) condition ENTAS0 ENTAS1 ENTAS2 ENTAS3	38.4 nano	1 100 2 50	μs μs ms ms	
t _{CBP}	Clock before STOP (P) condition	t _{CAS} (min)/2	-	ns	
t _{MMOverlap}	Current master to secondary master overlap time during handoff	t _{DIG_OD_L}	-	ns	
t _{AVAIL}	Bus available condition	1	-	μs	
t _{IDLE}	Bus idle condition	200	-	ms	
t _{MMLock}	Time interval where new master not driving SDA low	t _{AVAIL}	-	μs	

[1] C_b - total capacitance of the bus line in pF.

[2] See t_{LOW_OD}, t_{rDA_OD}, t_{CF}, f_{SCL}.

Table 25. MIPI-I3C push-pull specifications for SDR and HDR-DDR modes^[1]

Symbol	Parameter	Min	Typ.	Max	Unit	Notes
t _{SCL}	SCL clock frequency	0.01	12.5	13	MHz	
t _{LOW}	LOW period of the SCL clock	24	-	-	ns	
t _{DIG_L}		32	-	-	ns	
t _{HIGH_MIXED}	HIGH period of the SCL clock for a mixed bus	24	-	-	ns	
t _{DIG_HIGH_MIXED}		32	-	45	ns	2
t _{HIGH}	HIGH period of the SCL clock	24	-	-	ns	
t _{DIG_H}		32	-	-	ns	
t _{SCO}	Clock in to data out for a target	-	-	12		
t _{CR}	SCL clock rise time	-	-	150e06 * 1 / f _{SCL} (capped at 60)	ns	
t _{CF}	SCL clock fall time	-	-	150e06 * 1 / f _{SCL} (capped at 60)	ns	
t _{HD_PP}	SDA signal data hold					
	Controller mode	t _{CR} + 3 and t _{CF} + 3	-	-	ns	
	Target mode	0	-	-	ns	

Table 25. MIPI-I3C push-pull specifications for SDR and HDR-DDR modes^[1]

Symbol	Parameter	Min	Typ.	Max	Unit	Notes
t _{SU_PP}	SDA signal setup	3	-	-	ns	
t _{CASr}	Clock after repeated START (Sr)	t _{CAS} (min)/2	-	-	ns	
t _{CBSr}	Clock before repeated START (Sr)	t _{CAS} (min)/2	-	-	ns	
C _b	Capacitive load per bus line	-	-	50	pF	

[1] Based on simulation, not tested in production.

[2] When communication with an I3C Device on a mixed Bus, the tDIG_H period must be constrained in order to make sure that I2C devices do not interpret I3C signaling as valid I²C signaling.

12.7 SPI interfaces

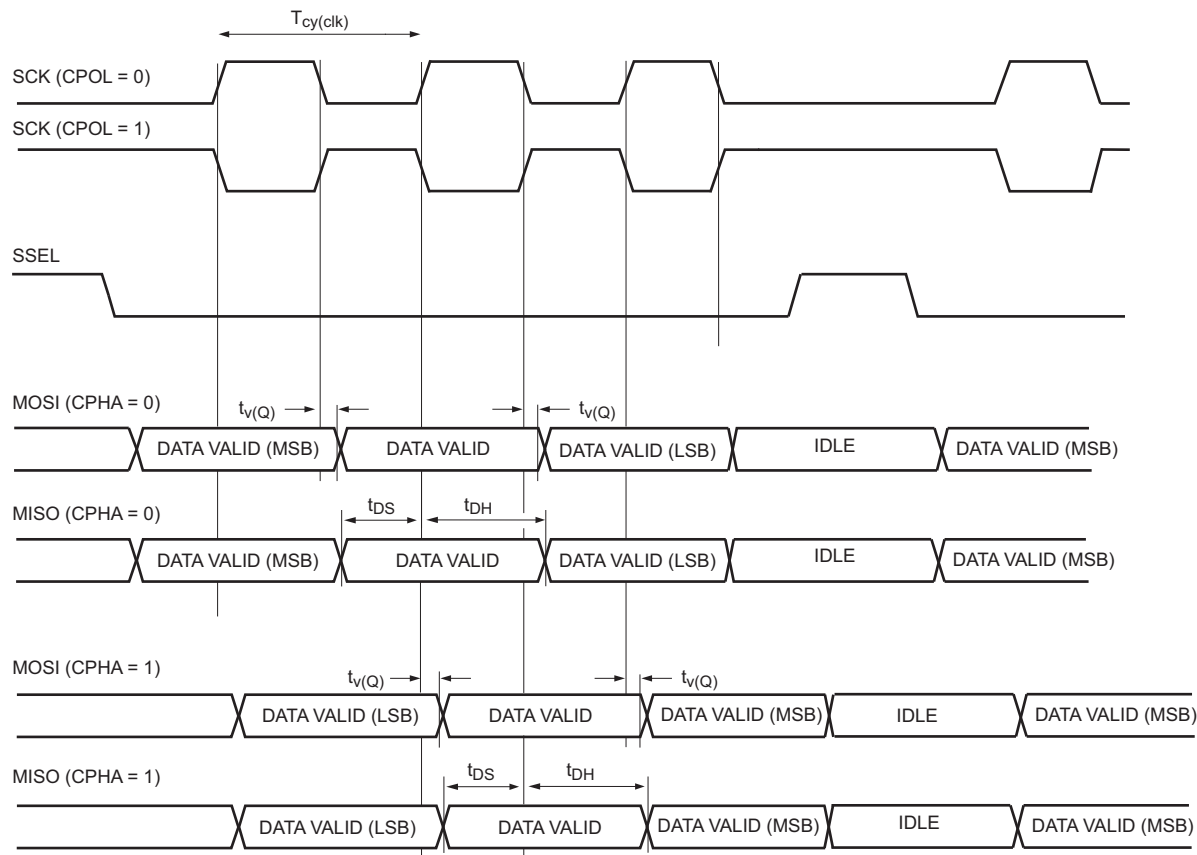
The actual SPI bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading. Excluding delays introduced by an external device and PCB, the maximum supported bit rate for SPI master mode is 30 Mbit/s, and the maximum supported bit rate for SPI target mode is $1/(2 \times 26 \text{ ns}) = 19 \text{ Mbit/s}$ at $3.0\text{V} \leq V_{DD} \leq 3.6\text{V}$ and $1/(2 \times 42 \text{ ns}) = 12 \text{ Mbit/s}$ at $1.8\text{V} \leq V_{DD} < 3.0\text{V}$.

Remark: SPI functions can be assigned to all digital pins. The characteristics are valid for all digital pins except the open-drain pins PIO0_10 and PIO0_11.

Table 26. SPI dynamic characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $105\text{ }^{\circ}\text{C}$; $C_L = 20 \text{ pF}$; input slew = 1 ns . Simulated parameters sampled at the 30 % and 70 % level of the rising or falling edge; values guaranteed by design. Delays introduced by the external trace or external device are not considered.

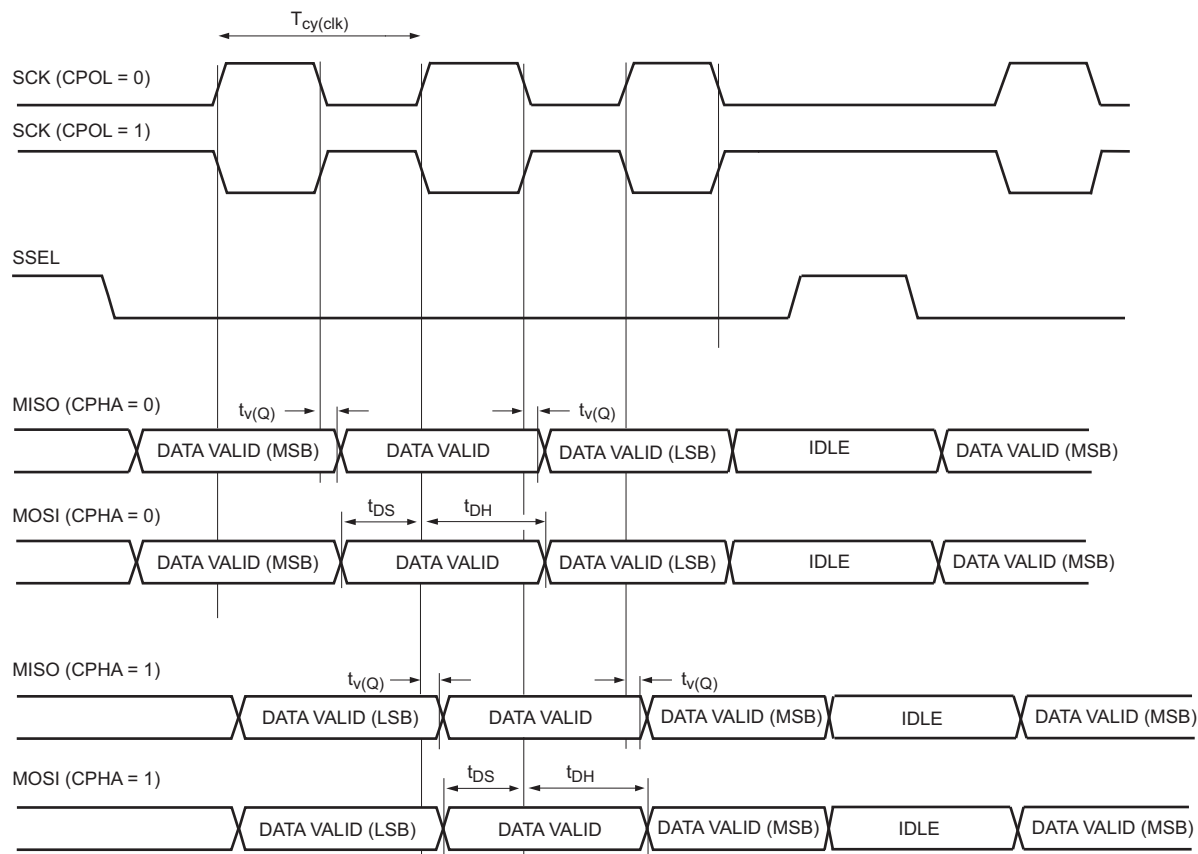
Symbol	Parameter	Conditions	Min	Max	Unit
SPI controller					
t_{DS}	data set-up time	$1.8 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	3	-	ns
t_{DH}	data hold time	$1.8 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	0	-	ns
$t_{V(Q)}$	data output valid time	$1.8 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	0	5	ns
SPI target					
t_{DS}	data set-up time	$1.8 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	4	-	ns
t_{DH}	data hold time	$1.8 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	1	-	ns
$t_{V(Q)}$	data output valid time	$3.0 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	0	26	ns
		$1.8 \text{ V} \leq V_{DD} < 3.0 \text{ V}$	0	42	ns



aaa-014969

$T_{cy(clk)} = CCLK/DIVVAL$ with CCLK = system clock frequency. DIVVAL is the SPI clock divider. See the LPC86x *User manual*.

Fig 28. SPI controller timing



aaa-014970

Fig 29. SPI target timing

12.8 USART interface (in synchronous mode)

The actual USART bit rate depends on the delays introduced by the external trace, the external device, the system clock (CCLK), and capacitive loading. Excluding delays introduced by external device and PCB, the maximum supported bit rate for USART asynchronous mode is 1.875 Mbit/s, the maximum supported bit rate for USART controller synchronous mode is 10 Mbit/s, and the maximum supported bit rate for USART target synchronous mode is 10 Mbit/s.

Remark: USART functions can be assigned to all digital pins. The characteristics are valid for all digital pins except the open-drain pins PIO0_10 and PIO0_11.

Table 27. USART synchronous mode dynamic characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $105\text{ }^{\circ}\text{C}$; $1.8\text{ V} \leq V_{DD} \leq 3.6\text{ V}$ unless noted otherwise; $C_L = 10\text{ pF}$; input slew = 10 ns . Simulated parameters sampled at the 30 %/70 % level of the falling or rising edge; values guaranteed by design.

Symbol	Parameter	Conditions	Min	Max	Unit
USART controller (in synchronous mode)					
$t_{su(D)}$	data input set-up time	$3.0\text{ V} \leq V_{DD} \leq 3.6\text{ V}$	31	-	ns
		$1.8\text{ V} \leq V_{DD} < 3.0\text{ V}$	42	-	
$t_{h(D)}$	data input hold time		0	-	ns
$t_{v(Q)}$	data output valid time		0	7	ns
USART target (in synchronous mode)					
$t_{su(D)}$	data input set-up time		5	-	ns
$t_{h(D)}$	data input hold time		5	-	ns
$t_{v(Q)}$	data output valid time	$3.0\text{ V} \leq V_{DD} \leq 3.6\text{ V}$	0	35	ns
		$1.8\text{ V} \leq V_{DD} < 3.0\text{ V}$	0	46	ns

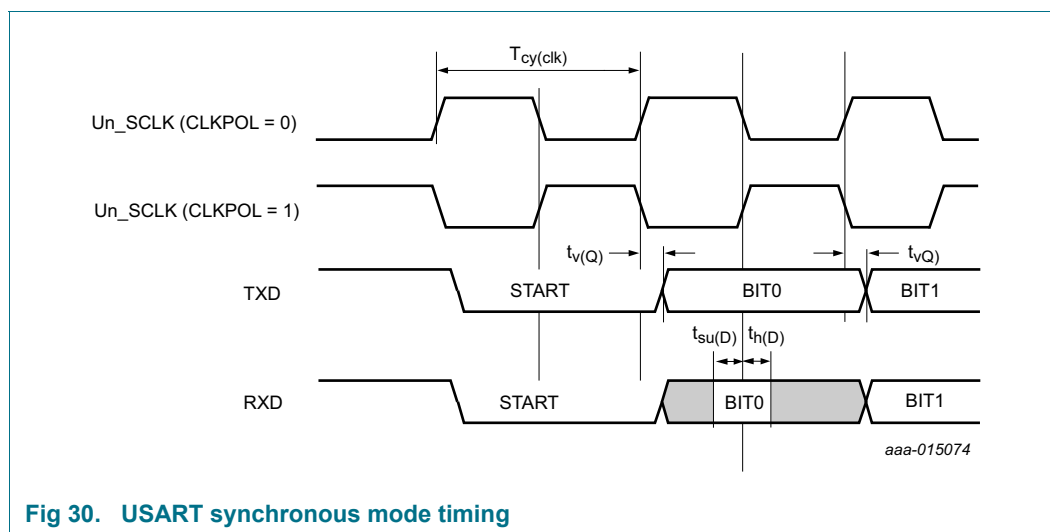


Fig 30. USART synchronous mode timing

12.9 Wake-up process

Table 28. Dynamic characteristic: Typical wake-up times from low power modes

$V_{DD} = 3.3\text{ V}$; $T_{amb} = 25\text{ °C}$; using FRO (24 MHz) as the system clock.

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
t_{wake}	wake-up time	from sleep mode	[2][3]	-	1.3	-	μs
		from deep-sleep mode	[2]	-	1.35	-	μs
		from power-down mode	[2]	-	55	-	μs
		from deep power-down mode; WKT disabled; using $\overline{\text{RESET}}$ pin.	[4]	-	250	-	μs

- [1] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.
- [2] The wake-up time measured is the time between when a GPIO input pin is triggered to wake the device up from the low power modes and from when a GPIO output pin is set in the interrupt service routine (ISR) wake-up handler. ISR is located in SRAM.
- [3] FRO enabled, all peripherals off. PLL disabled.
- [4] WKT disabled. Wake up from deep power-down causes the part to go through entire reset process. The wake-up time measured is the time between when the $\overline{\text{RESET}}$ pin is triggered to wake the device up and when a GPIO output pin is set in the reset handler.

13. Characteristics of analog peripherals

13.1 BOD

Table 29. BOD static characteristics^[1]

$T_{amb} = 25\text{ }^{\circ}\text{C}$.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
V_{th}	threshold voltage	interrupt level 0					
		assertion		-	2.05	-	V
		de-assertion		-	2.19	-	V
		interrupt level 1					
		assertion		-	2.27	-	V
		de-assertion		-	2.42	-	V
		interrupt level 2					
		assertion		-	2.57	-	V
		de-assertion		-	2.7	-	V
		interrupt level 3					
		assertion		-	2.86	-	V
		de-assertion		-	2.97	-	V
		reset level 0					
		assertion		-	1.54	-	V
		de-assertion		-	1.62	-	V
		reset level 1					
		assertion		-	1.81	-	V
		de-assertion		-	1.89	-	V
		reset level 2					
		assertion		-	2.37	-	V
		de-assertion		-	2.5	-	V
		reset level 3					
		assertion		-	2.66	-	V
		de-assertion		-	2.8	-	V

[1] Interrupt levels are selected by writing the level value to the BOD control register BODCTRL, see *the LPC86x user manual*. Interrupt level 0 is reserved.

13.2 ADC

Table 30. 12-bit ADC static characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$ unless noted otherwise; $V_{DD} = V_{DDA} = 2.4\text{ V}$ to 3.6 V ; $V_{REFP} = V_{DD} = V_{DDA}$; $V_{REFN} = V_{SS}$; ADC clock source from FRO 48 MHz(ADCCLKSEL set as 0x0), ADC clock is 48 MHz(ADCCLKDIV set as 0x01, divide by 1).

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
V_{IA}	analog input voltage			0	-	V_{DDA}	V
V_{ref}	reference voltage	on pin VREFP		2.4	-	V_{DDA}	V
C_{ia}	analog input capacitance			-	-	26	pF
$f_{clk(ADC)}$	ADC clock frequency		[2][11]	-	-	48	MHz
f_s	sampling frequency		[2]	-	-	1.9	Msamples/s
E_D	differential linearity error		[5][4]	-	± 3.0	-	LSB
$E_{L(adj)}$	integral non-linearity		[6][4]	-	± 2.5	-	LSB
E_O	offset error		[7][4]	-	± 2.5	-	LSB
$V_{err(fs)}$	full-scale error voltage		[8][4]	-	0.1	-	%
Z_i	input impedance	$f_s = 1.9\text{ Msamples/s}$	[1][9][10]	0.06	-	-	M Ω

- [1] The input resistance of ADC channel 0 is higher than for all other channels. See [Figure 31](#).
- [2] In the ADC TRM register, set VRANGE = 0 (default).
- [3] In the ADC TRM register, set VRANGE = 1.
- [4] Based on characterization. Not tested in production.
- [5] The differential linearity error (E_D) is the difference between the actual step width and the ideal step width. See [Figure 32](#).
- [6] The integral non-linearity ($E_{L(adj)}$) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See [Figure 32](#).
- [7] The offset error (E_O) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See [Figure 32](#).
- [8] The full-scale error voltage or gain error (E_G) is the difference between the straight line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See [Figure 32](#).
- [9] $T_{amb} = 25\text{ }^{\circ}\text{C}$; maximum sampling frequency $f_s = 1.9\text{ Msamples/s}$ and analog input capacitance $C_{ia} = 26\text{ pF}$.
- [10] Input impedance Z_i (See [Section 13.2.1 "ADC input impedance"](#)) is inversely proportional to the sampling frequency and the total input capacity including C_{ia} and C_{io} : $Z_i \propto 1 / (f_s \times C_i)$. See [Table 12](#) for C_{io} .
- [11] Set FRO output 48 MHz, in ADCCLKSEL register, set SEL as 0x0(default), in ADCCLKDIV register, set DIV as 0x01.
- [12] ADC should calibrated at 30 MHz core frequency, then raise core frequency to the maximum frequency after ADC calibration is successful.

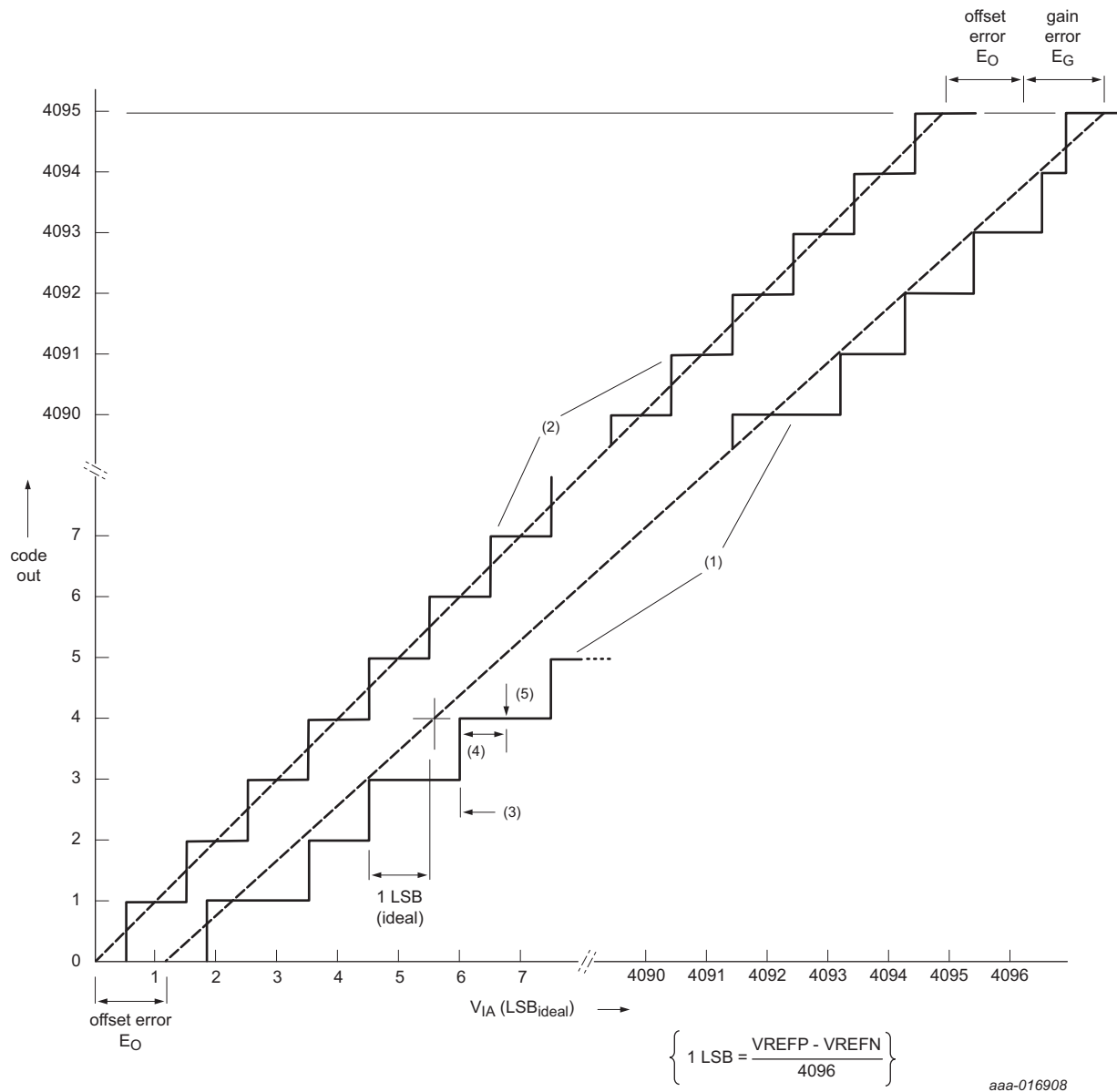


Fig 31. 12-bit ADC characteristics

13.2.1 ADC input impedance

[Figure 32](#) shows the ADC input impedance. In this figure:

- ADCx represents ADC input channel 0.
- ADCy represents ADC input channels 1 to 11.
- R_1 and R_{sw} are the switch-on resistance on the ADC input channel.
- If ADC input channel 0 is selected, the ADC input signal goes through $R_1 + R_{sw}$ to the sampling capacitor (C_{ia}).
- If ADC input channels 1 to 11 are selected, the ADC input signal goes through R_{sw} to the sampling capacitor (C_{ia}).
- Typical values, $R_1 = 2.5 \text{ k}\Omega$, $R_{sw} = 25 \text{ }\Omega$
- See [Table 12](#) for C_{io} .
- See [Table 30](#) for C_{ia} .

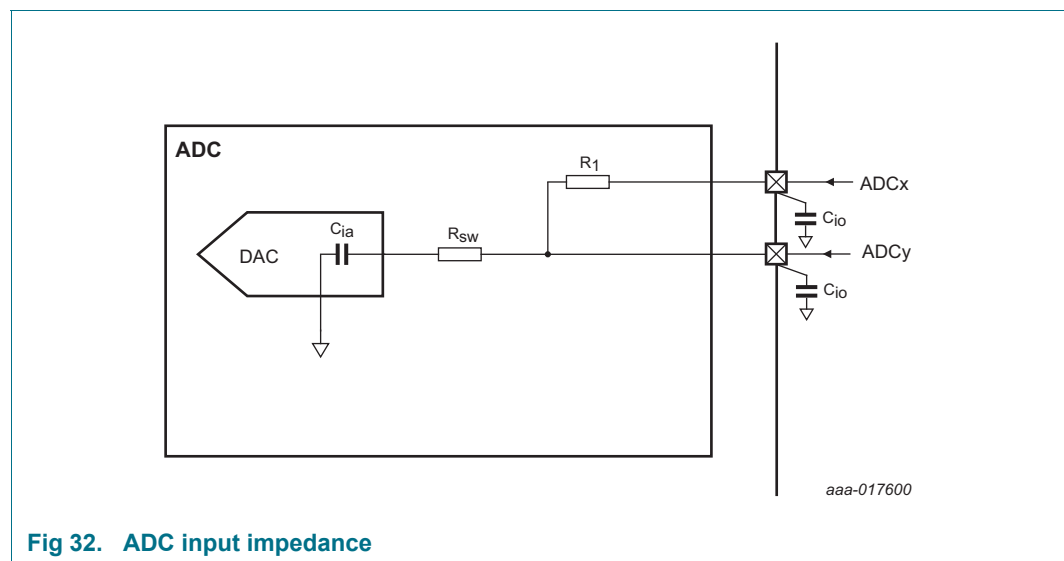


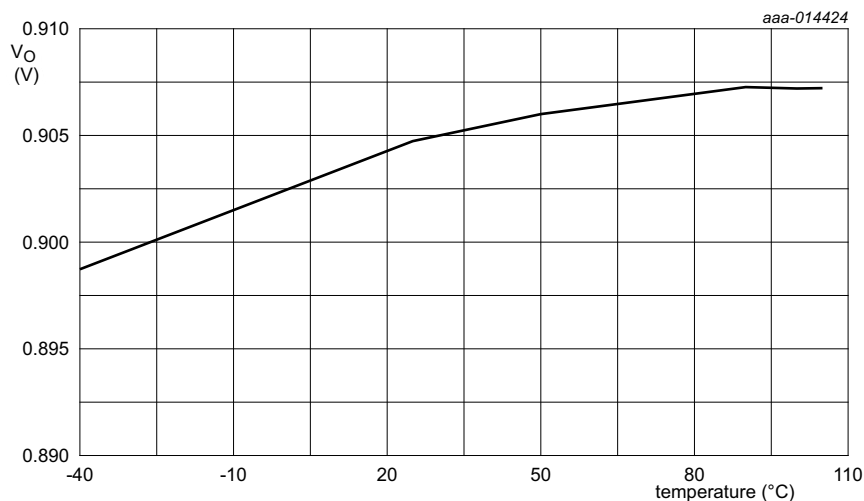
Fig 32. ADC input impedance

13.3 Comparator and internal voltage reference

Table 31. Internal voltage reference static and dynamic characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; $V_{DD} = 3.3\text{ V}$; hysteresis disabled in the comparator CTRL register.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_O	output voltage	$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $105\text{ }^{\circ}\text{C}$	860	-	940	mV
		$T_{amb} = 25\text{ }^{\circ}\text{C}$		904		mV



$V_{DD} = 3.3\text{ V}$; characterized through bench measurements on typical samples.

Fig 33. Typical internal voltage reference output voltage

Table 32. Comparator characteristics

$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$ unless noted otherwise; $V_{DD} = 1.8\text{ V}$ to 3.6 V .

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
Static characteristics							
V _{ref(cmp)}	comparator reference voltage	pin ACMPV _{REF}		1.5	-	3.6	V
I _{DD}	supply current	VP > VM; T _{amb} = 25 °C; V _{DD} = 3.3 V	[2]	-	90	-	μA
		VM > VP; T _{amb} = 25 °C; V _{DD} = 3.3 V	[2]	-	60	-	μA
V _{IC}	common-mode input voltage			0	-	V _{DD}	V
DV _O	output voltage variation			0	-	V _{DD}	V
V _{offset}	offset voltage	V _{IC} = 0.1 V; V _{DD} = 3.0 V	[2]	-	3	-	mV
		V _{IC} = 1.5 V; V _{DD} = 3.0 V	[2]	-	3	-	mV
		V _{IC} = 2.9 V; V _{DD} = 3.0V	[2]	-	6	-	mV
Dynamic characteristics							
t _{startup}	start-up time	nominal process; V _{DD} = 3.3 V; T _{amb} = 25 °C		-	13	-	μs

Table 32. Comparator characteristics ...continued $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$ unless noted otherwise; $V_{DD} = 1.8\text{ V}$ to 3.6 V .

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
t_{PD}	propagation delay	HIGH to LOW; $V_{DD} = 3.0\text{ V}$; $T_{amb} = 105\text{ }^{\circ}\text{C}$			150		
		$V_{IC} = 0.1\text{ V}$; 100 mV overdrive input	[1][2][4]	-		-	ns
		$V_{IC} = 0.1\text{ V}$; rail-to-rail input	[1][2]	-	250	-	ns
		$V_{IC} = 1.5\text{ V}$; 100 mV overdrive input	[1][2][4]	-	150	-	ns
		$V_{IC} = 1.5\text{ V}$; rail-to-rail input	[1][2]	-	170	-	ns
		$V_{IC} = 2.9\text{ V}$; 100 mV overdrive input	[1][2][4]	-	180	-	ns
t_{PD}	propagation delay	LOW to HIGH; $V_{DD} = 3.0\text{ V}$; $T_{amb} = 105\text{ }^{\circ}\text{C}$			260		
		$V_{IC} = 0.1\text{ V}$; 100 mV overdrive input	[1][2][4]	-		-	ns
		$V_{IC} = 0.1\text{ V}$; rail-to-rail input	[1][2]	-	90	-	ns
		$V_{IC} = 1.5\text{ V}$; 100 mV overdrive input	[1][2][4]	-	270	-	ns
		$V_{IC} = 1.5\text{ V}$; rail-to-rail input	[1][2]	-	220	-	ns
		$V_{IC} = 2.9\text{ V}$; 100 mV overdrive input	[1][2][4]	-	190	-	ns
V_{hys}	hysteresis voltage	positive hysteresis; $V_{DD} = 3.0\text{ V}$; $V_{IC} = 1.5\text{ V}$; $T_{amb} = 105\text{ }^{\circ}\text{C}$; settings:	[3]	-	6	-	
		5 mV					mV
		10 mV		-	12	-	mV
V_{hys}	hysteresis voltage	negative hysteresis; $V_{DD} = 3.0\text{ V}$; $V_{IC} = 1.5\text{ V}$; $T_{amb} = 105\text{ }^{\circ}\text{C}$; settings:	[1][3]	-	7	-	
		5 mV					mV
		10 mV		-	13	-	mV
R_{lad}	ladder resistance	20 mV		-	23	-	mV
		-		-	1	-	M Ω

[1] $C_L = 10\text{ pF}$

[2] Characterized on typical samples, not tested in production.

[3] Input hysteresis is relative to the reference input channel and is software programmable.

[4] 100 mV overdrive corresponds to a square wave from 50 mV below the reference (V_{IC}) to 50 mV above the reference.**Table 33. Comparator voltage ladder dynamic characteristics** $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+105\text{ }^{\circ}\text{C}$; $V_{DD} = 1.8\text{ V}$ to 3.6 V .

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$t_{s(pu)}$	power-up settling time	to 99% of voltage ladder output value	[1]	-	17	-	μs
$t_{s(sw)}$	switching settling time	to 99% of voltage ladder output value	[1]	-	18	-	μs

[1] Characterized on typical samples, not tested in production.

Table 34. Comparator voltage ladder reference static characteristics $V_{DD} = 1.8\text{ V to }3.6\text{ V}$. $T_{amb} = -40\text{ }^{\circ}\text{C to }+105\text{ }^{\circ}\text{C}$; external or internal reference.

Symbol	Parameter	Conditions		Min	Typ ^[1]	Max	Unit
$E_{V(O)}$	output voltage error	decimal code = 00	^[2]	-	± 6	-	mV
		decimal code = 08		-	± 1	-	%
		decimal code = 16		-	± 1	-	%
		decimal code = 24		-	± 1	-	%
		decimal code = 30		-	± 1	-	%
		decimal code = 31		-	± 1	-	%

[1] Characterized through limited samples. Not tested in production.

[2] All peripherals except comparator, temperature sensor, and FRO turned off.

14. Application information

14.1 Start-up behavior

Figure 34 shows the start-up timing after reset. The FRO 24 MHz oscillator provides the default clock at Reset and provides a clean system clock shortly after the supply pins reach operating voltage.

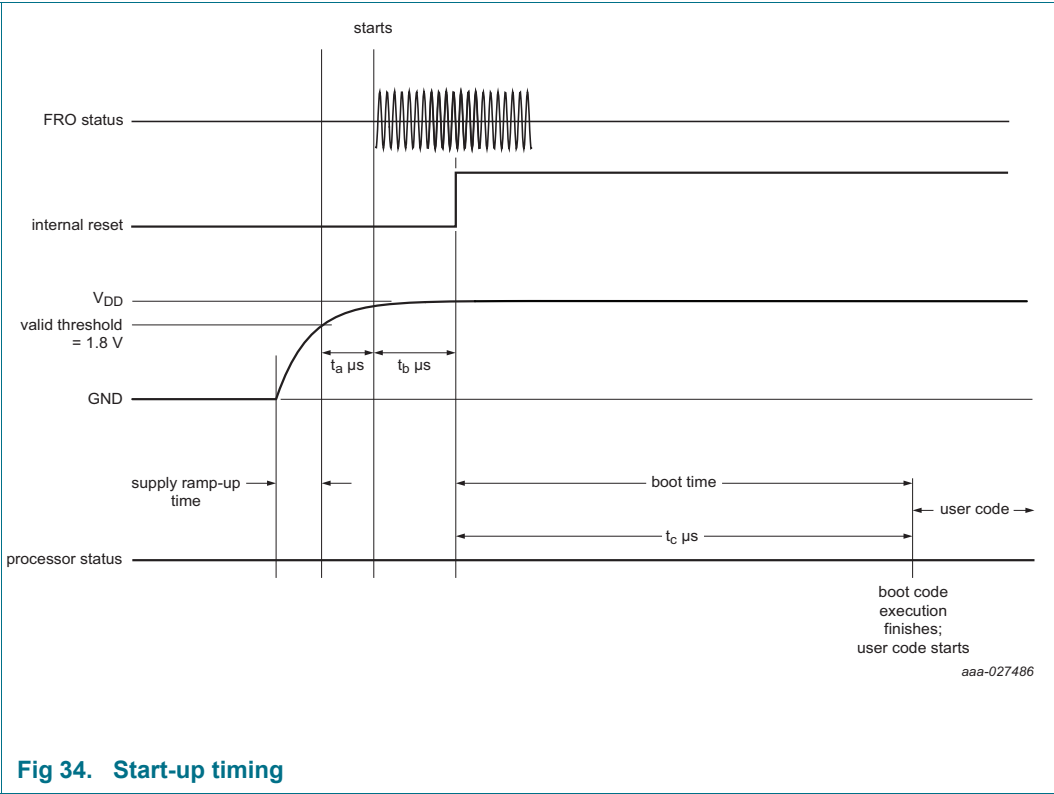


Fig 34. Start-up timing

Table 35. Typical start-up timing parameters

Parameter	Description	Value
t_a	FRO start time	$\leq 10 \mu\text{s}$
t_b	Internal reset de-asserted	$54 \mu\text{s}$
t_c	Boot time	$99 \mu\text{s}$

14.2 XTAL oscillator

In the XTAL oscillator circuit, only the crystal (XTAL) and the capacitances C_{X1} and C_{X2} need to be connected externally on XTALIN and XTALOUT. See [Figure 35](#).

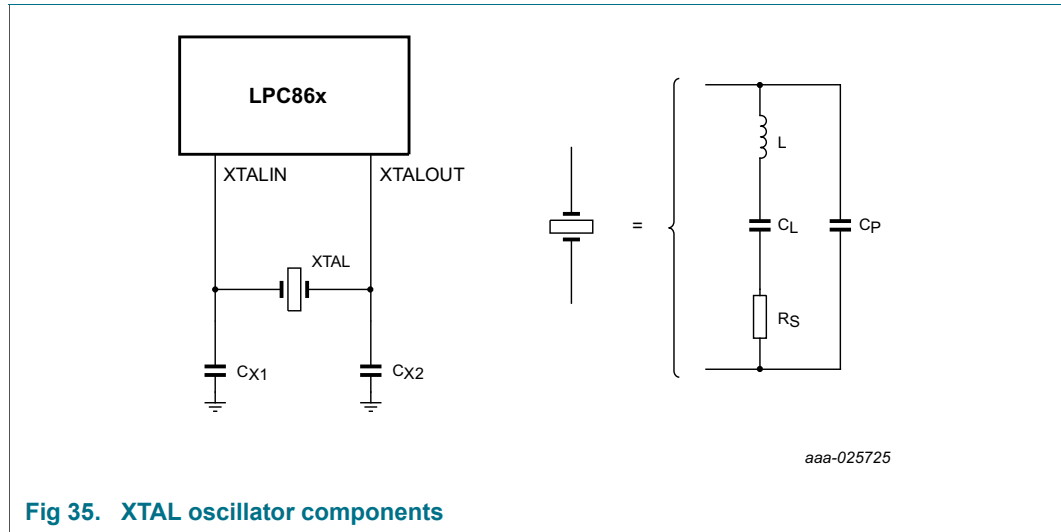


Fig 35. XTAL oscillator components

For best results, it is very critical to select a matching crystal for the on-chip oscillator. Load capacitance (C_L), series resistance (R_S), and drive level (DL) are important parameters to consider while choosing the crystal. After selecting the proper crystal, the external load capacitor C_{X1} and C_{X2} values can also be generally determined by the following expression:

$$C_{X1} = C_{X2} = 2C_L - (C_{Pad} + C_{Parasitic})$$

Where:

C_L - Crystal load capacitance

C_{Pad} - Pad capacitance of the XTALIN and XTALOUT pins (~3 pF).

$C_{Parasitic}$ - Parasitic or stray capacitance of external circuit.

Although $C_{Parasitic}$ can be ignored in general, the actual board layout and placement of external components influence the optimal values of external load capacitors. Therefore, it is recommended to fine tune the values of external load capacitors on the actual hardware board to get an accurate clock frequency. For fine tuning, measure the clock on the XTALOUT pin and optimize the values of external load capacitors for minimum frequency deviation.

14.2.1 XTAL Printed Circuit Board (PCB) design guidelines

- Connect the crystal and external load capacitors on the PCB as close as possible to the oscillator input and output pins of the chip.
- The length of traces in the oscillation circuit should be as short as possible and must not cross other signal lines.
- Ensure that the load capacitors CX1, CX2, and CX3, in case of third overtone crystal usage, have a common ground plane.
- Loops must be made as small as possible to minimize the noise coupled in through the PCB and to keep the parasitics as small as possible.
- Lay out the ground (GND) pattern under the crystal unit.
- Do not lay out other signal lines under the crystal unit for multi-layered PCB.

14.2.2 XTAL input

The input voltage to the on-chip oscillators is limited to 1.95 V. If the oscillator is driven by a clock in target mode, it is recommended to couple the input through a capacitor with $C_i = 100$ pF. To limit the input voltage to the specified range, choose an additional capacitor to ground C_g which attenuates the input voltage by a factor $C_i/(C_i + C_g)$. In target mode, a minimum of 200 mV(RMS) is needed.

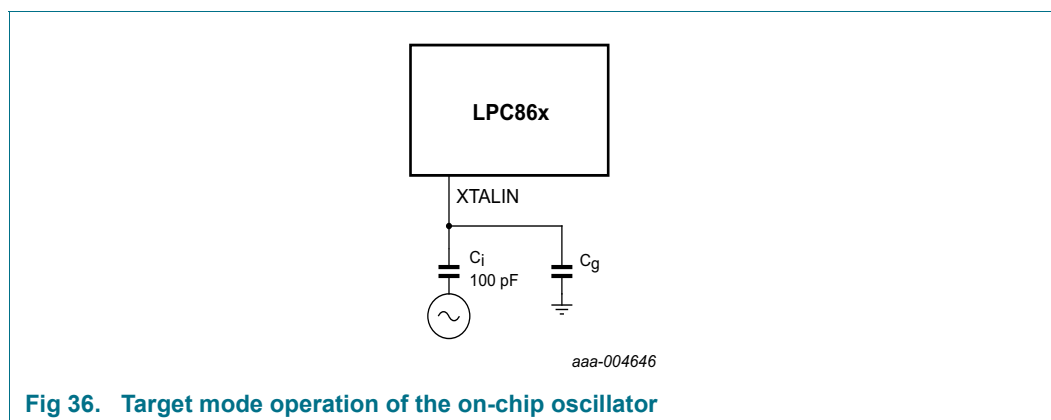
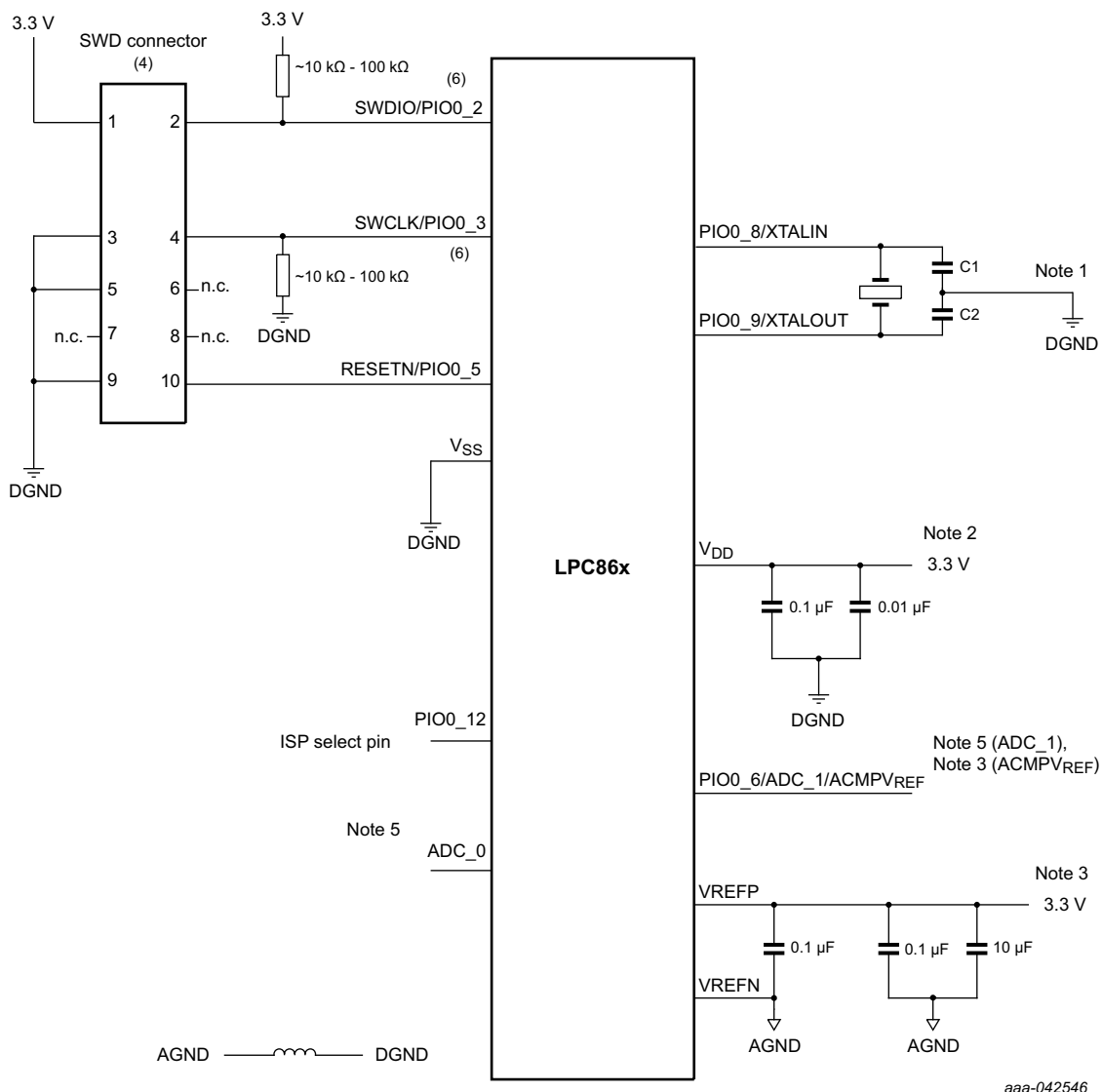


Fig 36. Target mode operation of the on-chip oscillator

In target mode the input clock signal should be coupled with a capacitor of 100 pF ([Figure 36](#)), with an amplitude between 200 mV (RMS) and 1000 mV (RMS). This corresponds to a square wave signal with a signal swing of between 280 mV and 1.4 V. The XTALOUT pin in this configuration can be left unconnected.

14.3 Connecting power, clocks, and debug functions

[Figure 37](#) shows the basic board connections used to power the LPC86x, connect the external crystal, and provide debug capabilities via the serial wire port.



- (1) See [Section 14.2 "XTAL oscillator"](#) for the values of C1 and C2.
- (2) Position the decoupling capacitors of 0.1 μF and 0.01 μF as close as possible to the V_{DD} pin. Add one set of decoupling capacitors to each V_{DD} pin.
- (3) Position the decoupling capacitors of 0.1 μF as close as possible to the V_{REFN} and V_{DD} pins. The 10 μF bypass capacitor filters the power line. Tie V_{REFP} to V_{DD} if the ADC is not used. Tie V_{REFN} to V_{SS} if ADC is not used.
- (4) Uses the Arm 10-pin interface for SWD.
- (5) When measuring signals of low frequency, use a low-pass filter to remove noise and to improve ADC performance. Also, see [Ref. 4](#).
- (6) External pull-up resistors on SWDIO pins are optional because these pins have an internal pull-up enabled by default.

Fig 37. Power, clock, and debug connections

14.4 I/O power consumption

I/O pins are contributing to the overall dynamic and static power consumption of the part. If pins are configured as digital inputs, a static current can flow depending on the voltage level at the pin and the setting of the internal pull-up and pull-down resistors. This current can be calculated using the parameters R_{pu} and R_{pd} given in [Table 16](#) for a given input voltage V_I . For pins set to output, the current drive strength is given by parameters I_{OH} and I_{OL} in [Table 16](#), but for calculating the total static current, you also need to consider any external loads connected to the pin.

I/O pins also contribute to the dynamic power consumption when the pins are switching because the V_{DD} supply provides the current to charge and discharge all internal and external capacitive loads connected to the pin in addition to powering the I/O circuitry.

The contribution from the I/O switching current I_{sw} can be calculated as follows for any given switching frequency f_{sw} if the external capacitive load (C_{ext}) is known (see [Table 16](#) for the internal I/O capacitance):

$$I_{sw} = V_{DD} \times f_{sw} \times (C_{io} + C_{ext})$$

14.5 Termination of unused pins

[Table 36](#) shows how to terminate pins that are **not** used in the application. In many cases, unused pins may be connected externally or configured correctly by software to minimize the overall power consumption of the part.

Unused pins with GPIO function should be configured as outputs set to LOW with their internal pull-up disabled. To configure a GPIO pin as output and drive it LOW, select the GPIO function in the IOCON register, select output in the GPIO DIR register, and write a 0 to the GPIO PORT register for that pin. Disable the pull-up in the pin's IOCON register.

In addition, it is recommended to configure all GPIO pins that are not bonded out on smaller packages as outputs LOW with their internal pull-up disabled.

Table 36. Termination of unused pins

Pin	Default state ^[1]	Recommended termination of unused pins
RESET/PIO0_5	I; PU	In an application that does not use the RESET pin or its GPIO function, the termination of this pin depends on whether the deep power-down mode is used: <ul style="list-style-type: none"> Deep power-down used: Connect an external pull-up resistor and keep pin in the default state (input, pull-up enabled) during all other power modes. Deep power-down not used and no external pull-up connected: can be left unconnected if internal pull-up is disabled and the pin is driven LOW and configured as output by software.
all PION_m (not open-drain)	I; HI-Z	Can be left unconnected if driven LOW and configured as GPIO output with pull-up disabled by software.
PION_m (I2C open-drain)	IA	Can be left unconnected if driven LOW and configured as GPIO output by software.
VREFP	-	Tie to VDD.
VREFN	-	Tie to VSS.

[1] I = Input, O = Output, IA = Inactive (no pull-up/pull-down enabled), F = floating, PU = Pull-Up HI-Z = tri-state.

14.6 Pin states in different power modes

Table 37. Pin states in different power modes

Pin	Active	Sleep	Deep-sleep/power-down	Deep power-down
PION_m pins (not I2C)	As configured in the IOCON[1]. Default: internal pull-up enabled.			Floating.
Open-drain I2C-bus pins	As configured in the IOCON[1].			Floating.
$\overline{\text{RESET}}$	Reset function enabled. Default: input, internal pull-up enabled.			Reset function disabled; floating; if the part is in deep power-down mode, the $\overline{\text{RESET}}$ pin needs an external pull-up to reduce power consumption.
$\overline{\text{WAKEUP}}$	As configured in the IOCON[1]. $\overline{\text{WAKEUP}}$ function inactive.			Wake-up function enabled; can be disabled by software.

[1] Default and programmed pin states are retained in sleep, deep-sleep, and power-down modes.

15. Package outline

LQFP64: plastic low profile quad flat package; 64 leads; body 10 x 10 x 1.4 mm

SOT314-2

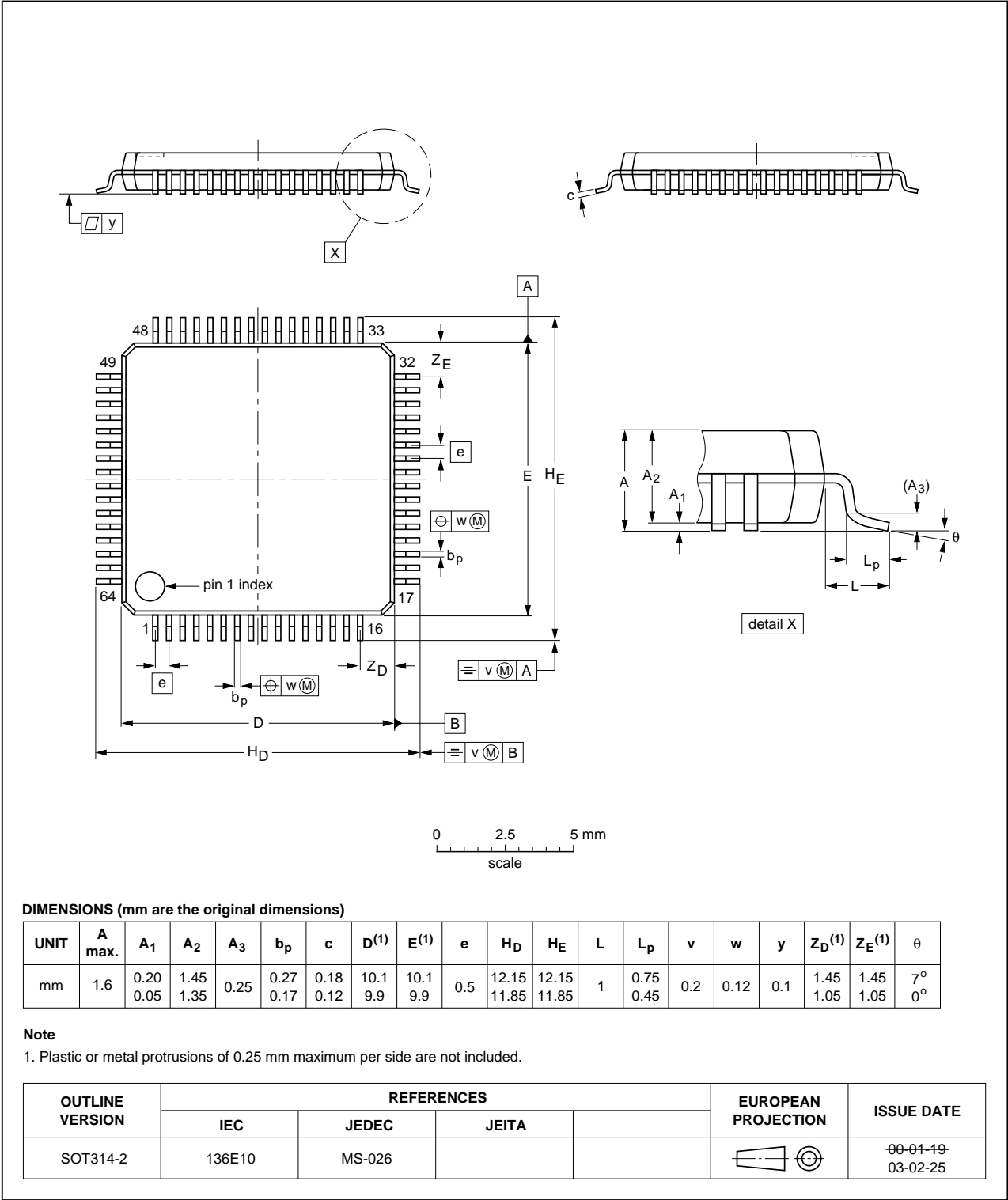


Fig 38. Package outline SOT314-2 (LQFP64)

HVQFN48: plastic thermal enhanced very thin quad flat package; no leads;
48 terminals; body 7 x 7 x 0.85 mm

SOT619-1

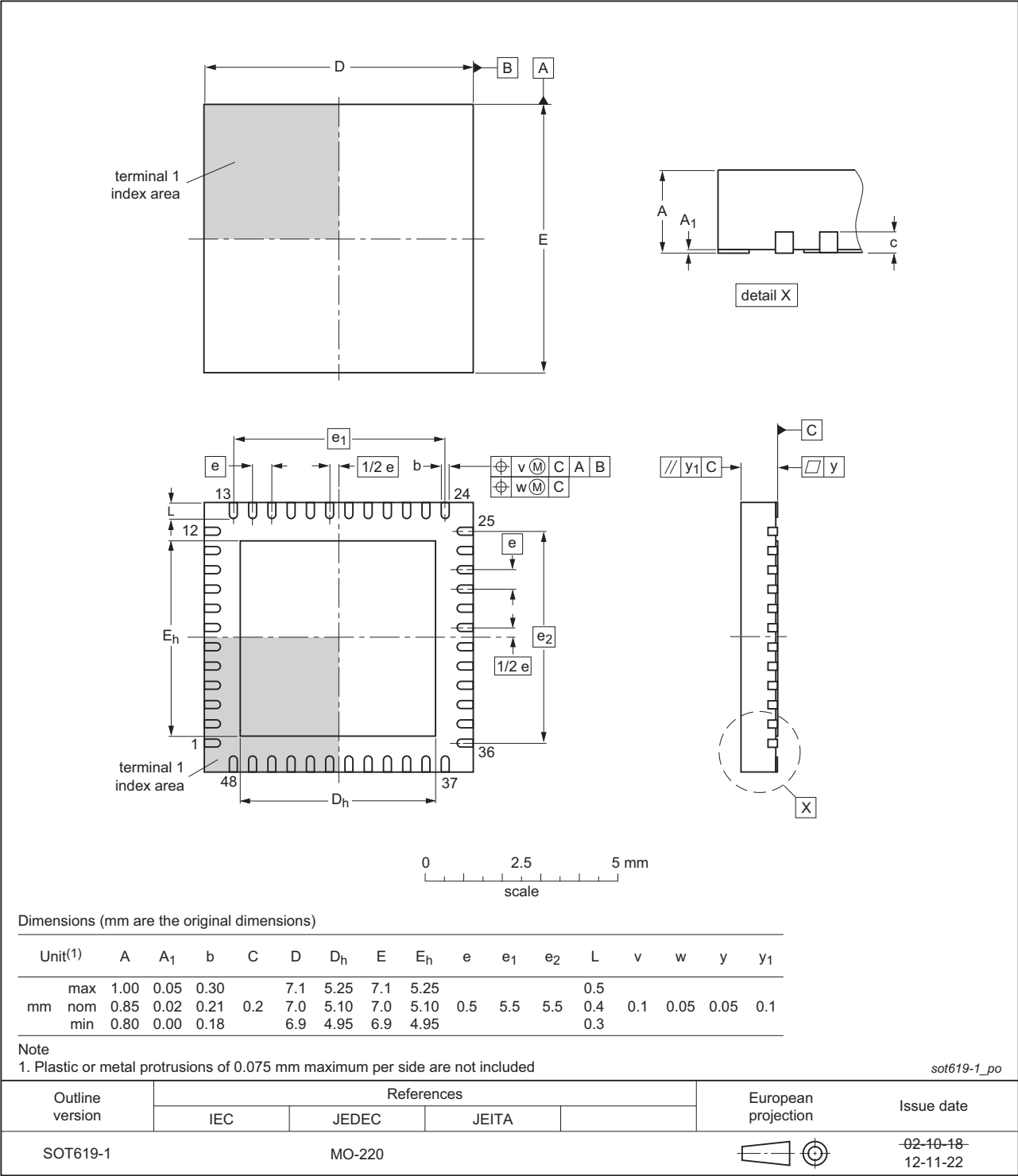


Fig 39. Package outline HVQFN48 7 x 7x 0.85 mm (SOT619-1)

HVQFN32: plastic thermal enhanced very thin quad flat package; no leads;
32 terminals; body 5 x 5 x 0.85 mm

SOT617-11

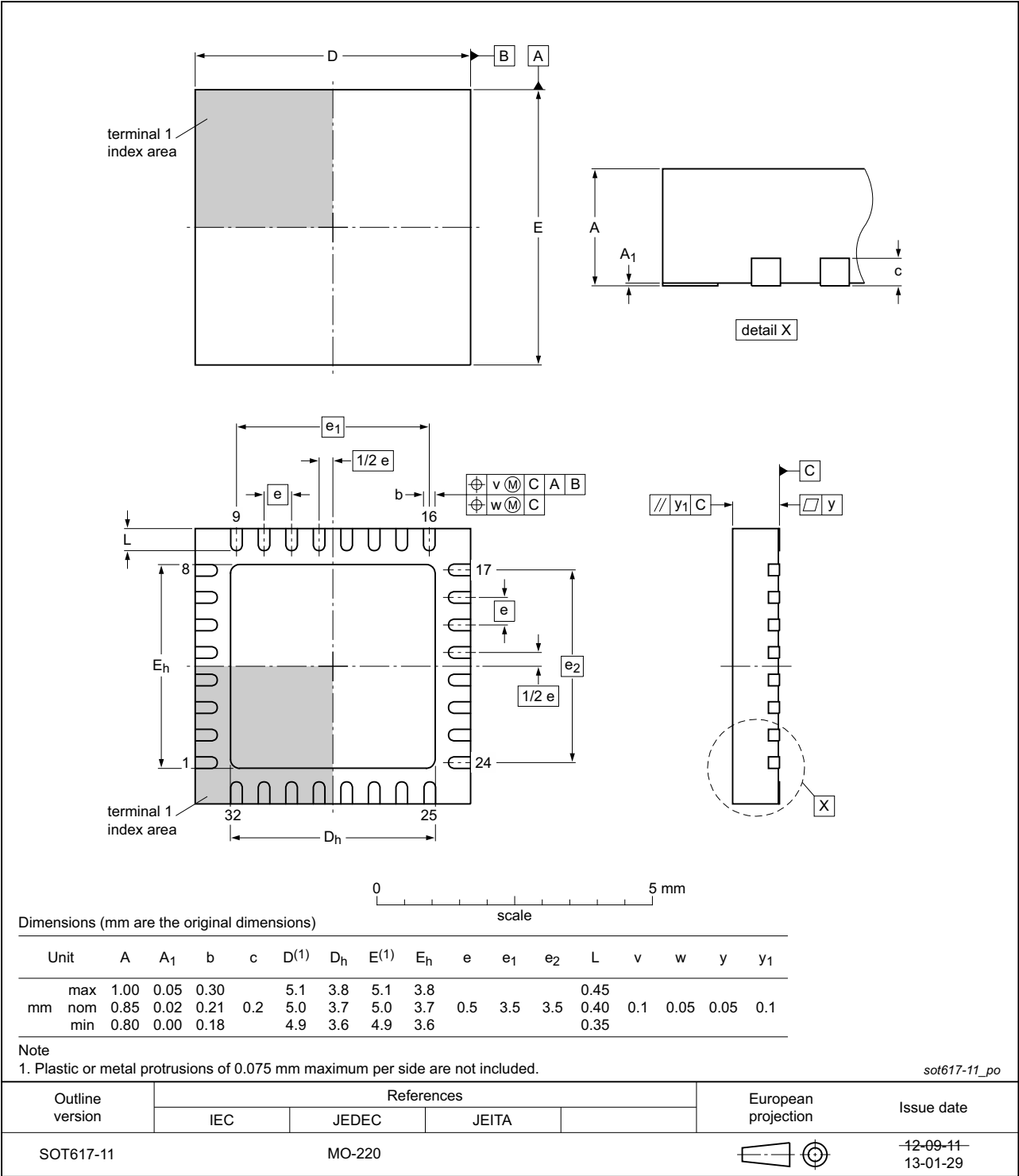


Fig 40. Package outline HVQFN32 5x 5x 0.85 mm (SOT617-11)

16. Soldering

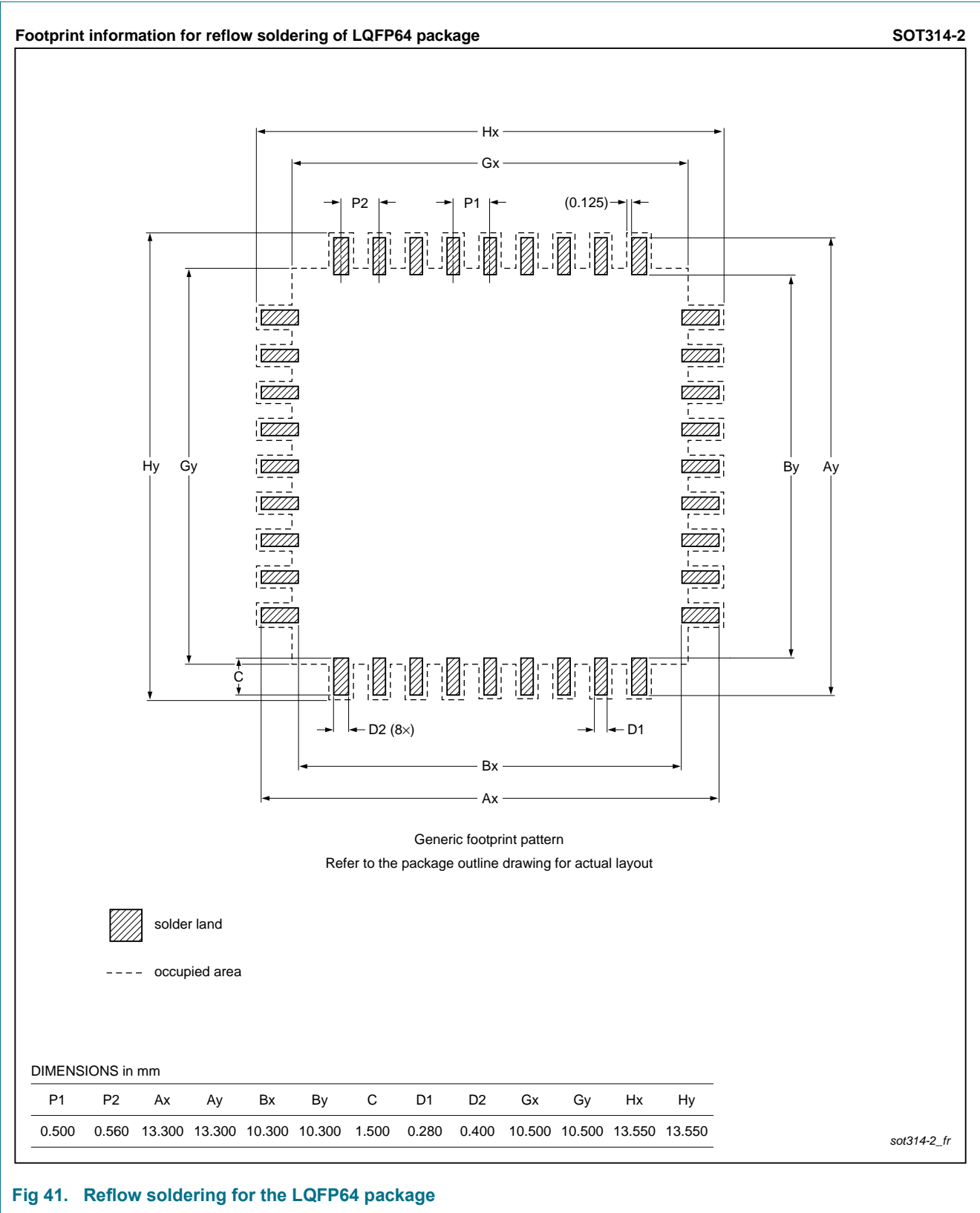
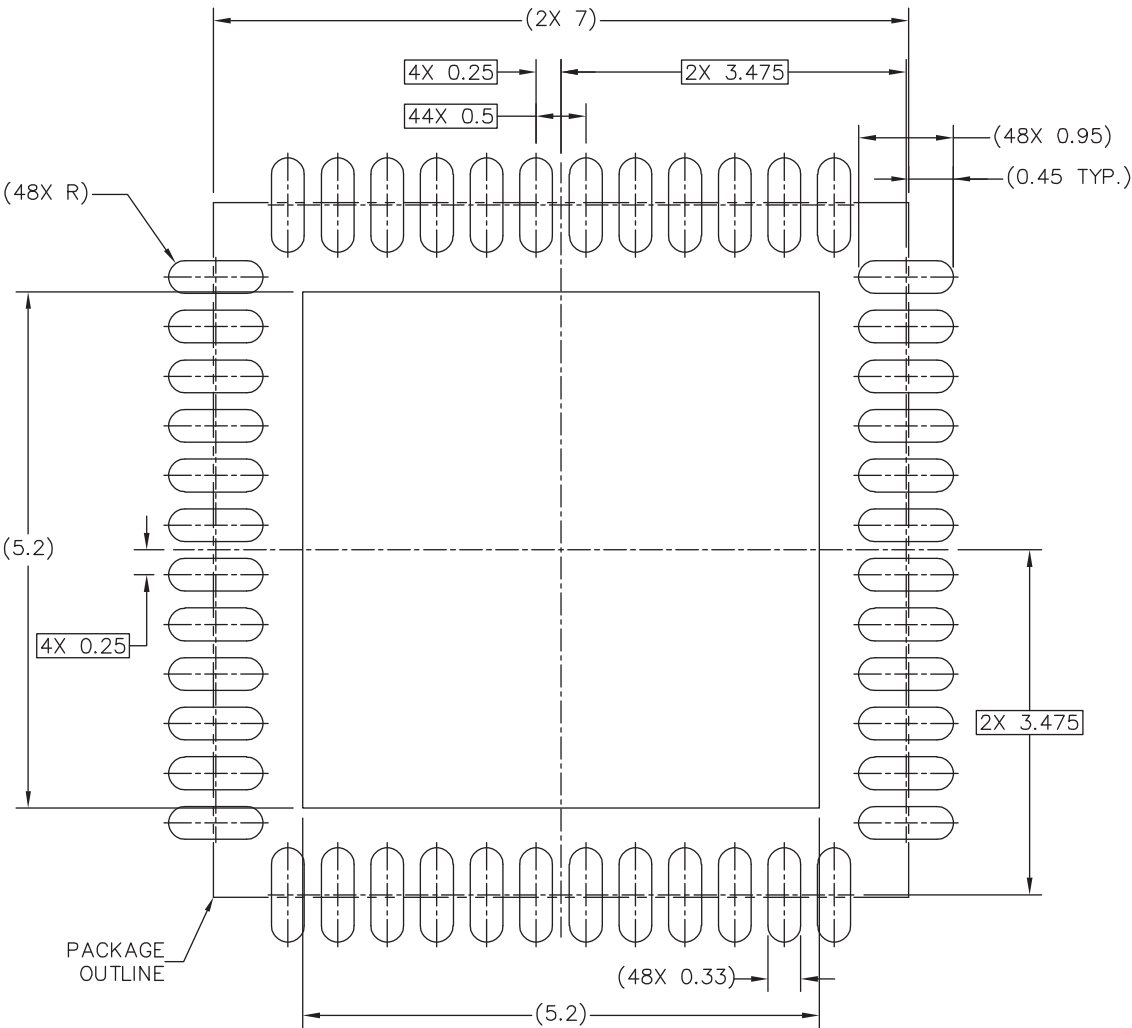


Fig 41. Reflow soldering for the LQFP64 package

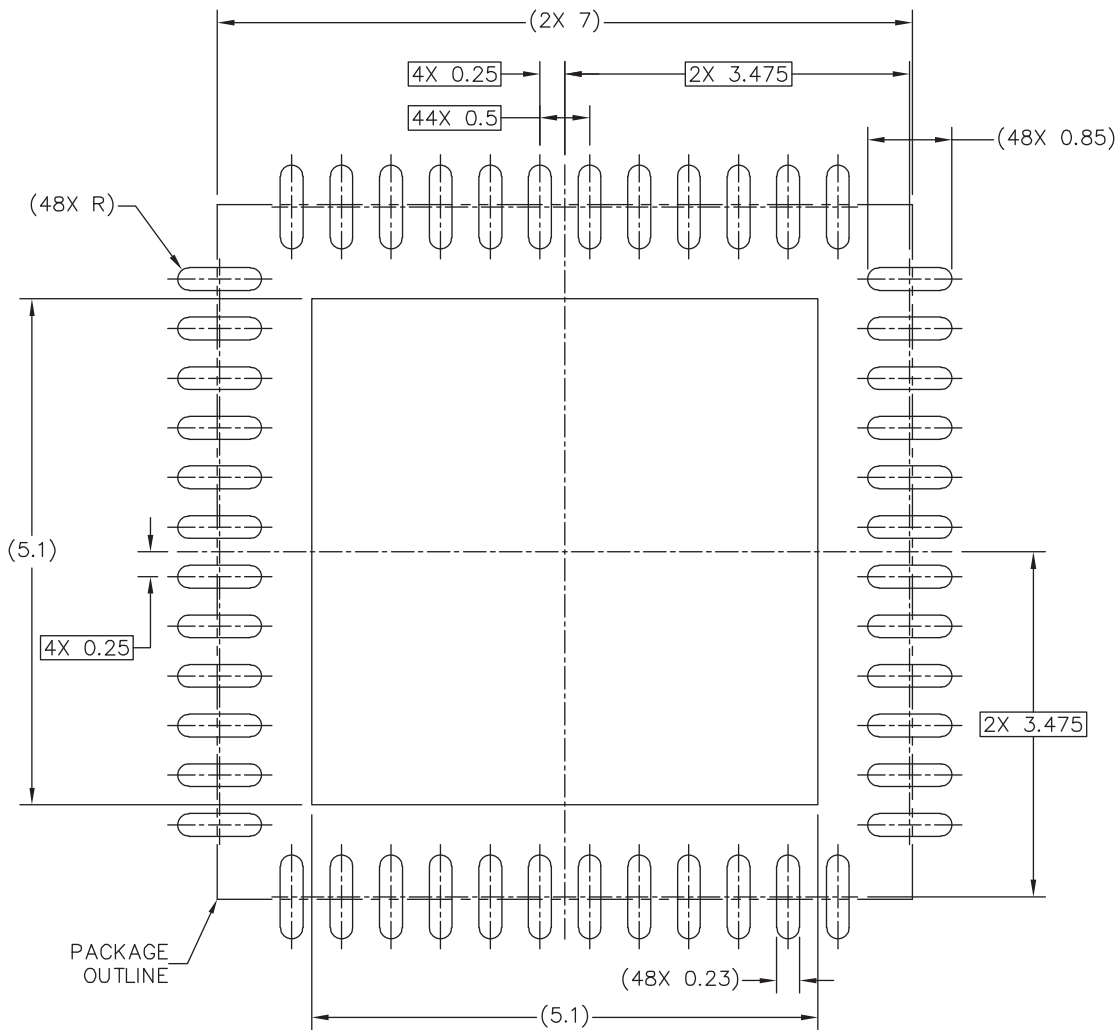


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Fig 42. Reflow soldering of the HVQFN48 package (7x7) 1 of 3

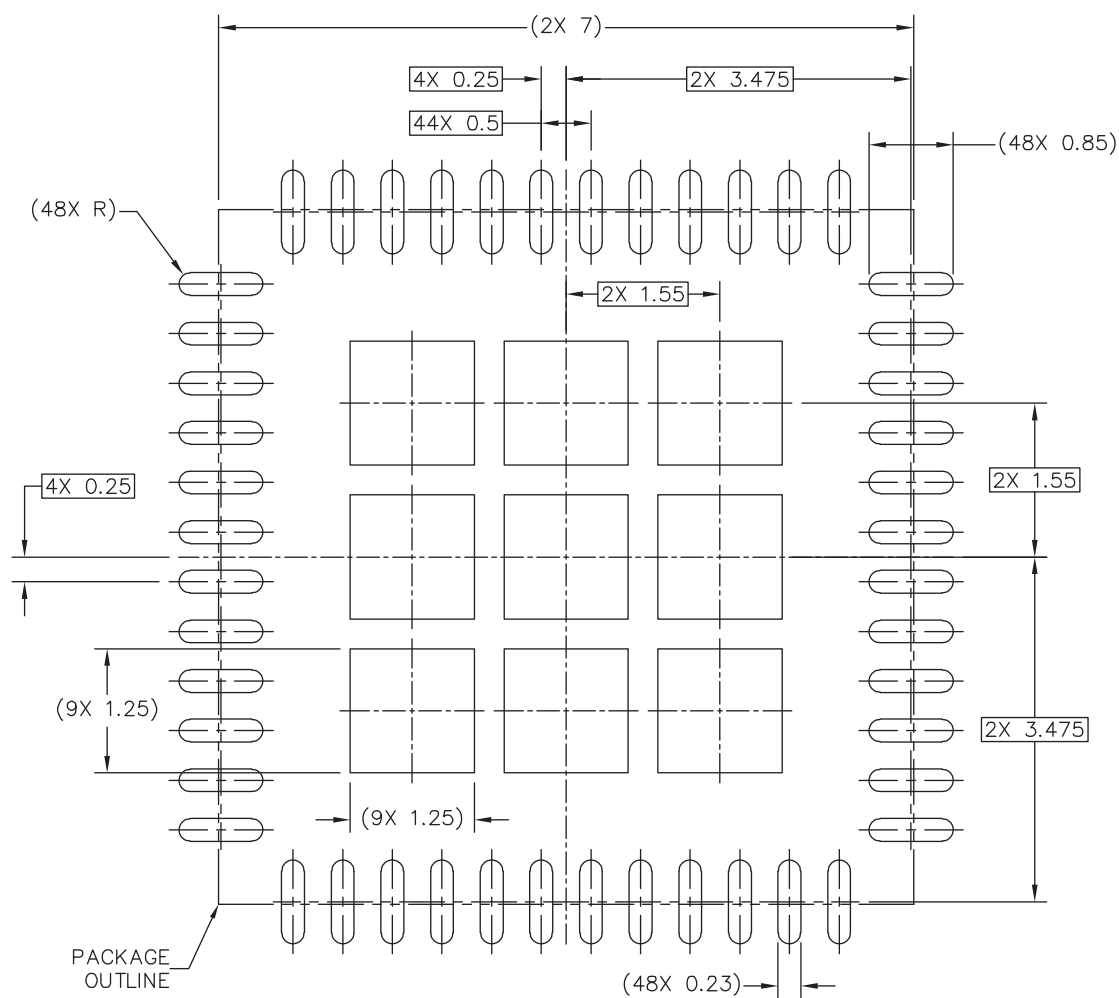


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Fig 43. Reflow soldering of the HVQFN48 package (7x7) 2 of 3



RECOMMENDED STENCIL THICKNESS 0.125

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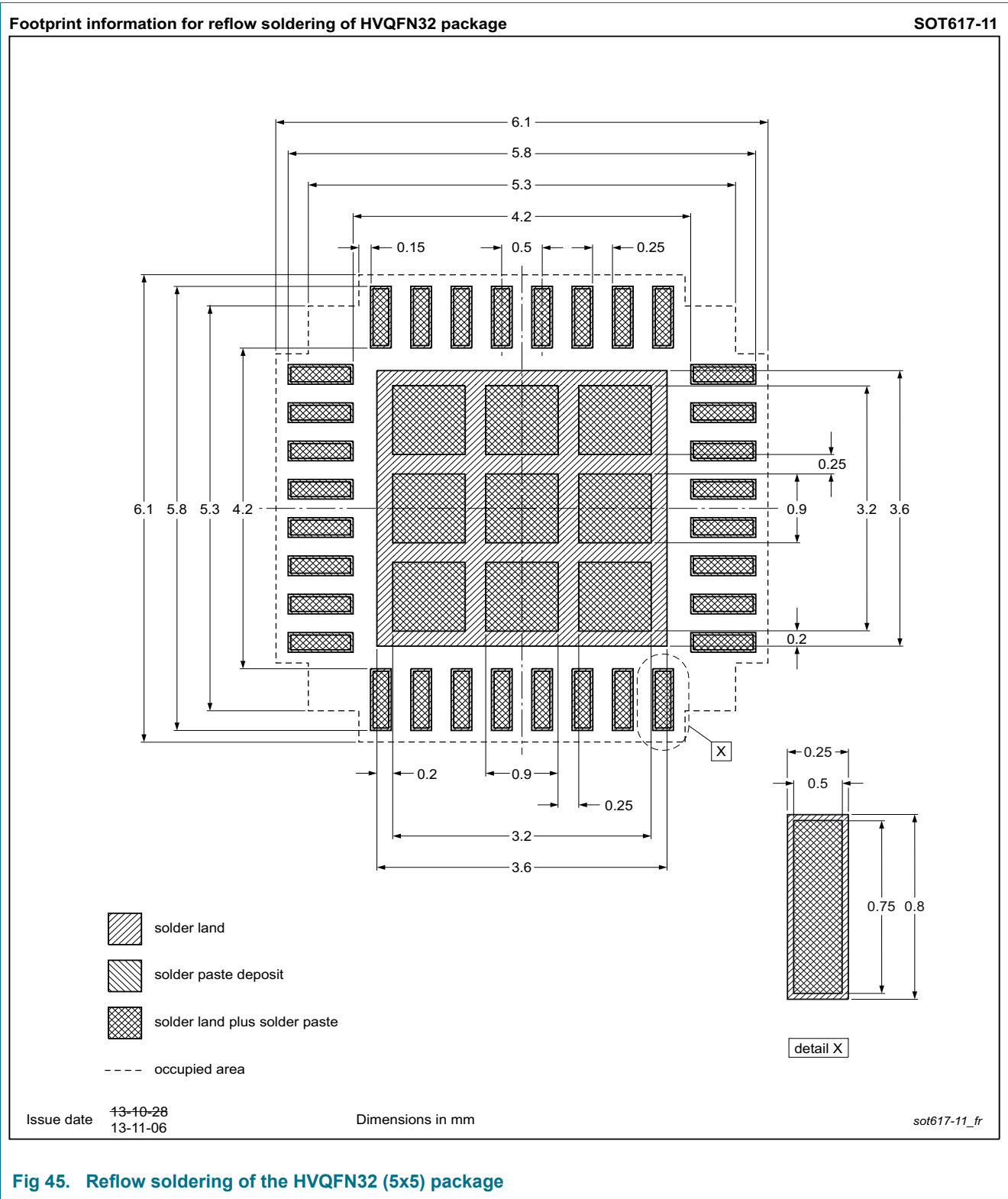
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Fig 44. Reflow soldering of the HVQFN48 package (7x7) 3 of 3



17. Abbreviations

Table 38. Abbreviations

Acronym	Description
AHB	Advanced High-performance Bus
APB	Advanced Peripheral Bus
BOD	BrownOut Detection
GPIO	General-Purpose Input/Output
I3C	Improved Inter Integrated Circuit
PLL	Phase-Locked Loop
RC	Resistor-Capacitor
SPI	Serial Peripheral Interface
SMBus	System Management Bus
TEM	Transverse ElectroMagnetic
UART	Universal Asynchronous Receiver/Transmitter

18. References

- [1] LPC86x User manual UM11607
- [2] LPC86x Errata sheet
- [3] I2C-bus specification *UM10204*
- [4] Technical note ADC design guidelines:
http://www.nxp.com/documents/technical_note/TN00009.pdf

19. Revision history

Table 39. Revision history

Document ID	Rev. No.	Release date	Data sheet status	Change notice	Supersedes
LPC86x	3	20230415	Product Data Sheet	-	Initial release

20. Contents

1	General description	1	8.21	Analog comparator (ACMP)	29
2	Features and benefits	1	8.21.1	Features	30
3	Applications	3	8.22	Analog-to-Digital Converter (ADC)	30
4	Ordering information	4	8.22.1	Features	30
4.1	Ordering options	4	8.23	CRC engine	31
5	Marking	5	8.23.1	Features	31
6	Block diagram	7	8.24	Clocking and power control	31
7	Pinning information	7	8.24.1	Crystal and internal oscillators	31
7.1	Pinning	7	8.24.1.1	Free Running Oscillator (FRO)	32
7.2	Pin description	10	8.24.1.2	Crystal Oscillator (SysOsc)	32
8	Functional description	17	8.24.1.3	Low power Oscillator (LPOSC)	32
8.1	Arm Cortex-M0+ core	17	8.24.2	Clock input	32
8.2	On-chip flash program memory	17	8.24.3	System PLL	32
8.3	On-chip SRAM	17	8.24.4	Clock output	33
8.4	On-chip ROM	17	8.24.5	Power control	35
8.5	Memory map	18	8.24.5.1	Sleep mode	35
8.6	Nested Vectored Interrupt Controller (NVIC)	20	8.24.5.2	Deep-sleep mode	35
8.6.1	Features	20	8.24.5.3	Power-down mode	36
8.6.2	Interrupt sources	20	8.24.5.4	Deep power-down mode	36
8.7	System tick timer	20	8.24.6	Wake-up process	38
8.8	I/O configuration	20	8.25	System control	39
8.8.1	Standard I/O pad configuration	21	8.25.1	Reset	39
8.9	Switch Matrix (SWM)	22	8.25.2	Brownout detection	39
8.10	Fast General-Purpose parallel I/O (GPIO)	22	8.25.3	Code Read Protection - CRP	40
8.10.1	Features	22	8.25.4	APB interface	40
8.11	Pin interrupt/pattern match engine	22	8.25.5	AHBLite	40
8.11.1	Features	23	8.26	Emulation and debugging	41
8.12	DMA controller	23	9	Limiting values	42
8.12.1	Features	23	10	Thermal characteristics	44
8.12.2	DMA trigger input MUX (TRIGMUX)	24	11	Static characteristics	45
8.13	USART0/1/2	24	11.1	General operating conditions	45
8.13.1	Features	24	11.2	Power-up ramp conditions	46
8.14	SPI0/1	24	11.3	Power consumption	47
8.14.1	Features	25	11.4	Peripheral power consumption	53
8.15	I ² C-bus interface (I ² C0)	25	11.5	Pin characteristics	55
8.15.1	Features	25	11.5.1	Electrical pin characteristics	58
8.16	I3C-bus interface (I3C0)	25	12	Dynamic characteristics	61
8.16.1	Features	26	12.1	Flash memory	61
8.17	FlexTimer (FTM0/1)	27	12.2	FRO	61
8.17.1	Features	27	12.3	I/O pins	62
8.18	Multi-Rate Timer (MRT)	28	12.4	WKTCLKIN pin (wake-up clock input)	62
8.18.1	Features	28	12.5	I ² C-bus	62
8.19	Windowed WatchDog Timer (WWDT)	28	12.6	MIPI-I3C	64
8.19.1	Features	28	12.7	SPI interfaces	67
8.20	Self-Wake-up Timer (WKT)	28	12.8	USART interface (in synchronous mode)	70
8.20.1	Features	29	12.9	Wake-up process	71
			13	Characteristics of analog peripherals	72

[continued >>](#)

13.1	BOD	72
13.2	ADC	73
13.2.1	ADC input impedance	75
13.3	Comparator and internal voltage reference ..	76
14	Application information	79
14.1	Start-up behavior	79
14.2	XTAL oscillator	80
14.2.1	XTAL Printed Circuit Board (PCB) design guidelines	81
14.2.2	XTAL input	81
14.3	Connecting power, clocks, and debug functions . 81	
14.4	I/O power consumption	83
14.5	Termination of unused pins	83
14.6	Pin states in different power modes	84
15	Package outline	85
16	Soldering	88
17	Abbreviations	93
18	References	93
19	Revision history	94
20	Contents	95

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Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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